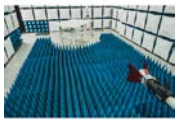
PCTEST
7185 Oakland Mills Road, Columbia, MD 21046 USA
Tel. 410.290.6652 / Fax 410.290.6654
http://www.pctest.com



PART 27 MEASUREMENT REPORT

Applicant Name:
Samsung Electronics Co., Ltd.
129, Samsung-ro,
Yeongtong-gu, Suwon-si
Gyeonggi-do, 16677, Korea

Date of Testing:
06/30/2021 - 07/24/2021
Test Site/Location:
PCTEST Lab. Columbia, MD, USA
Test Report Serial No.:
1M2106280072-04.A3L

FCC ID:	**A3LSMA528B**
APPLICANT:	**Samsung Electronics Co., Ltd.**

Application Type:	Certification
Model:	SM-A528B/DS
Additional Model(s):	SM-A528B
EUT Type:	Portable Handset
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part:	27
Test Procedure(s):	ANSI C63.26-2015, ANSI/TIA-603-E-2016, KDB 971168 D01 v03r01

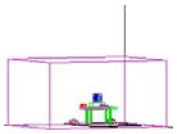
This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

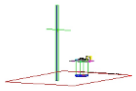
Randy Ortanez
President

ACCREDITED
CERT #2041.01

TABLE OF CONTENTS



MEASUREMENT REPORT
FCC Part 27



Mode	Bandwidth	Modulation	Tx Frequency Range [MHz]	ERP		EIRP		Emission Designator
				Max. Power [W]	Max. Power [dBm]	Max. Power [W]	Max. Power [dBm]	
LTE Band 17/12	10 MHz	QPSK	704.0 - 711.0	0.074	18.69	0.121	20.84	9M03G7D
		16QAM	704.0 - 711.0	0.059	17.73	0.097	19.88	8M98W7D
	5 MHz	QPSK	701.5 - 713.5	0.073	18.66	0.121	20.81	4M52G7D
		16QAM	701.5 - 713.5	0.059	17.74	0.098	19.89	4M50W7D
LTE Band 12	3 MHz	QPSK	700.5 - 714.5	0.073	18.65	0.120	20.80	2M70G7D
		16QAM	700.5 - 714.5	0.059	17.71	0.097	19.86	2M71W7D
	1.4 MHz	QPSK	699.7 - 715.3	0.072	18.58	0.118	20.73	1M09G7D
		16QAM	699.7 - 715.3	0.059	17.74	0.098	19.89	1M09W7D

Overview Table (<1GHz Bands)

Mode	Modulation	Tx Frequency Range [MHz]	EIRP		Emission Designator
			Max. Power [W]	Max. Power [dBm]	
WCDMA1700	Spread Spectrum	1712.4 - 1752.6	0.204	23.09	4M19F9W

Overview Table (>1GHz Bands)

Mode	Bandwidth	Modulation	Tx Frequency Range [MHz]	EIRP		Emission Designator
				Max. Power [W]	Max. Power [dBm]	
LTE Band 66/4	20 MHz	QPSK	1720.0 - 1770.0	0.190	22.79	18M0G7D
		16QAM	1720.0 - 1770.0	0.157	21.96	18M0W7D
	15 MHz	QPSK	1717.5 - 1772.5	0.195	22.89	13M5G7D
		16QAM	1717.5 - 1772.5	0.160	22.03	13M5W7D
	10 MHz	QPSK	1715.0 - 1775.0	0.197	22.94	9M03G7D
		16QAM	1715.0 - 1775.0	0.160	22.04	8M99W7D
	5 MHz	QPSK	1712.5 - 1777.5	0.199	22.99	4M50G7D
		16QAM	1712.5 - 1777.5	0.161	22.08	4M50W7D
	3 MHz	QPSK	1711.5 - 1778.5	0.191	22.80	2M70G7D
		16QAM	1711.5 - 1778.5	0.159	22.01	2M73W7D
	1.4 MHz	QPSK	1710.7 - 1779.3	0.196	22.93	1M09G7D
		16QAM	1710.7 - 1779.3	0.165	22.17	1M10W7D
NR Band n66	20 MHz	π/2 BPSK	1720.0 - 1770.0	0.131	21.16	18M0G7D
		QPSK	1720.0 - 1770.0	0.125	20.97	19M0G7D
		16QAM	1720.0 - 1770.0	0.101	20.04	19M1W7D
	15 MHz	π/2 BPSK	1717.5 - 1772.5	0.134	21.29	13M5G7D
		QPSK	1717.5 - 1772.5	0.123	20.89	14M2G7D
		16QAM	1717.5 - 1772.5	0.094	19.73	14M2W7D
	10 MHz	π/2 BPSK	1715.0 - 1775.0	0.135	21.29	9M02G7D
		QPSK	1715.0 - 1775.0	0.122	20.86	9M35G7D
		16QAM	1715.0 - 1775.0	0.095	19.79	9M35W7D
	5 MHz	π/2 BPSK	1712.5 - 1777.5	0.134	21.28	4M50G7D
		QPSK	1712.5 - 1777.5	0.119	20.75	4M51G7D
		16QAM	1712.5 - 1777.5	0.092	19.64	4M50W7D

Overview Table (>1GHz Bands)

1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada.

1.2 PCTEST Test Location

These measurement tests were conducted at the PCTEST facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The measurement facility is compliant with the test site requirements specified in ANSI C63.4-2014.

1.3 Test Facility / Accreditations

Measurements were performed at PCTEST located in Columbia, MD 21046, U.S.A.

- PCTEST is an ISO 17025-2017 accredited test facility under the American Association for Laboratory Accreditation (A2LA) with Certificate number 2041.01 for Specific Absorption Rate (SAR), Hearing Aid Compatibility (HAC) testing, where applicable, and Electromagnetic Compatibility (EMC) testing for FCC and Innovation, Science, and Economic Development Canada rules.

- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC 17065-2012 by A2LA (Certificate number 2041.03) in all scopes of FCC Rules and ISED Standards (RSS).

- PCTEST facility is a registered (2451B) test laboratory with the site description on file with ISED.

2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMA528B**. The test data contained in this report pertains only to the emissions due to the EUT's licensed transmitters that operate under the provisions of Part 27.

Test Device Serial No.: 0792M, 0618M, 1846M, 0715M, 0740M, 0566M

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 GSM/GPRS/EDGE, 850/1700/1900, WCDMA/HSPA, Multi-band LTE, 5G NR (FR1), 802.11b/g/n/ax WLAN, 802.11a/n/ac/ax UNII, Bluetooth (1x, EDR, LE), NFC

2.3 Test Configuration

The EUT was tested per the guidance of ANSI/TIA-603-E-2016 and KDB 971168 D01 v03r01. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

3.0 DESCRIPTION OF TESTS

3.1 Evaluation Procedure

The measurement procedures described in the document titled "Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards" (ANSI/TIA-603-E-2016) and "Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems" (KDB 971168 D01 v03r01) were used in the measurement of the EUT**.**

3.2 Radiated Power and Radiated Spurious Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Figure 5.7 of Clause 5 in ANSI C63.4-2014. Absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz. For measurements below 1GHz, the absorbers are removed. A raised turntable is used for radiated measurement. The turn table is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm tall test table made of Styrodur is placed on top of the turn table. A Styrodur pedestal is placed on top of the test table to bring the total table height to 1.5m.

The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Radiated power levels are also investigated with the receive antenna horizontally and vertically polarized. The maximized power level is recorded using the spectrum analyzer "Channel Power" function with the integration band set to the emissions' occupied bandwidth, a RMS detector, RBW = 100kHz, VBW = 300kHz, and a 1 second sweep time over a minimum of 10 sweeps, per the guidelines of KDB 971168 D01 v03r01.

Per the guidance of ANSI/TIA-603-E-2016, a half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_{d\ [dBm]} = P_{g\ [dBm]} - \text{cable loss}_{\ [dB]} + \text{antenna gain}_{\ [dBd/dBi]}$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_{g\ [dBm]}$ – cable loss $_{[dB]}$.

For fundamental radiated power measurements, the guidance of KDB 971168 D01 v03r01 is used to record the EUT power level that is subsequently matched via the aforementioned substitution method given in ANSI/TIA-603-E-2016.

All radiated measurements are performed in a chamber that meets the site requirements per ANSI C63.4-2014. Additionally, radiated emissions below 30MHz are also validated on an Open Area Test Site to assert correlation with the chamber measurements per the requirements of KDB 414788 D01.

4.0 MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of k = 2 to indicate a 95% level of confidence. The measurement uncertainty shown below meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty (±dB)
Conducted Bench Top Measurements	1.13
Radiated Disturbance (<1GHz)	4.98
Radiated Disturbance (>1GHz)	5.07
Radiated Disturbance (>18GHz)	5.09

5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST). Measurements antennas used during testing were calibrated in accordance to the requirements of ANSI C63.5-2017.

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	AP2	EMC Cable and Switch System	3/4/2021	Annual	3/4/2022	AP2
-	AP1	EMC Cable and Switch System	3/9/2021	Annual	3/9/2022	AP1
-	LTx3	LIcensed Transmitter Cable Set	2/26/2021	Annual	2/26/2022	LTx3
-	LTx5	LIcensed Transmitter Cable Set	3/3/2021	Annual	3/3/2022	LTx5
Agilent	E5515C	Wireless Communications Test Set	N/A			GB46310798
Anritsu	MT8821C	Radio Communication Analyzer	N/A			6200901190
Com-Power	AL-130R	Active Loop Antenna	8/22/2019	Biennial	8/22/2021	121085
Emco	3115	Horn Antenna (1-18GHz)	6/18/2020	Biennial	6/18/2022	9704-5182
Emco	3116	Horn Antenna (18 - 40GHz)	8/7/2018	Triennial	8/7/2021	9203-2178
Espec	ESX-2CA	Environmental Chamber	8/27/2020	Annual	8/27/2022	17620
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	3/12/2020	Biennial	3/12/2022	128337
Keysight Technologies	N9030A	PXA Signal Analyzer (44GHz)	8/17/2020	Annual	8/17/2021	MY52350166
Keysight Technologies	N9038A	MXE EMI Receiver	8/11/2020	Annual	8/11/2021	MY51210133
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator	N/A			11403100002
Rohde & Schwarz	CMW500	Radio Communication Tester	N/A			112347
Rohde & Schwarz	ESU26	EMI Test Receiver (26.5GHz)	7/15/2020	Annual	7/15/2021	100342
Rohde & Schwarz	ESU40	EMI Test Receiver (40GHz)	9/9/2020	Annual	9/9/2021	100348
Rohde & Schwarz	FSW67	Signal / Spectrum Analyzer	8/10/2020	Annual	8/10/2021	103200
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	7/27/2020	Biennial	7/27/2022	A051107

Table 5-1. Test Equipment

Notes:

1. For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date.

2. Equipment with a calibration date of “N/A” shown in this list was not used to make direct calibrated measurements.

6.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz
G = Phase Modulation
7 = Quantized/Digital Info
D = Data transmission, telemetry, telecommand

QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz
W = Amplitude/Angle Modulated
7 = Quantized/Digital Info
D = Data transmission, telemetry, telecommand

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was –81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of –81.0 dBm on the spectrum analzyer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of –30.9 dBm yielding –24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm – (-24.80).

7.0 TEST RESULTS

7.1 Summary

Company Name: Samsung Electronics Co., Ltd.

FCC ID: A3LSMA528B

FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)

Mode(s): WCDMA/LTE/NR

Test Condition	Test Description	FCC Part Section(s)	Test Limit	Test Result	Reference
CONDUCTED	Transmitter Conducted Output Power	2.1046	N/A	PASS	Section 7.2
	Occupied Bandwidth	2.1049(h)	N/A	PASS	Section 7.3
	Conducted Band Edge / Spurious Emissions (LTE Band 12, 17)	2.1051, 27.53(g)	≥ 43 + 10 log (P[Watts]) dB of attenuation below transmitter power	PASS	Sections 7.4, 7.5
	Conducted Band Edge / Spurious Emissions (WCDMA AWS; LTE Band 4, 66; NR Band n66)	2.1051, 27.53(h)	≥ 43 + 10 log (P[Watts]) dB of attenuation below transmitter power	PASS	Sections 7.4, 7.5
	Peak-to-Average Ratio (WCDMA AWS; LTE Band 4, 66; NR Band n66)	27.50(d)(5)	≤ 13 dB	PASS	Section 7.6
	Frequency Stability	2.1055, 27.54	Fundamental emissions stay within authorized frequency block	PASS	Section 7.9
RADIATED	Effective Radiated Power (LTE Band 12, 17)	27.50(c)(10)	≤ 3 Watts max. ERP	PASS	Section 7.7
	Equivalent Isotropic Radiated Power (WCDMA AWS; LTE Band 4, 66; NR Band n66)	27.50(d)(10)	≤ 1 Watt max. EIRP	PASS	Section 7.7
	Radiated Spurious Emissions (LTE Band 12, 17)	2.1053, 27.53(g)	≥ 43 + 10 log (P[Watts]) dB of attenuation below transmitter power	PASS	Section 7.8
	Radiated Spurious Emissions (WCDMA AWS; LTE Band 4, 66; NR Band n66)	2.1053, 27.53(h)	≥ 43 + 10 log (P[Watts]) dB of attenuation below transmitter power	PASS	Section 7.8

Table 7-1. Summary of Test Results (FCC)

Notes:

1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
2) The analyzer plots shown in Section 7.0 were taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and

attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.

3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
4) For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is PCTEST 2G/3G Automation Version 4.2.

7.2 Occupied Bandwidth

Test Overview

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 4.2

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW ≥ 3 x RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

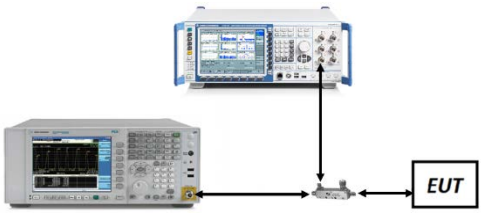
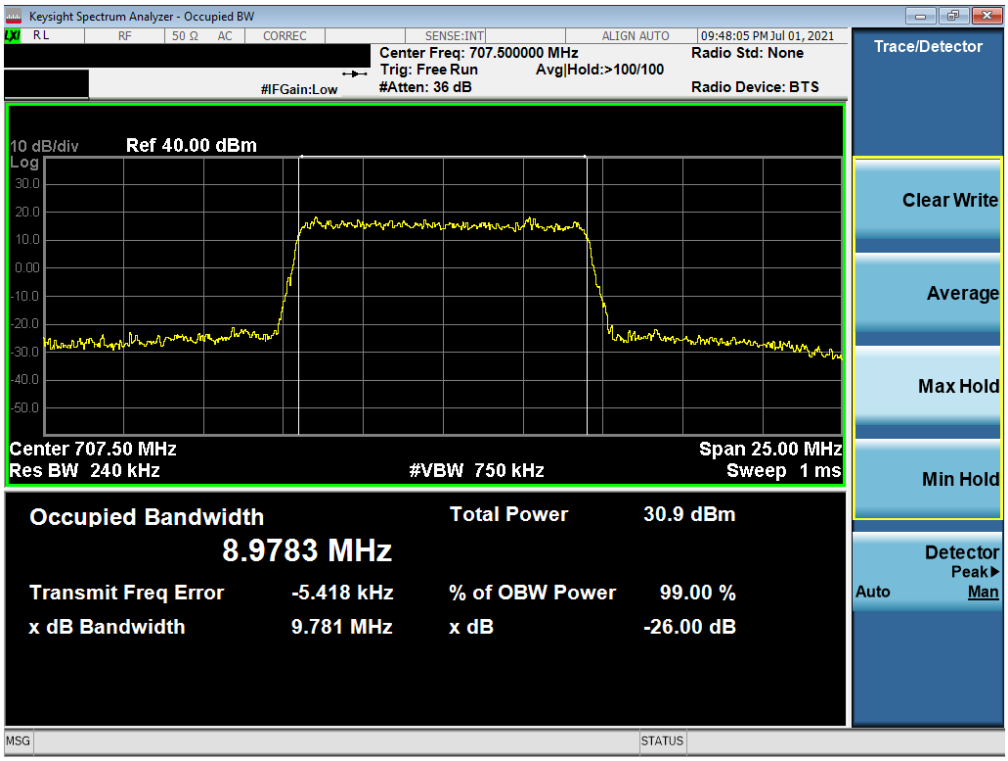


Figure 7-1. Test Instrument & Measurement Setup

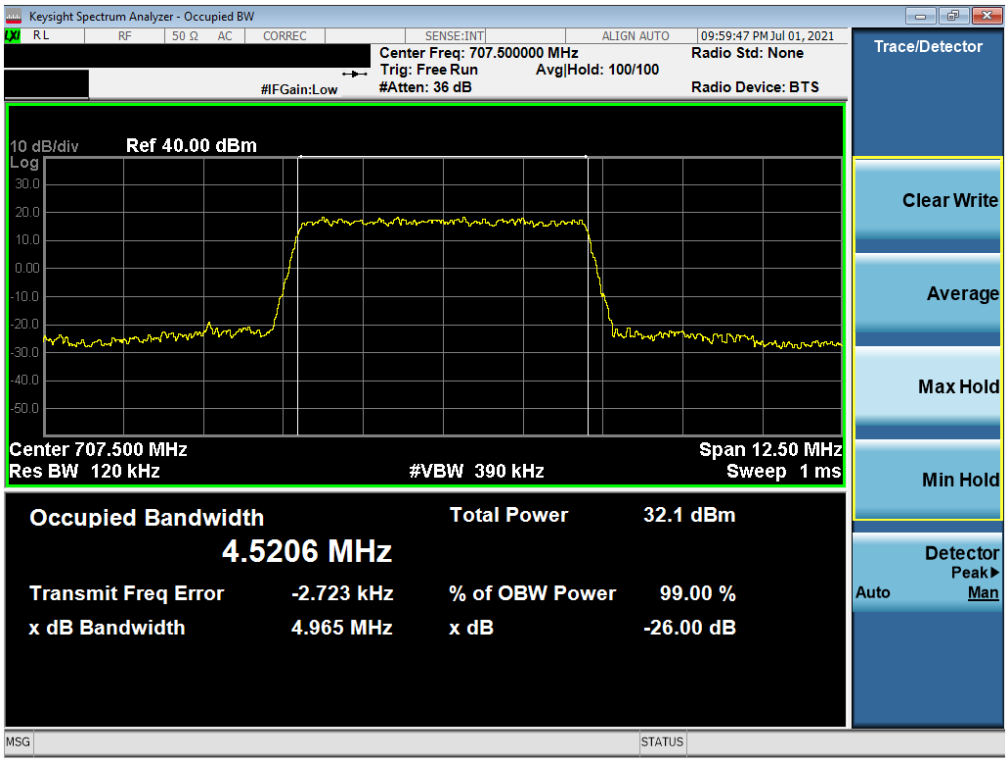
Test Notes

None.

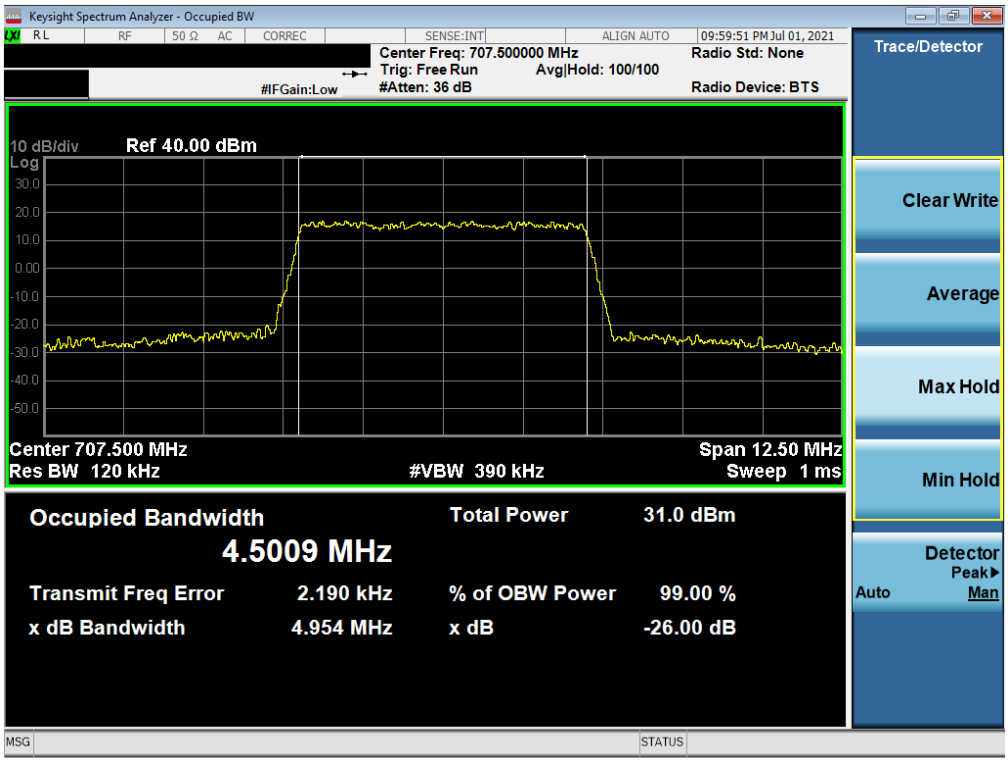
Plot 7-1. Occupied Bandwidth Plot (LTE Band 12/17 - 10MHz QPSK - Full RB)



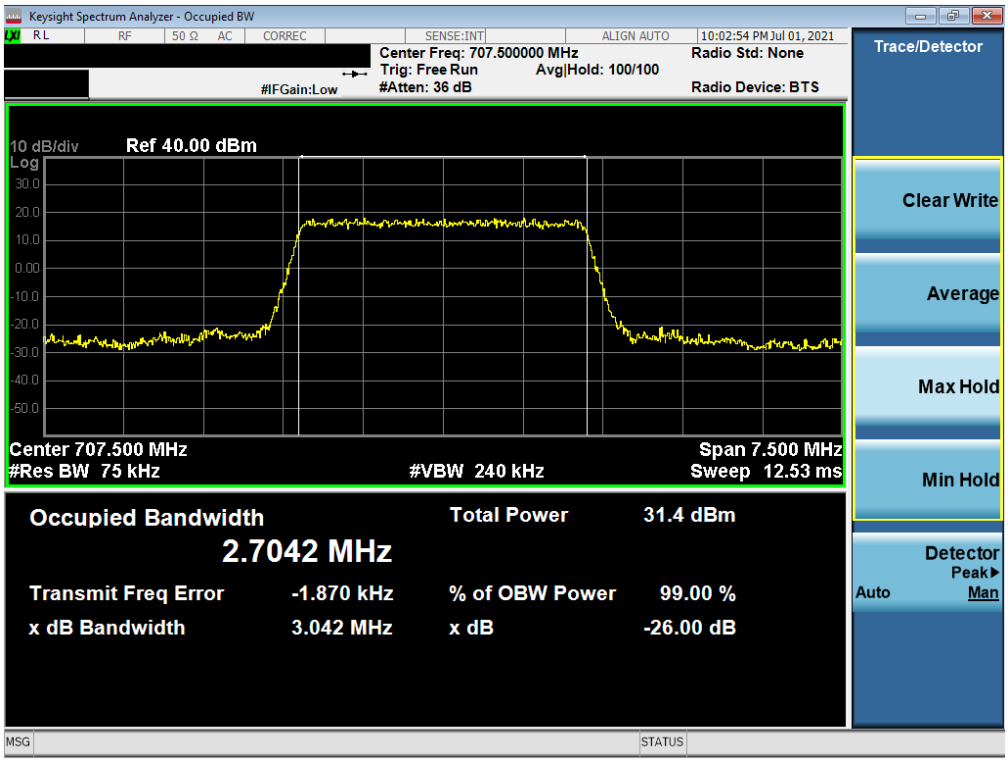
Plot 7-2. Occupied Bandwidth Plot (LTE Band 12/17 - 10MHz 16-QAM - Full RB)



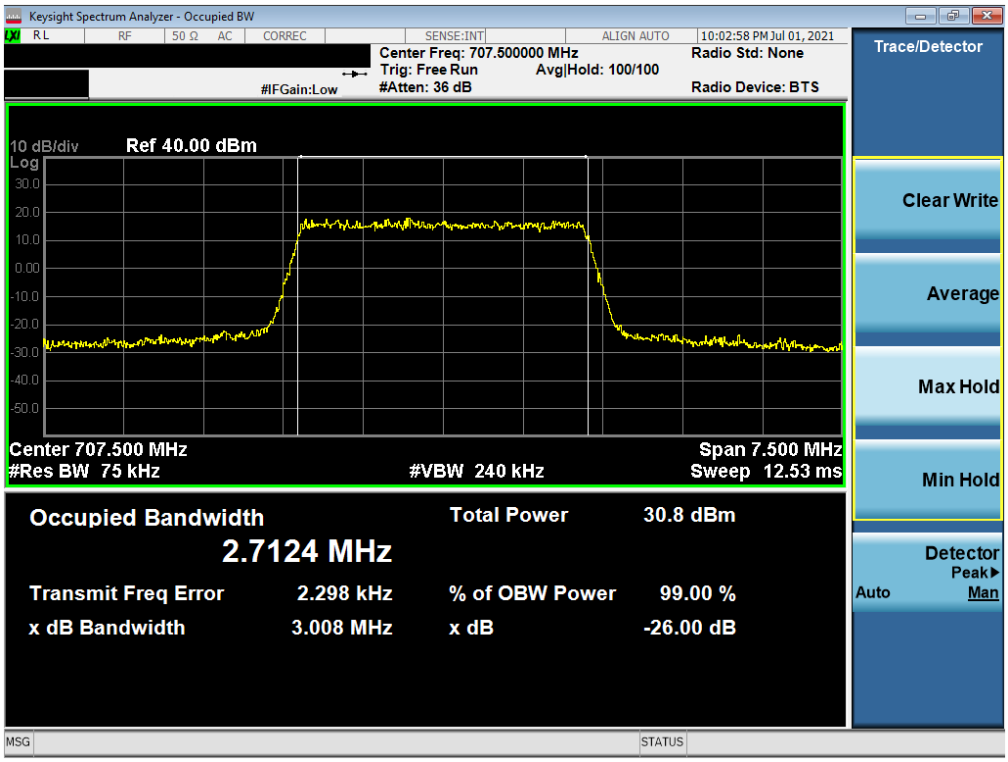
Plot 7-3. Occupied Bandwidth Plot (LTE Band 12/17 - 5MHz QPSK - Full RB)



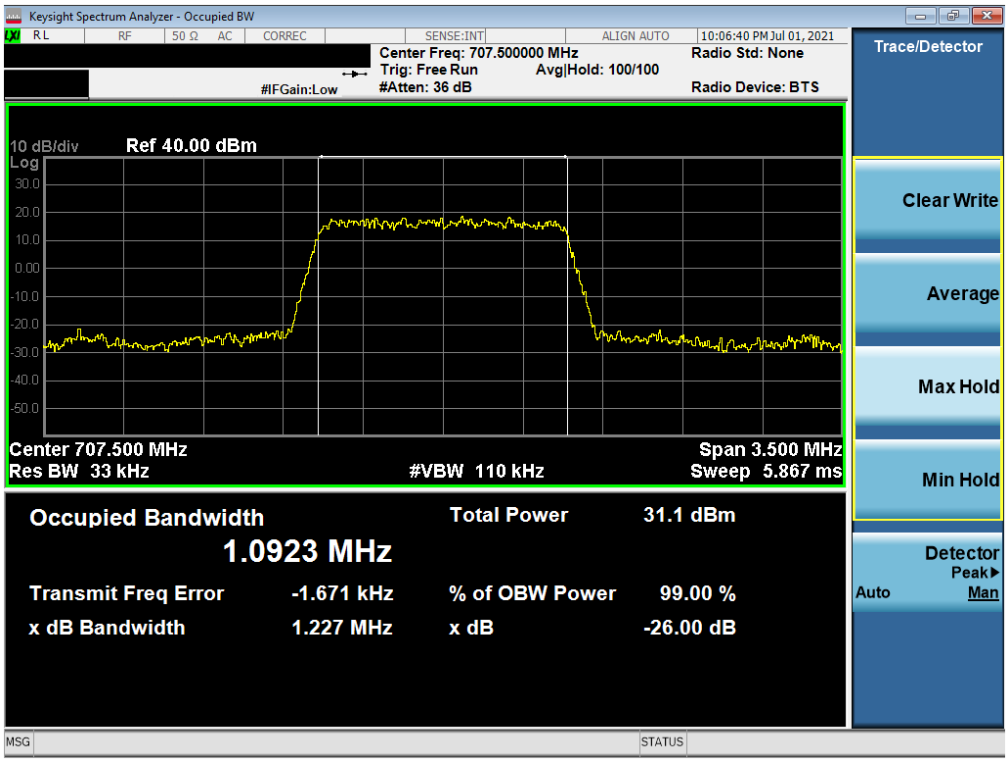
Plot 7-4. Occupied Bandwidth Plot (LTE Band 12/17 - 5MHz 16-QAM - Full RB)



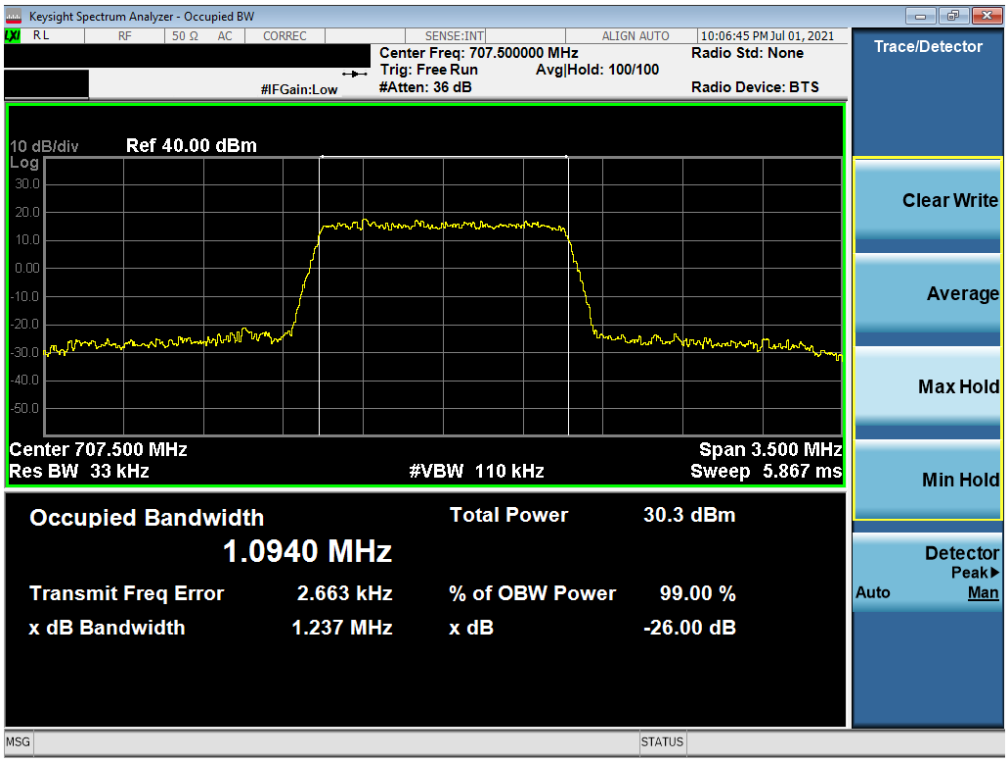
Plot 7-5. Occupied Bandwidth Plot (LTE Band 12 - 3MHz QPSK - Full RB)



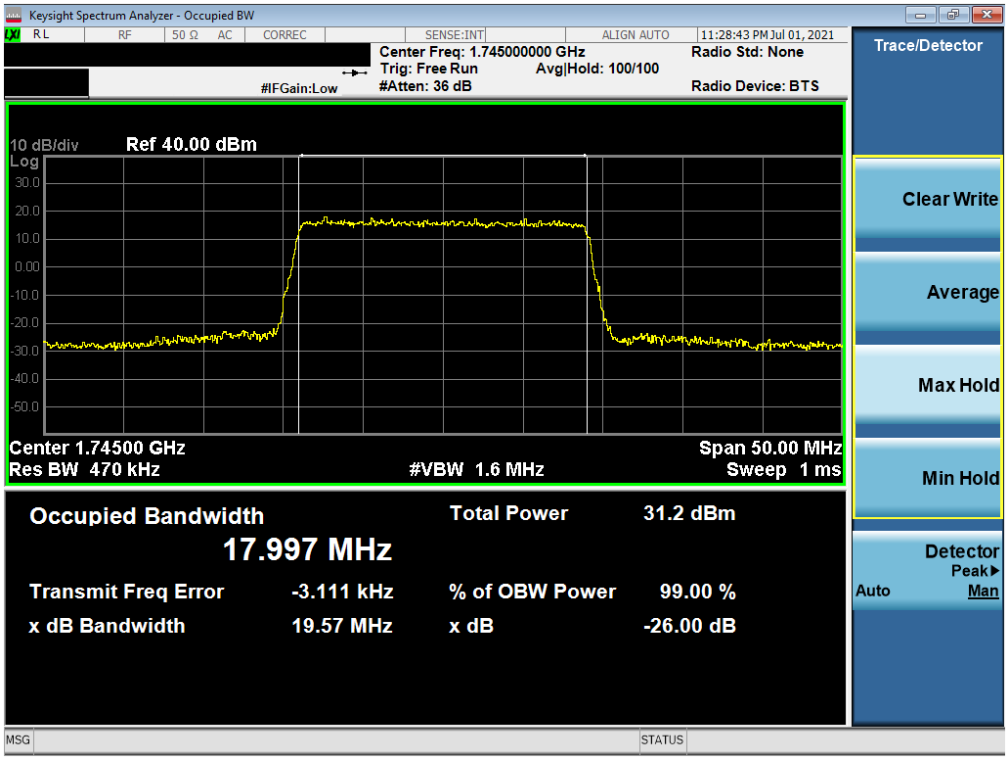
Plot 7-6. Occupied Bandwidth Plot (LTE Band 12 - 3MHz 16-QAM - Full RB)



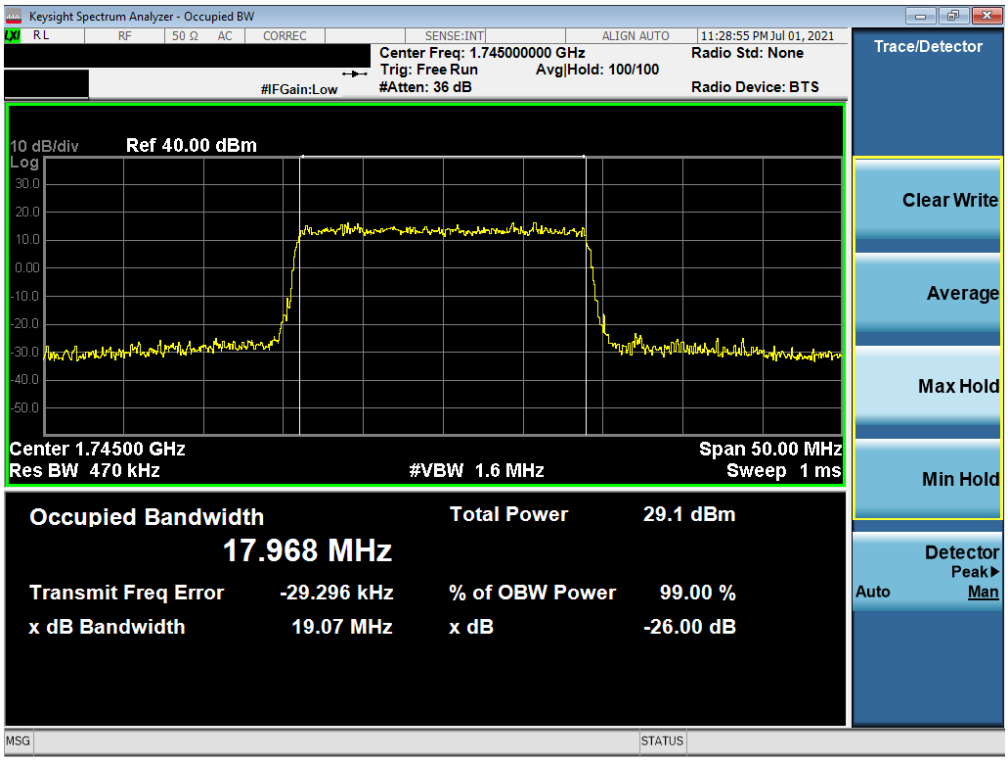
Plot 7-7. Occupied Bandwidth Plot (LTE Band 12 – 1.4MHz QPSK - Full RB)



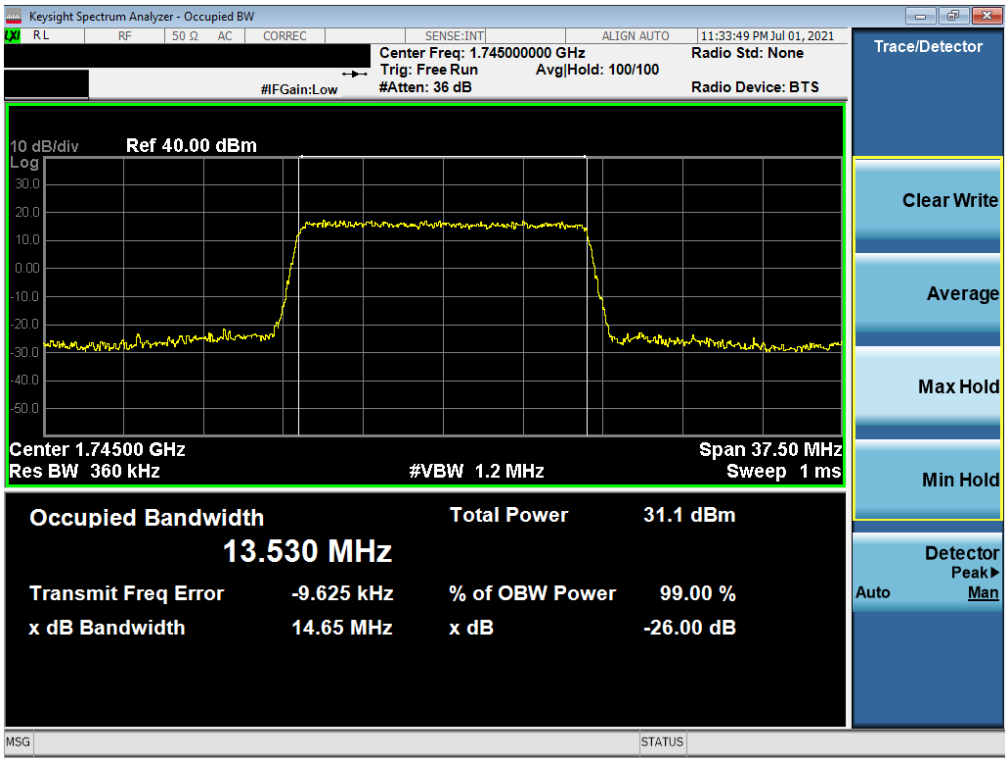
Plot 7-8. Occupied Bandwidth Plot (LTE Band 12 – 1.4MHz 16-QAM - Full RB)



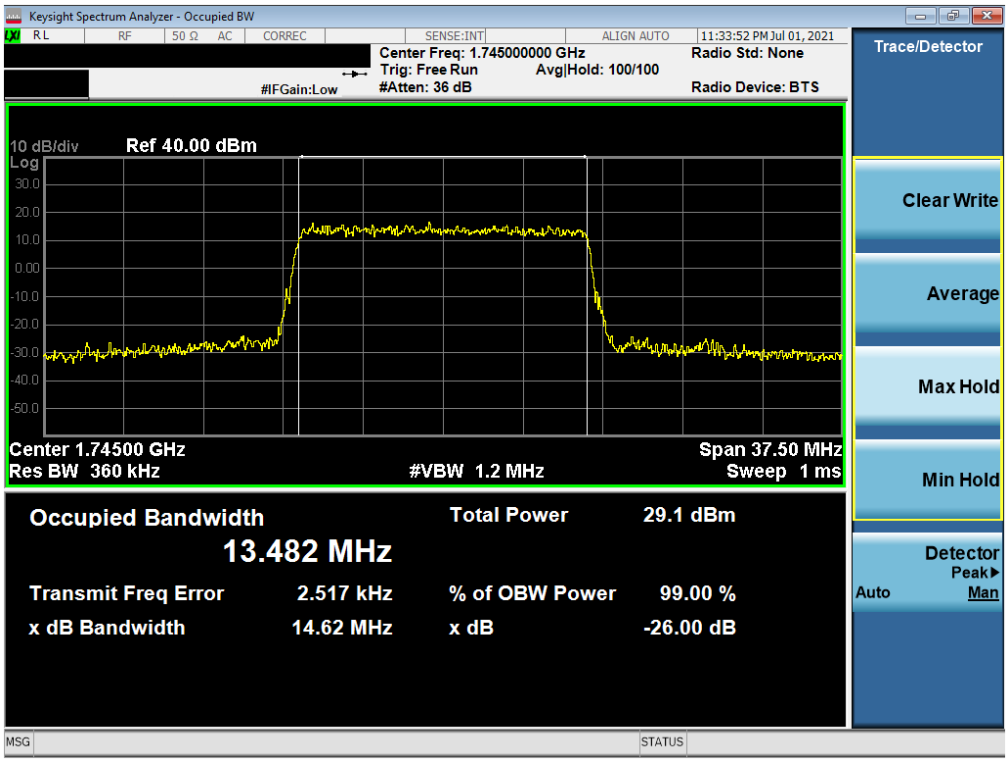
Plot 7-9. Occupied Bandwidth Plot (LTE Band 66/4 - 20MHz QPSK - Full RB)



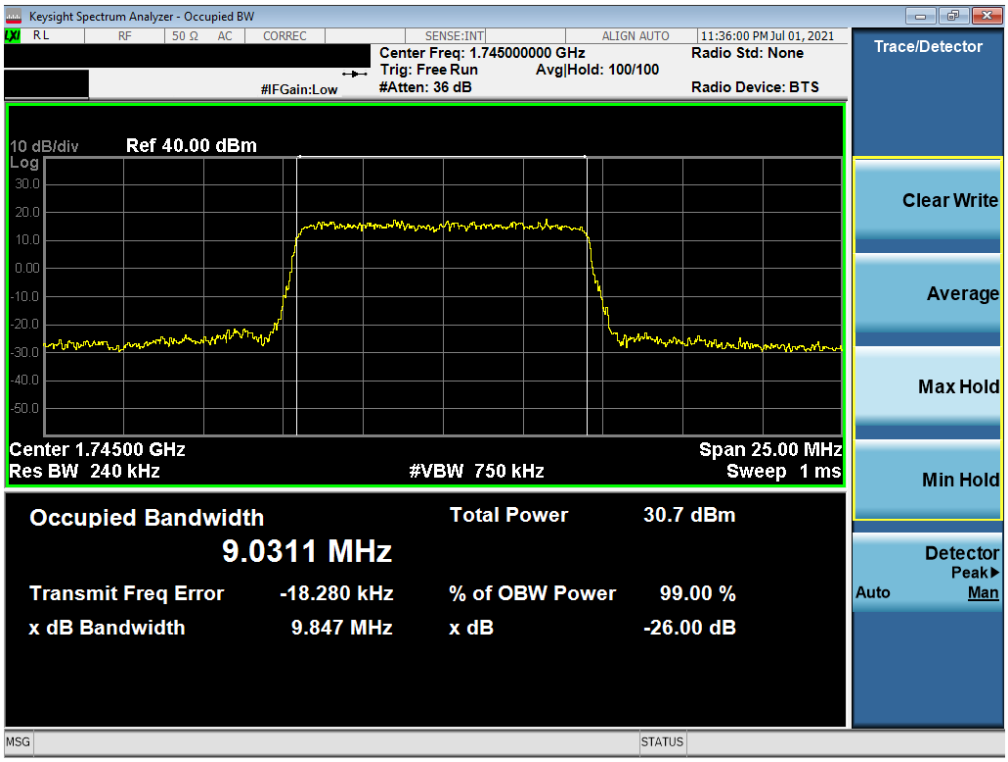
Plot 7-10. Occupied Bandwidth Plot (LTE Band 66/4 - 20MHz 16-QAM - Full RB)



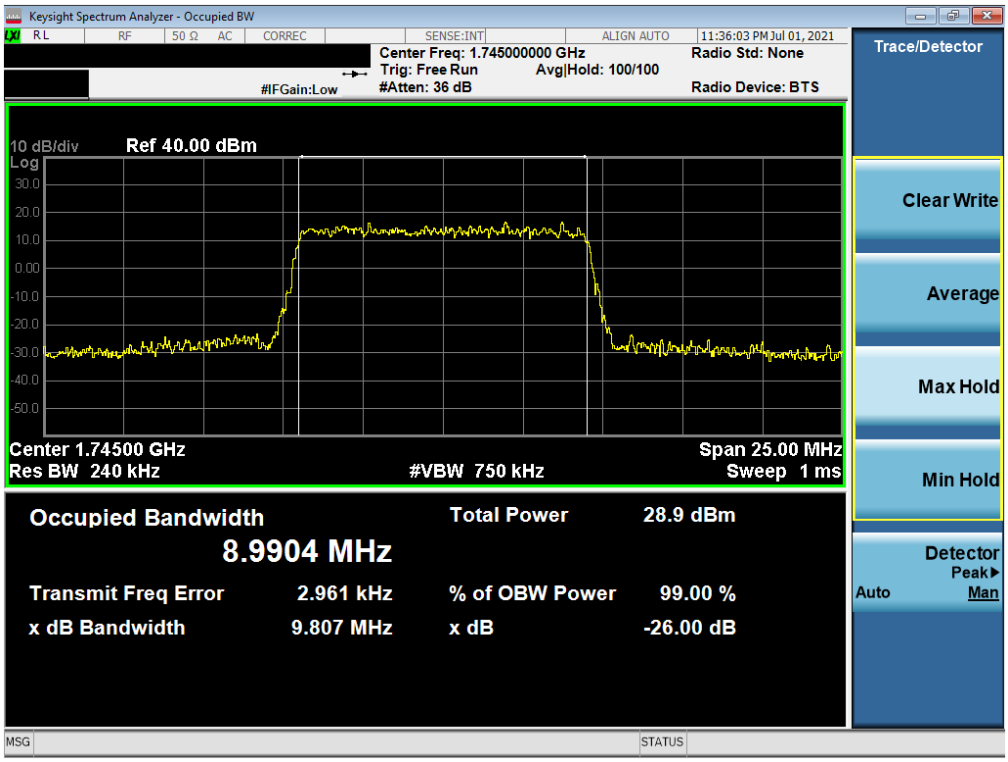
Plot 7-11. Occupied Bandwidth Plot (LTE Band 66/4 - 15MHz QPSK - Full RB)



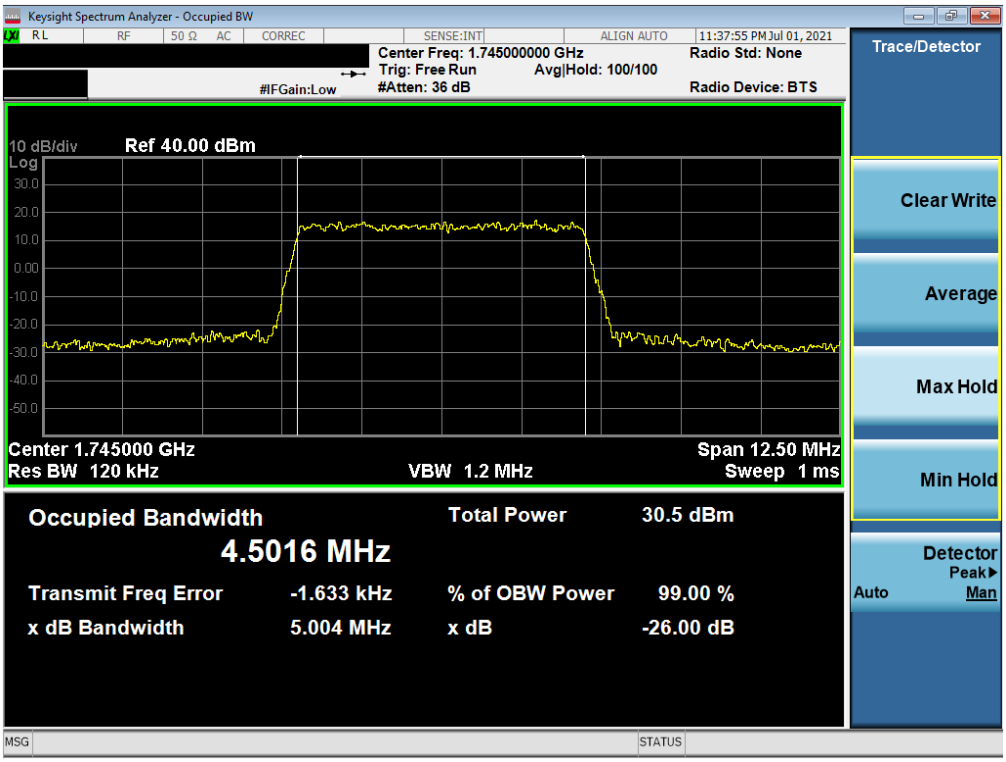
Plot 7-12. Occupied Bandwidth Plot (LTE Band 66/4 - 15MHz 16-QAM - Full RB)



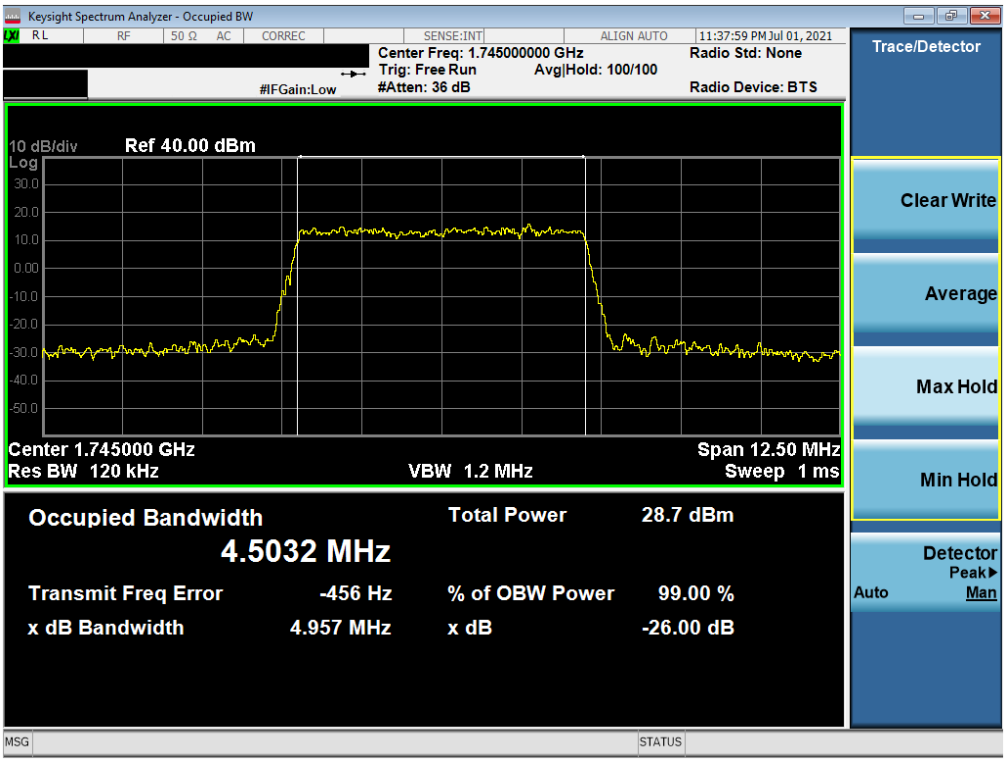
Plot 7-13. Occupied Bandwidth Plot (LTE Band 66/4 - 10MHz QPSK - Full RB)



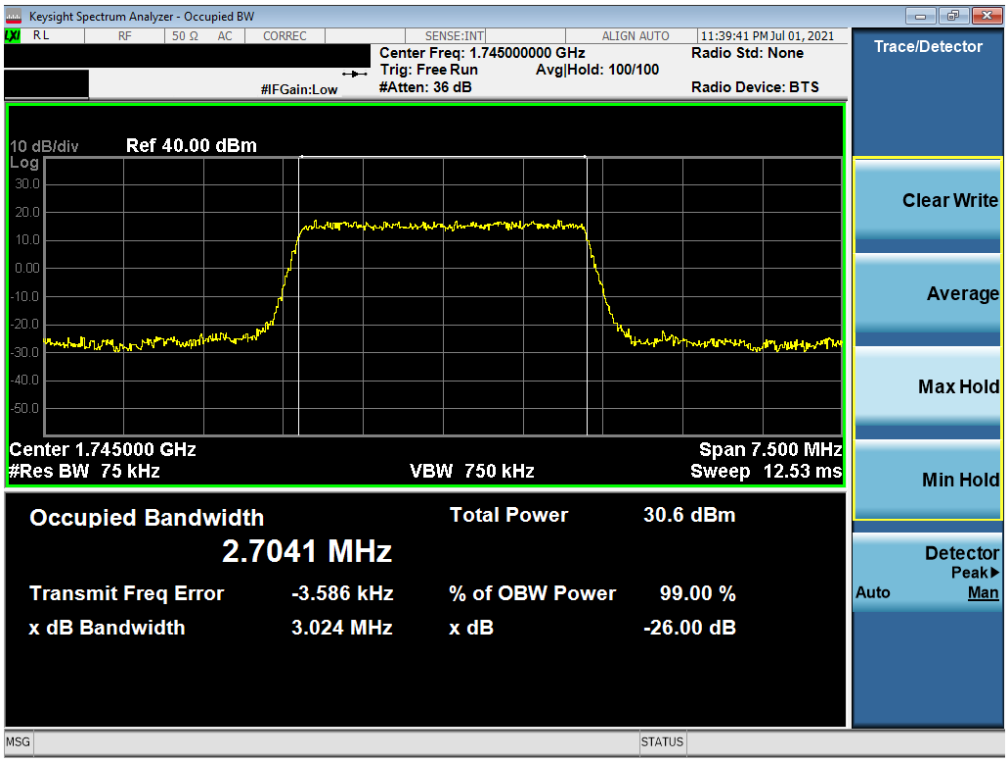
Plot 7-14. Occupied Bandwidth Plot (LTE Band 66/4 - 10MHz 16-QAM - Full RB)



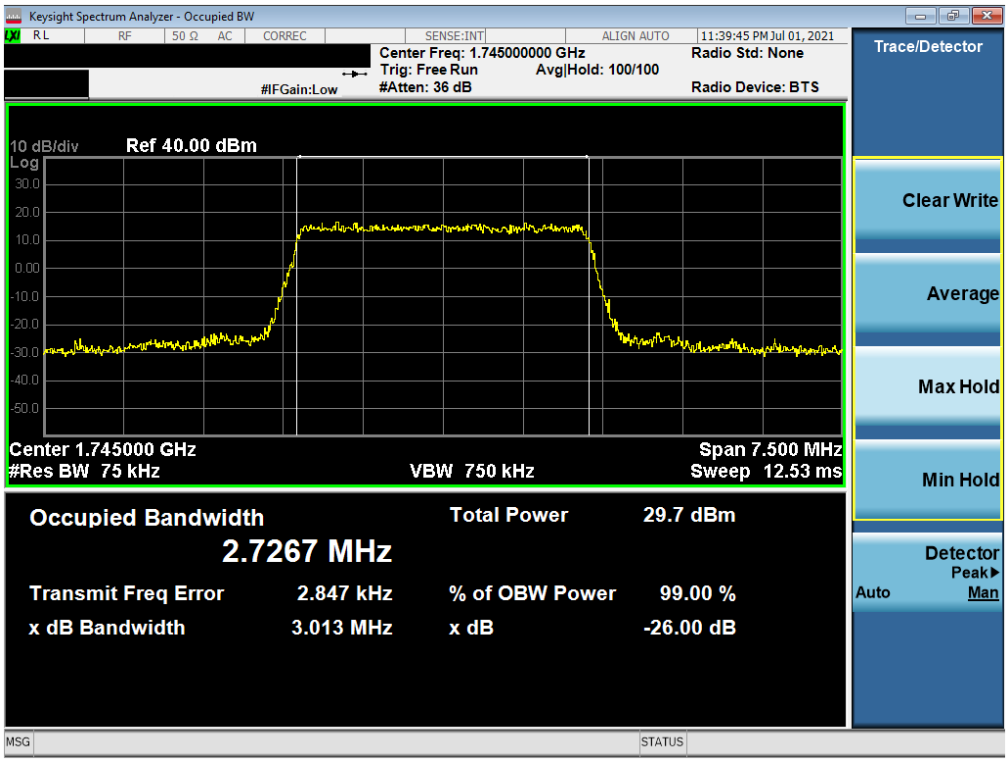
Plot 7-15. Occupied Bandwidth Plot (LTE Band 66/4 - 5MHz QPSK - Full RB)



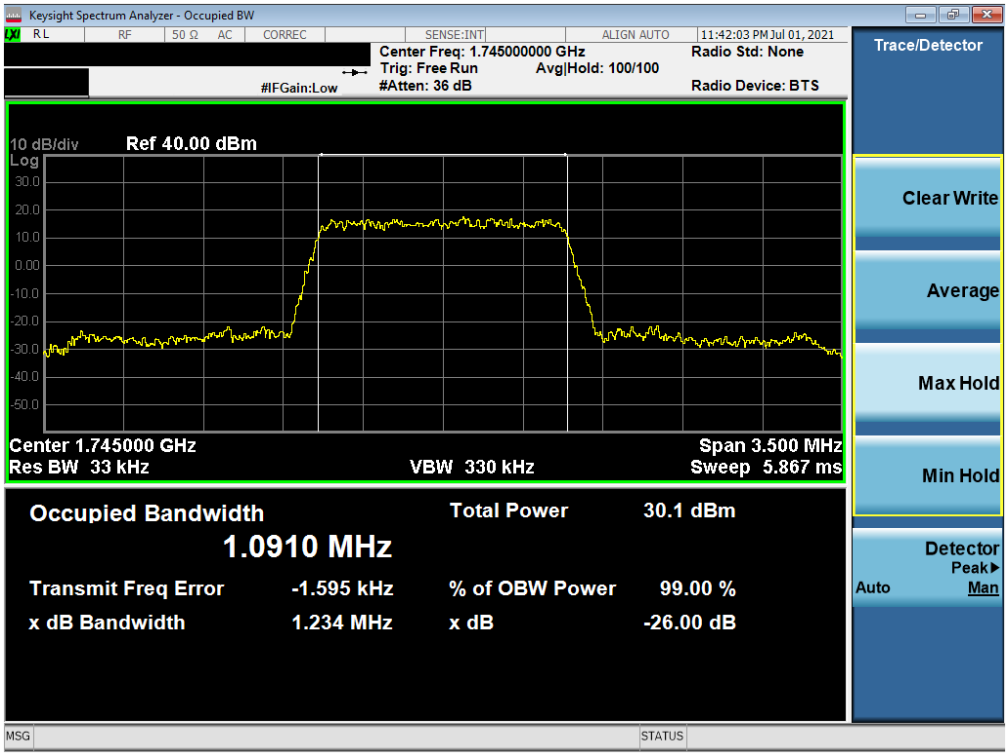
Plot 7-16. Occupied Bandwidth Plot (LTE Band 66/4 - 5MHz 16-QAM - Full RB)



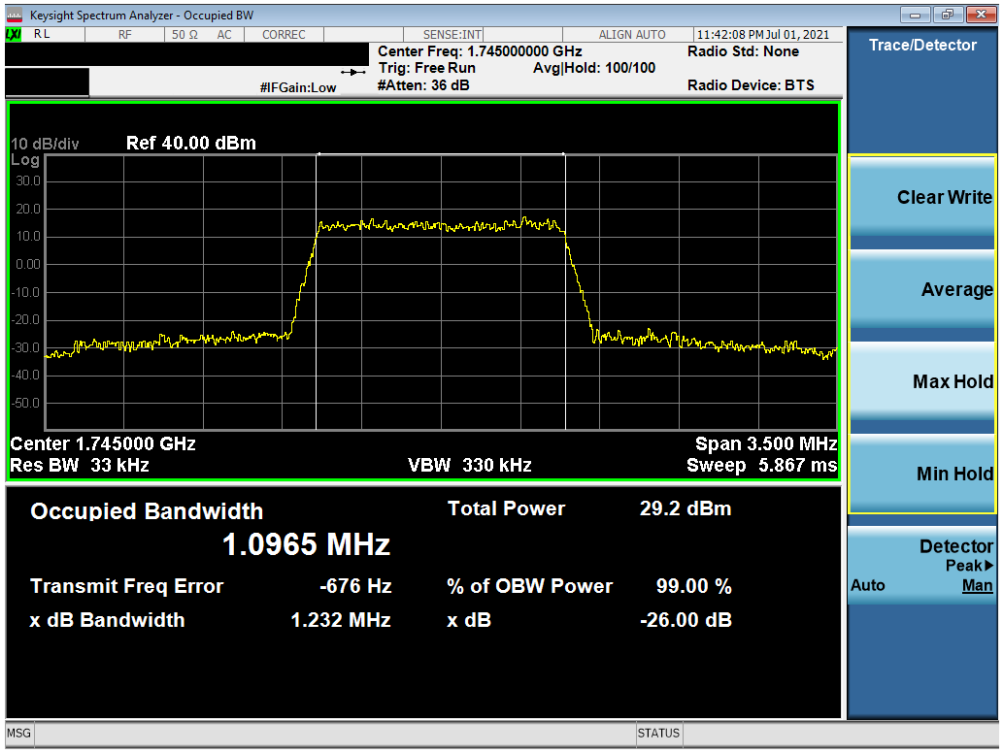
Plot 7-17. Occupied Bandwidth Plot (LTE Band 66/4 - 3MHz QPSK - Full RB)



Plot 7-18. Occupied Bandwidth Plot (LTE Band 66/4 - 3MHz 16-QAM - Full RB)

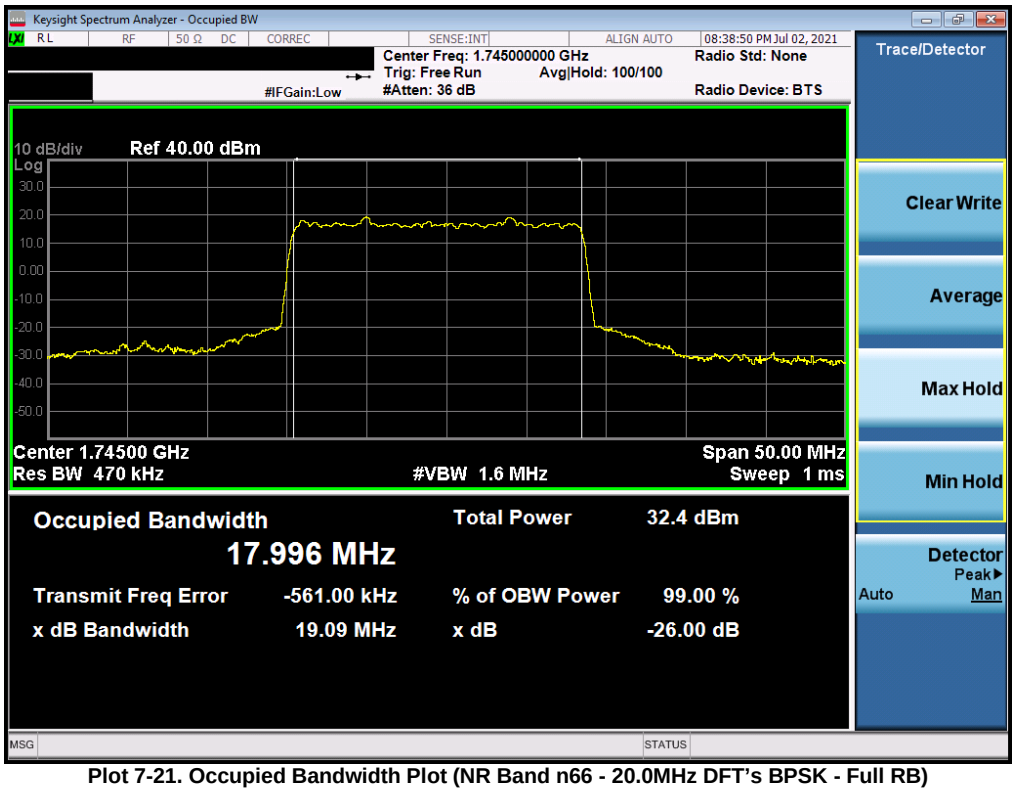


Plot 7-19. Occupied Bandwidth Plot (LTE Band 66/4 - 1.4MHz QPSK - Full RB)

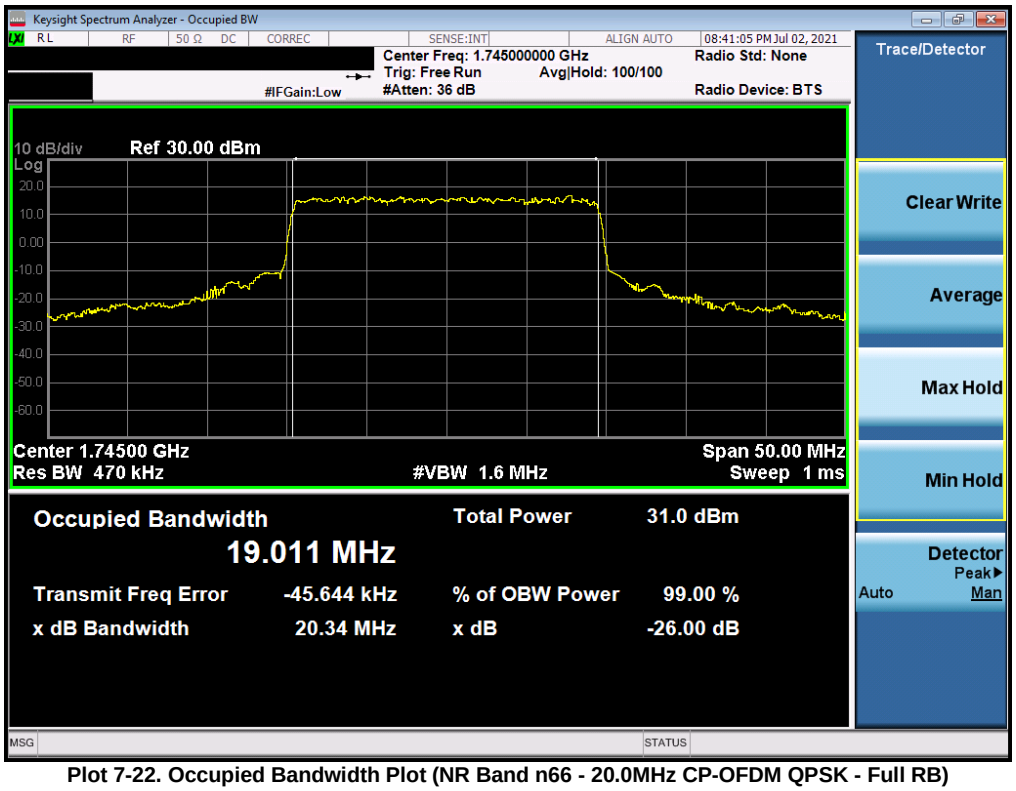


Plot 7-20. Occupied Bandwidth Plot (LTE Band 66/4 - 1.4MHz 16-QAM - Full RB)

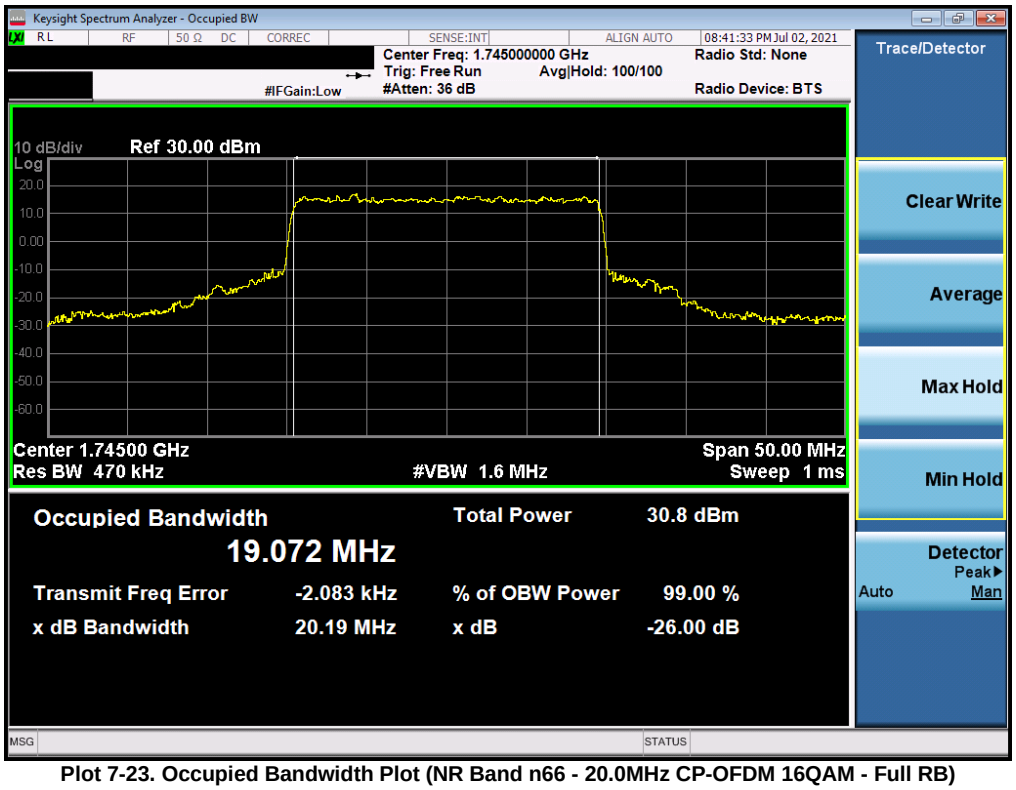
NR Band n66



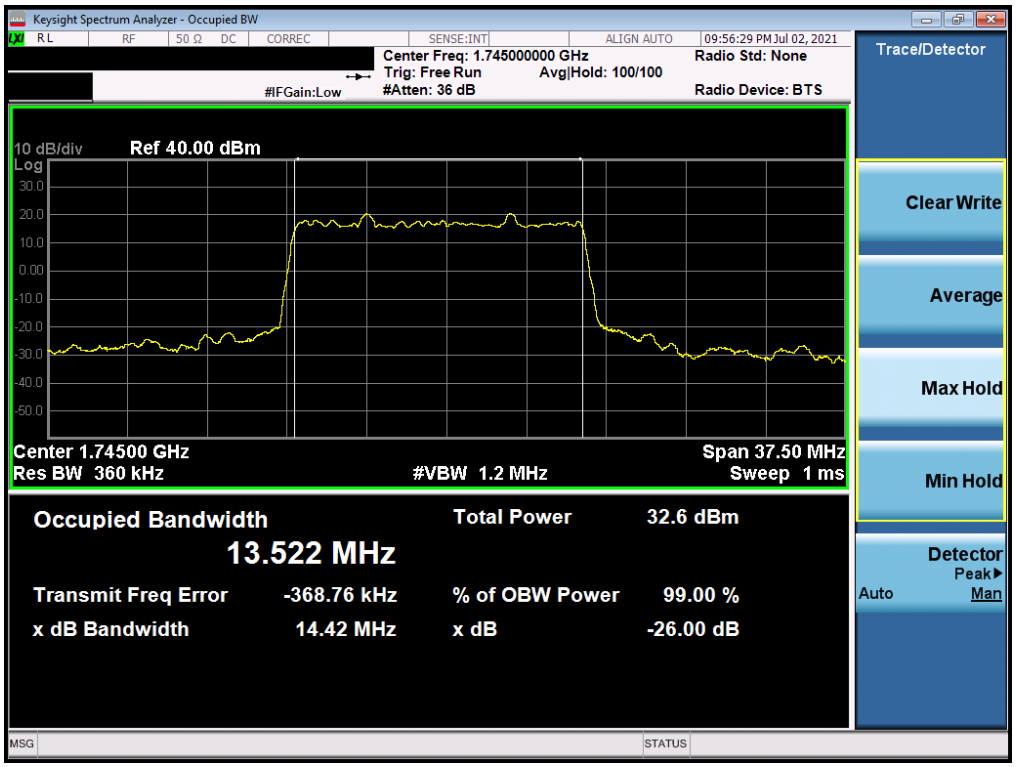
Plot 7-21. Occupied Bandwidth Plot (NR Band n66 - 20.0MHz DFT's BPSK - Full RB)



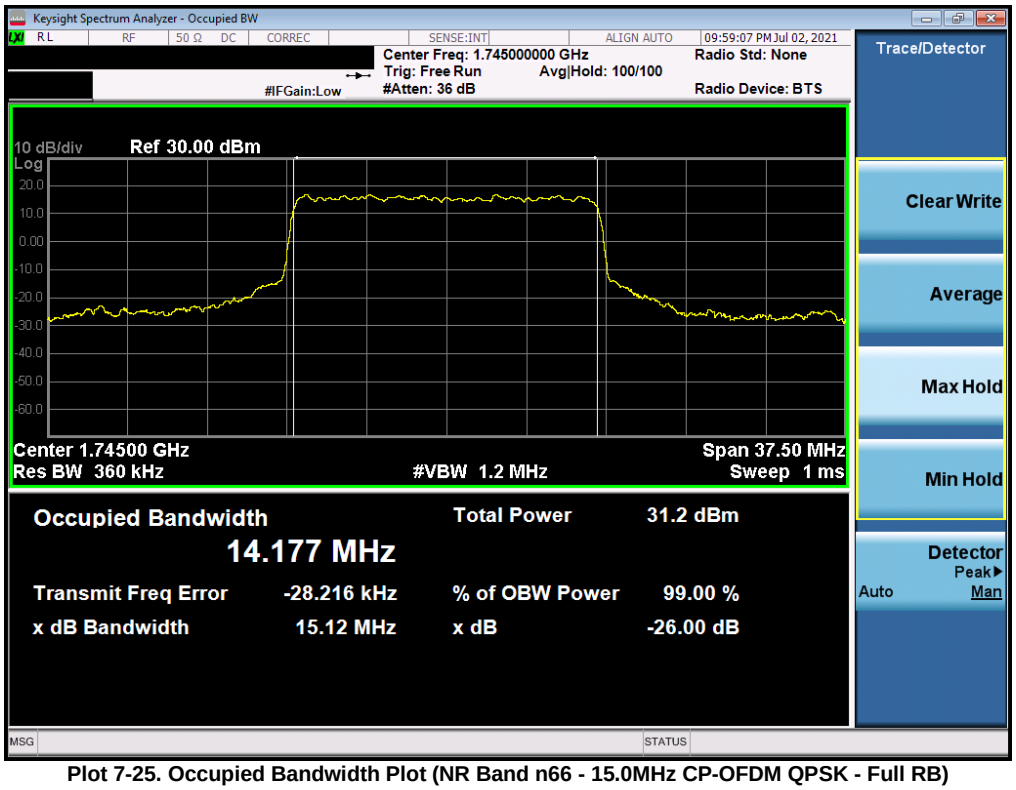
Plot 7-22. Occupied Bandwidth Plot (NR Band n66 - 20.0MHz CP-OFDM QPSK - Full RB)



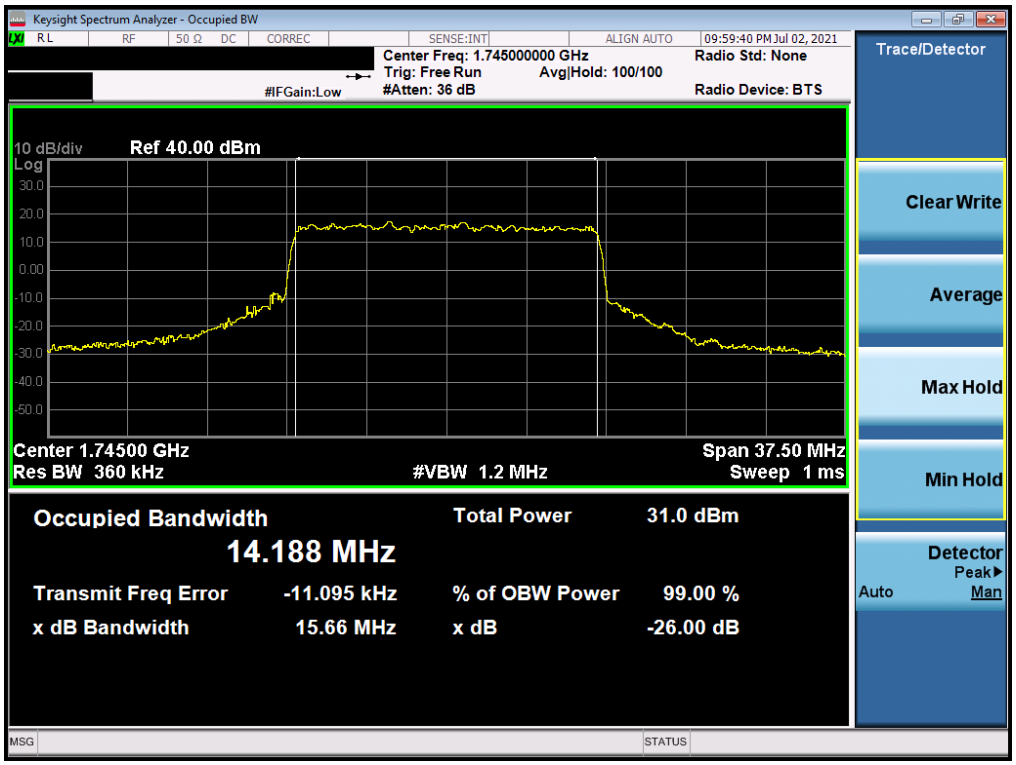
Plot 7-23. Occupied Bandwidth Plot (NR Band n66 - 20.0MHz CP-OFDM 16QAM - Full RB)



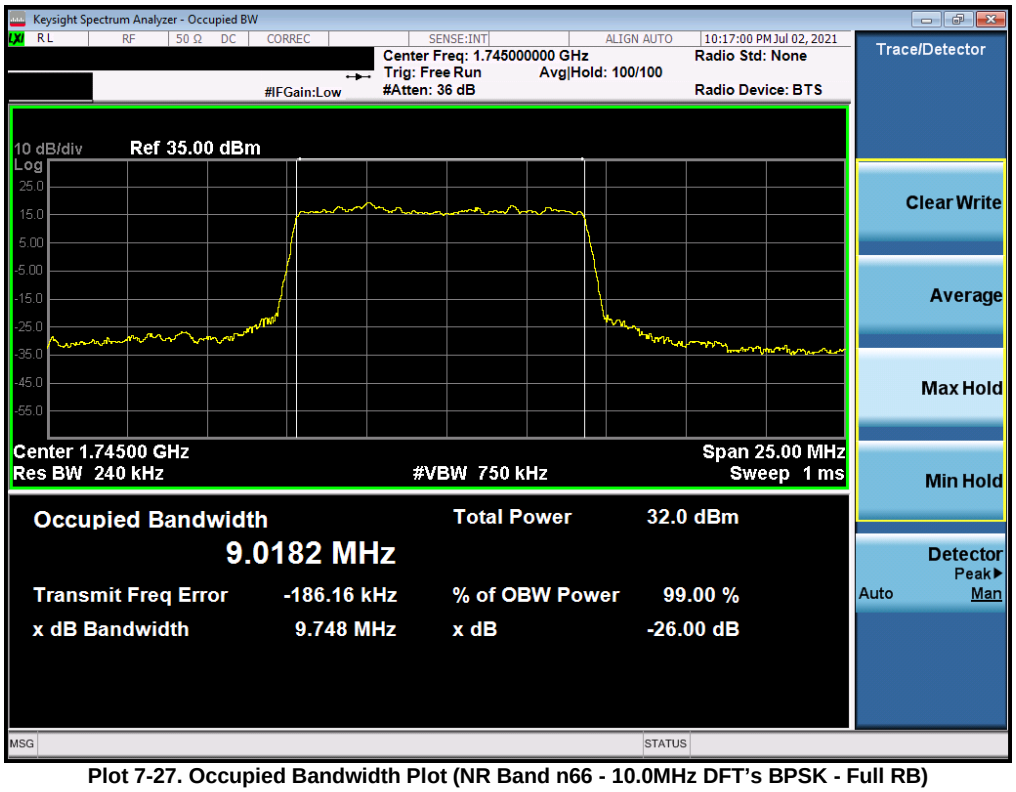
Plot 7-24. Occupied Bandwidth Plot (NR Band n66 - 15.0MHz DFT's BPSK - Full RB)



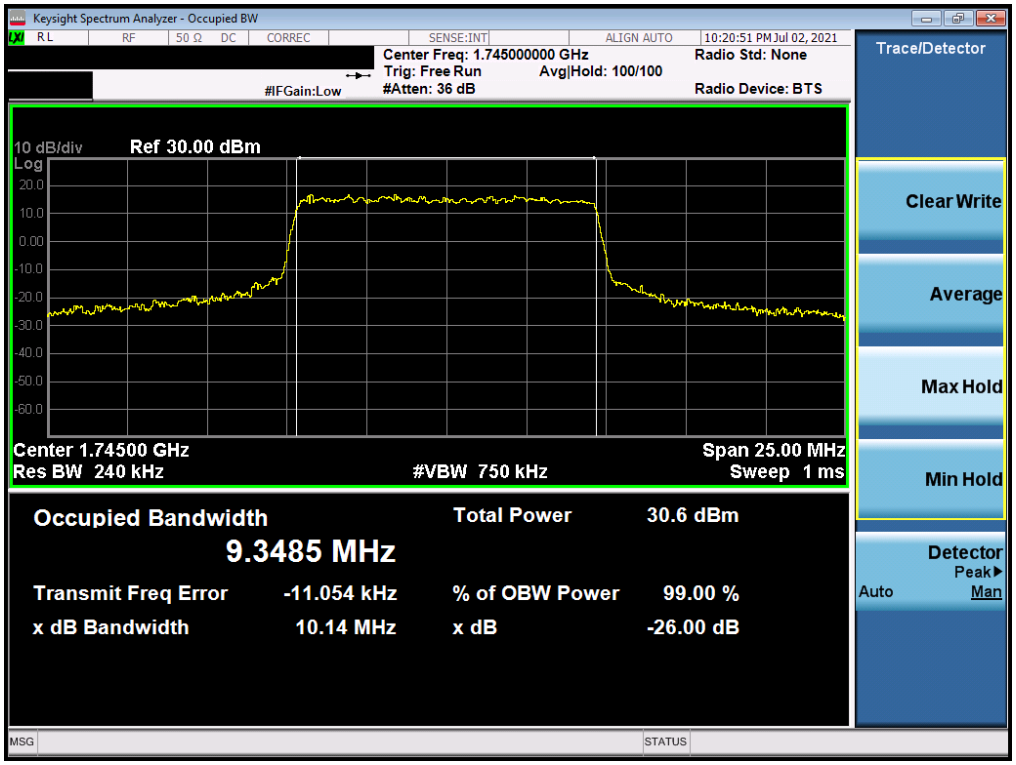
Plot 7-25. Occupied Bandwidth Plot (NR Band n66 - 15.0MHz CP-OFDM QPSK - Full RB)



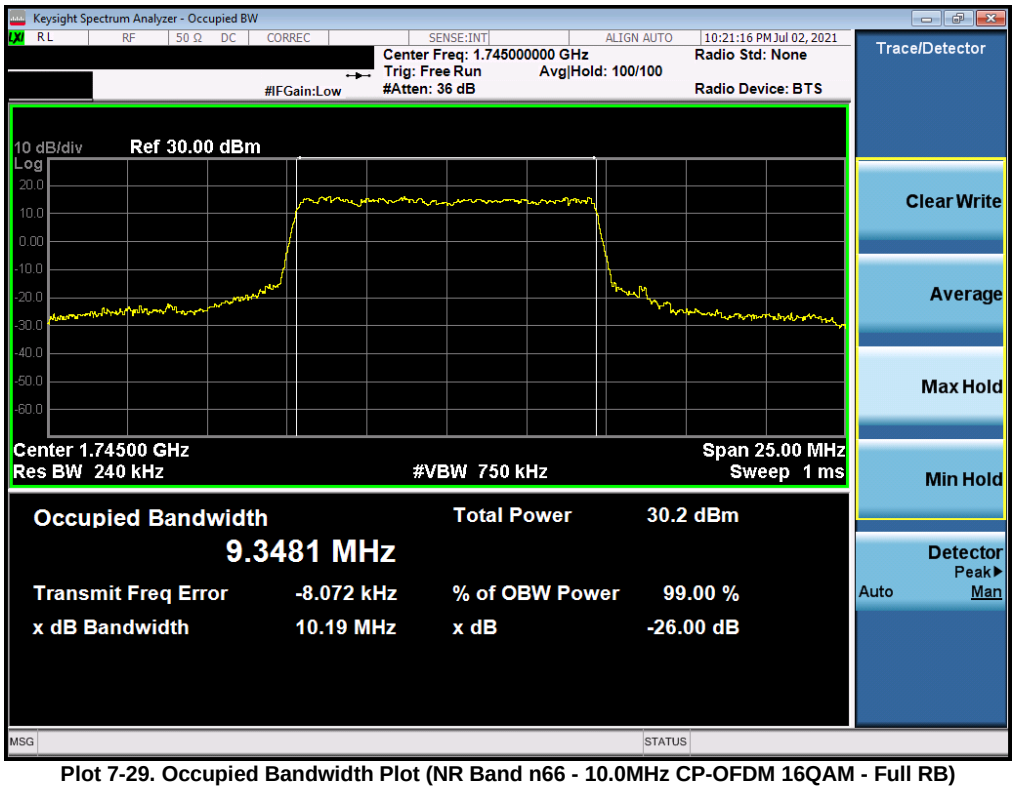
Plot 7-26. Occupied Bandwidth Plot (NR Band n66 - 15.0MHz CP-OFDM 16QAM - Full RB)



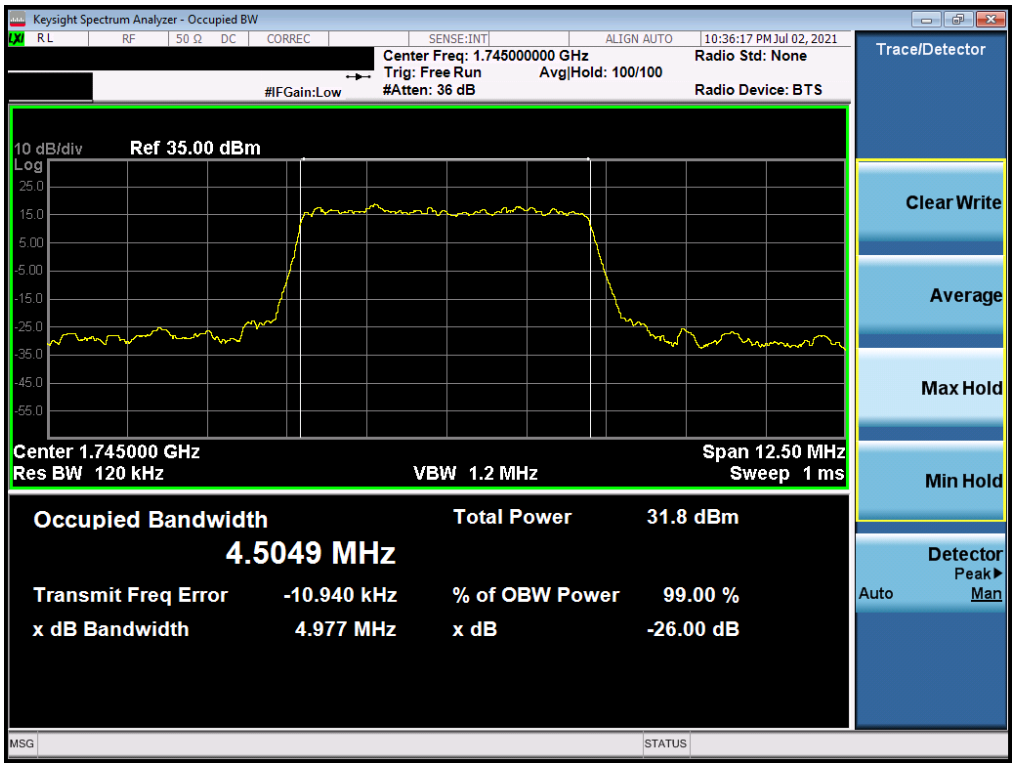
Plot 7-27. Occupied Bandwidth Plot (NR Band n66 - 10.0MHz DFT's BPSK - Full RB)



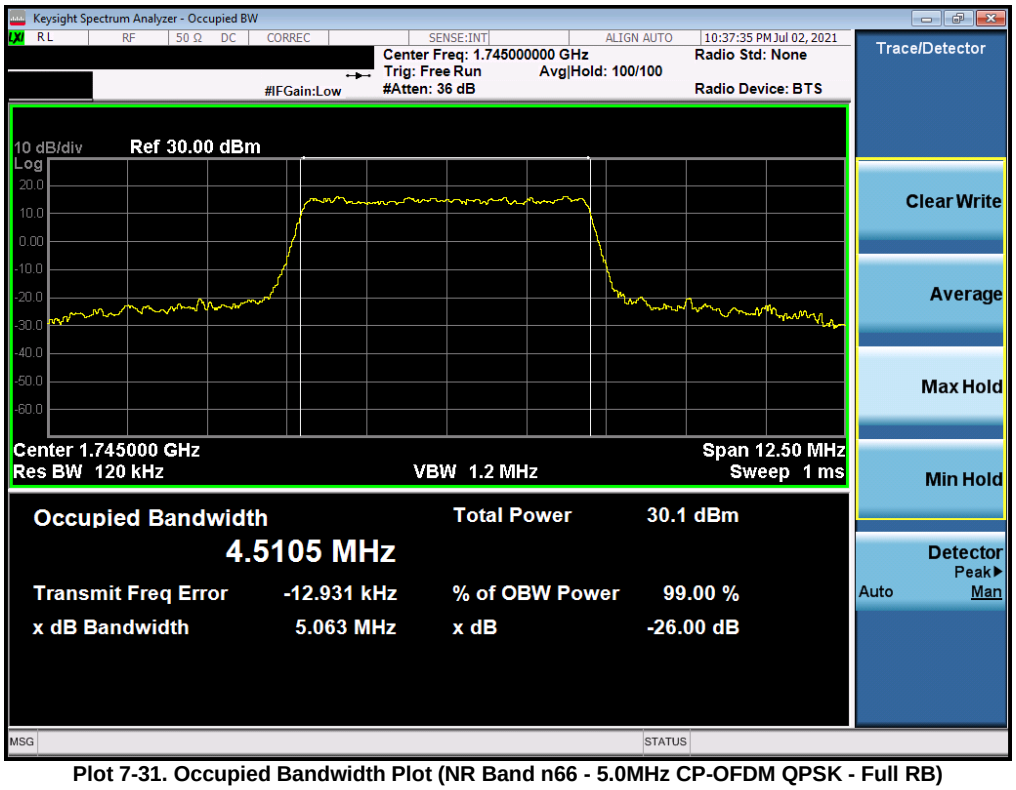
Plot 7-28. Occupied Bandwidth Plot (NR Band n66 - 10.0MHz CP-OFDM QPSK - Full RB)



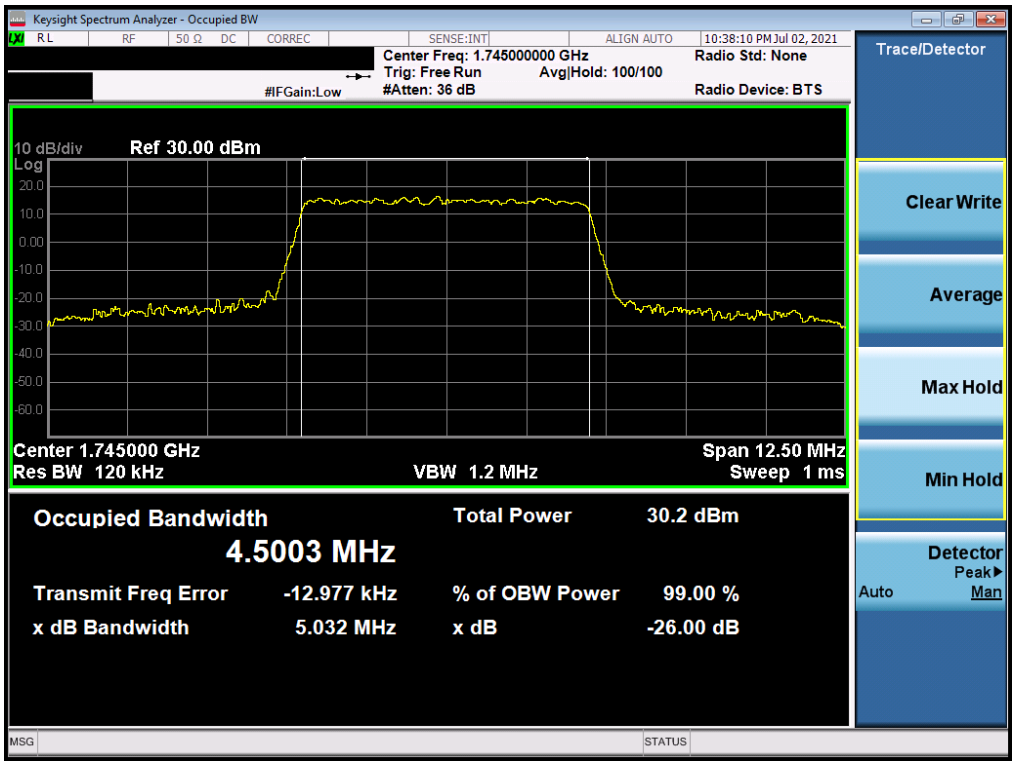
Plot 7-29. Occupied Bandwidth Plot (NR Band n66 - 10.0MHz CP-OFDM 16QAM - Full RB)



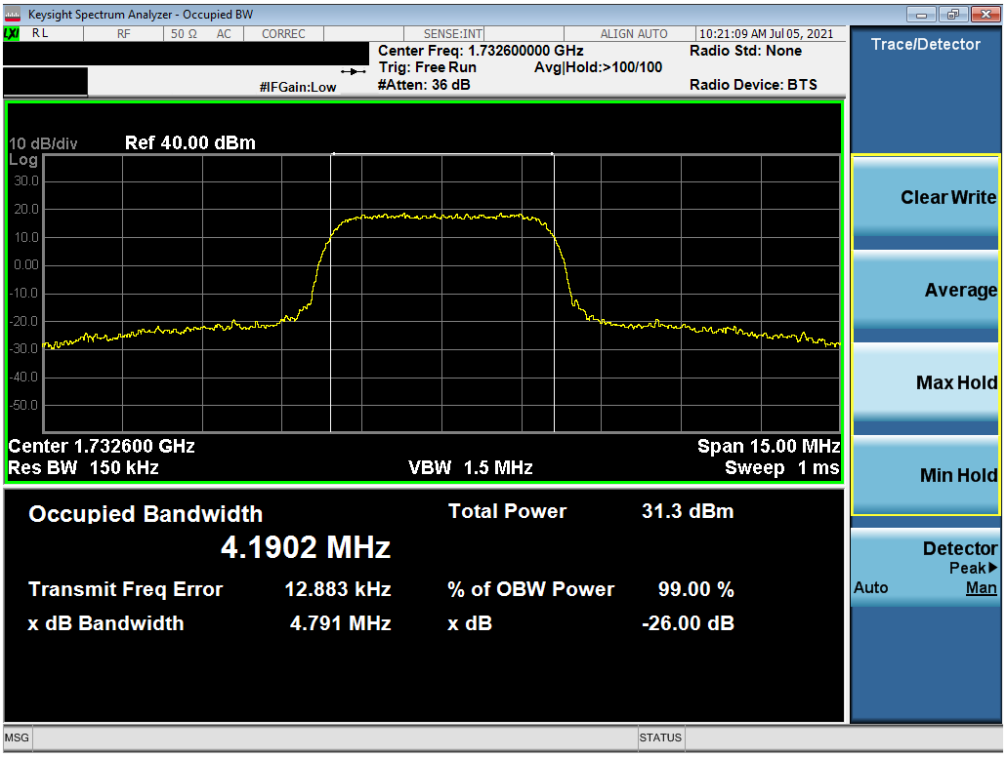
Plot 7-30. Occupied Bandwidth Plot (NR Band n66 - 5.0MHz DFT's BPSK - Full RB)



Plot 7-31. Occupied Bandwidth Plot (NR Band n66 - 5.0MHz CP-OFDM QPSK - Full RB)



Plot 7-32. Occupied Bandwidth Plot (NR Band n66 - 5.0MHz CP-OFDM 16QAM - Full RB)



Plot 7-33. Occupied Bandwidth Plot (WCDMA, Ch. 1413)

7.3 Spurious and Harmonic Emissions at Antenna Terminal

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is 43 + 10 $log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 6.0

Test Settings

1. Start frequency was set to 30MHz and stop frequency was set to 18GHz (separated into at least two plots per channel)
2. RBW ≥ 100kHz
3. VBW ≥ 3 x RBW
4. Detector = RMS
5. Trace mode = max hold
6. Sweep time = auto couple
7. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

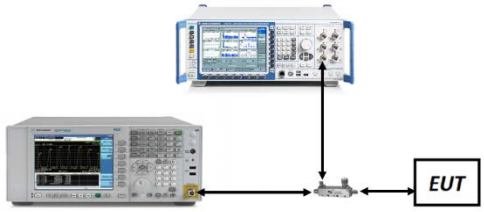
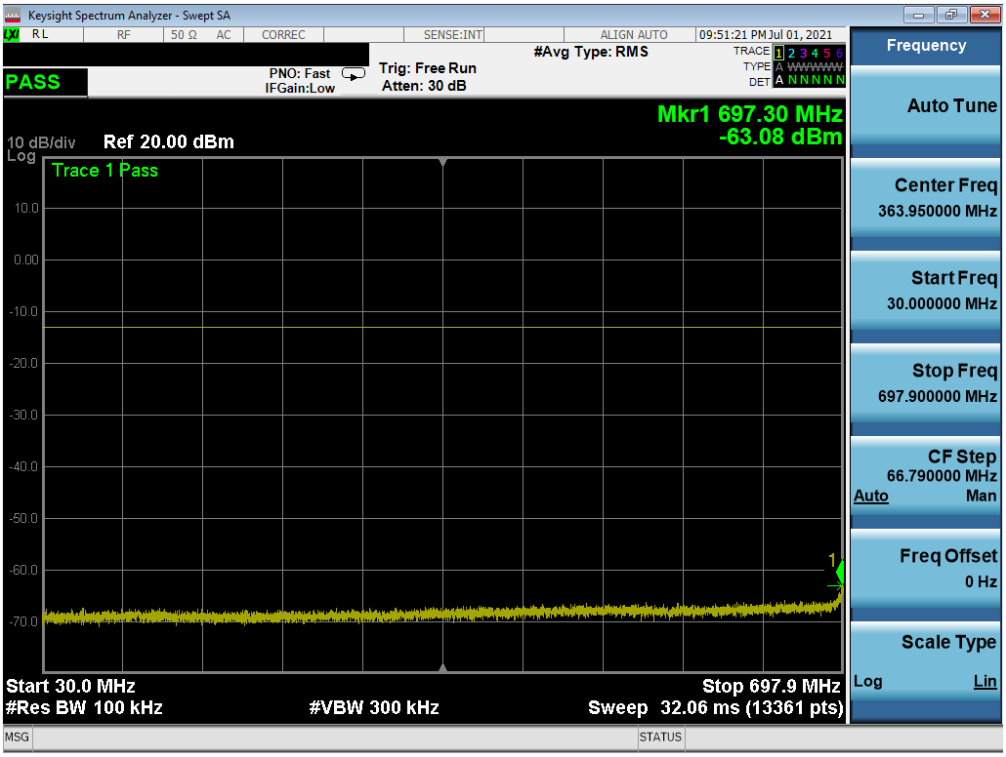


Figure 7-2. Test Instrument & Measurement Setup

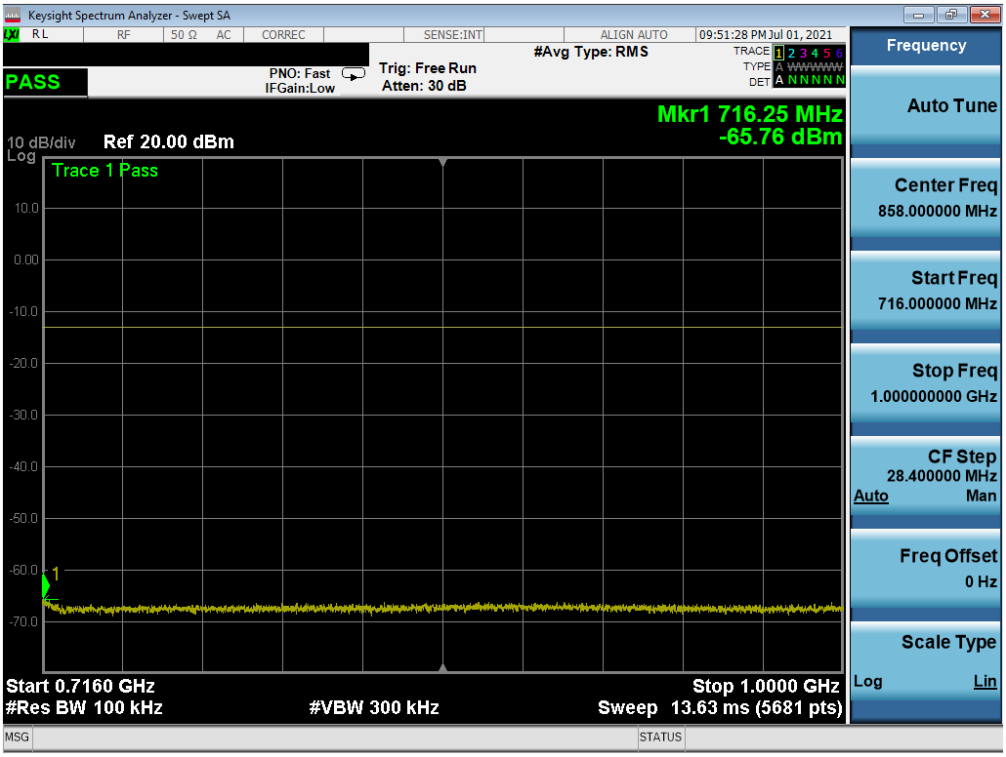
Test Notes

1. Per Part 27 and RSS-139, compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth 100 kHz or greater for measurements below 1GHz. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

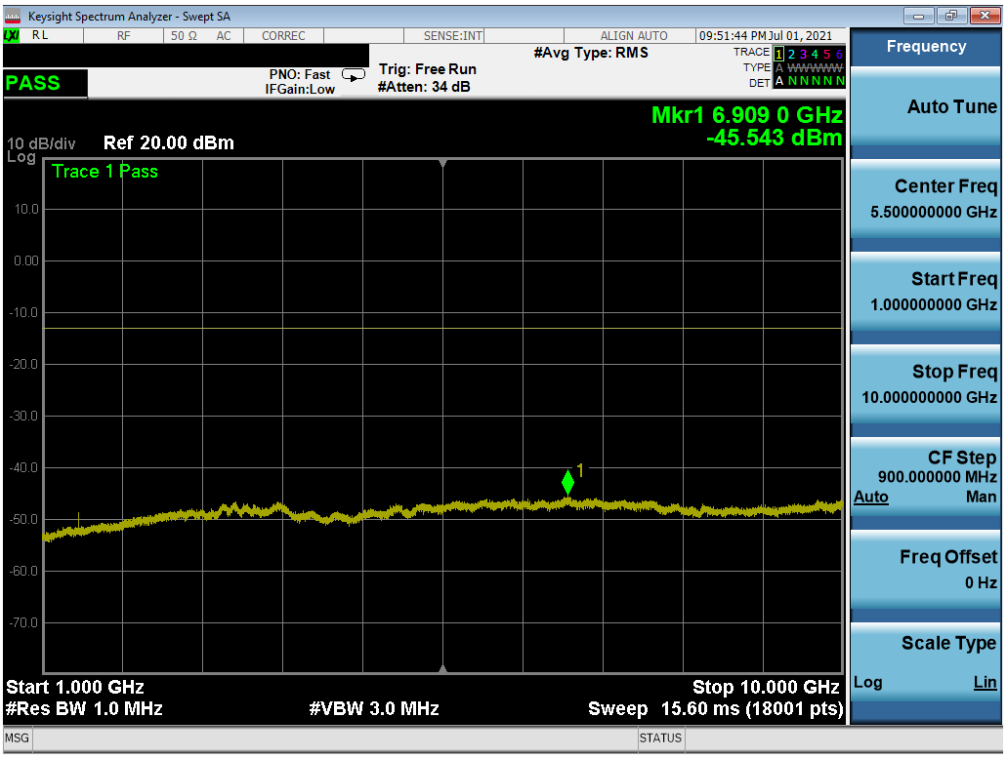
2. For NR operation, all subcarrier spacings (SCS) and transmission schemes (e.g. CP-OFDM and DFT-s-OFDM) were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.



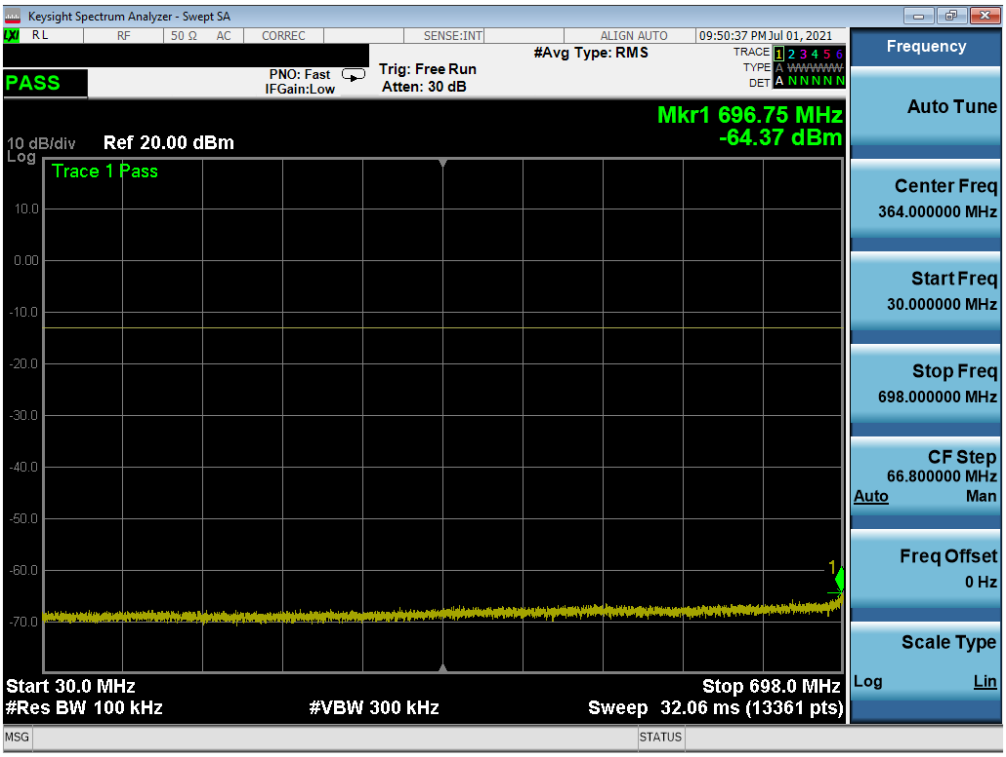
Plot 7-34. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - Low Channel)



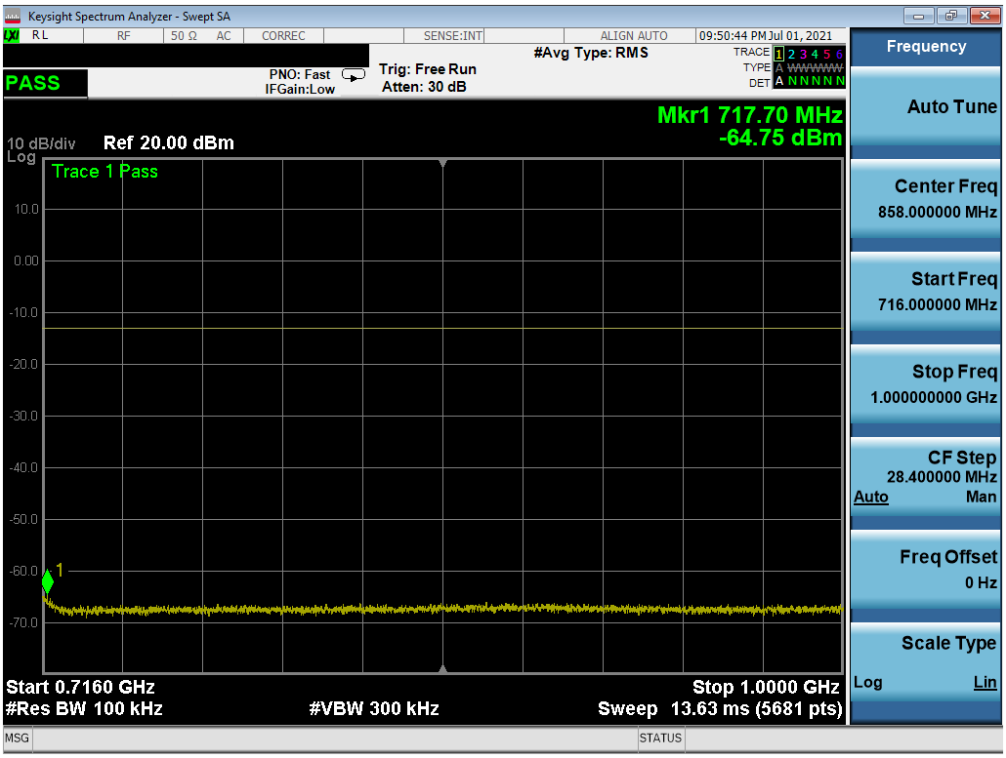
Plot 7-35. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - Low Channel)



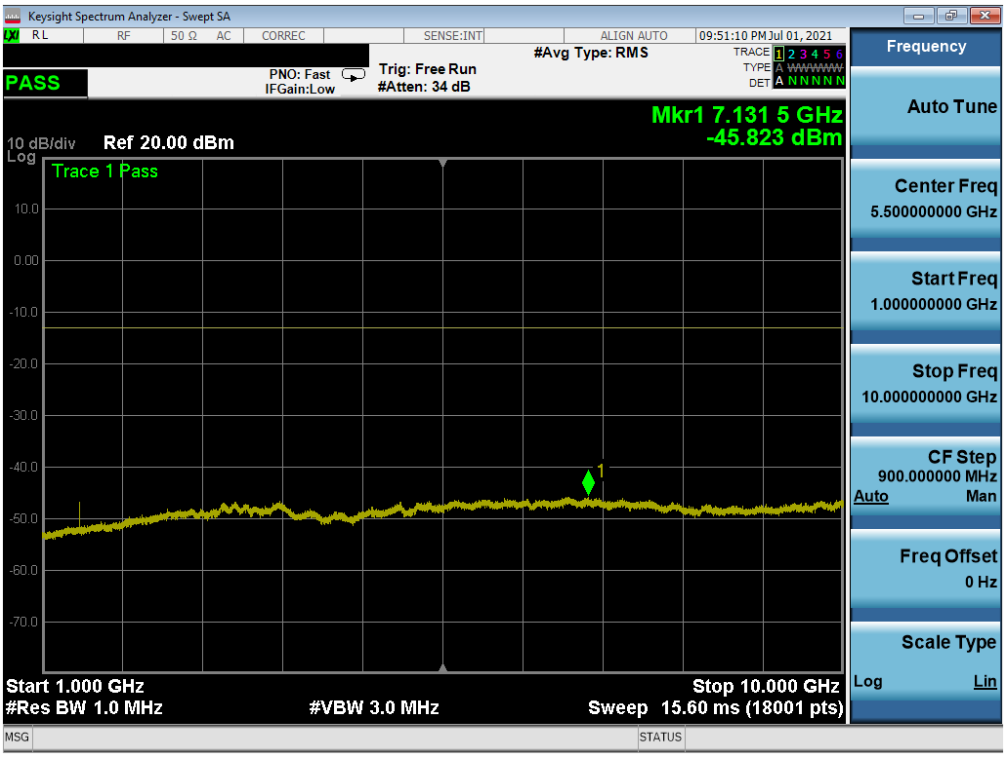
Plot 7-36. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - Low Channel)



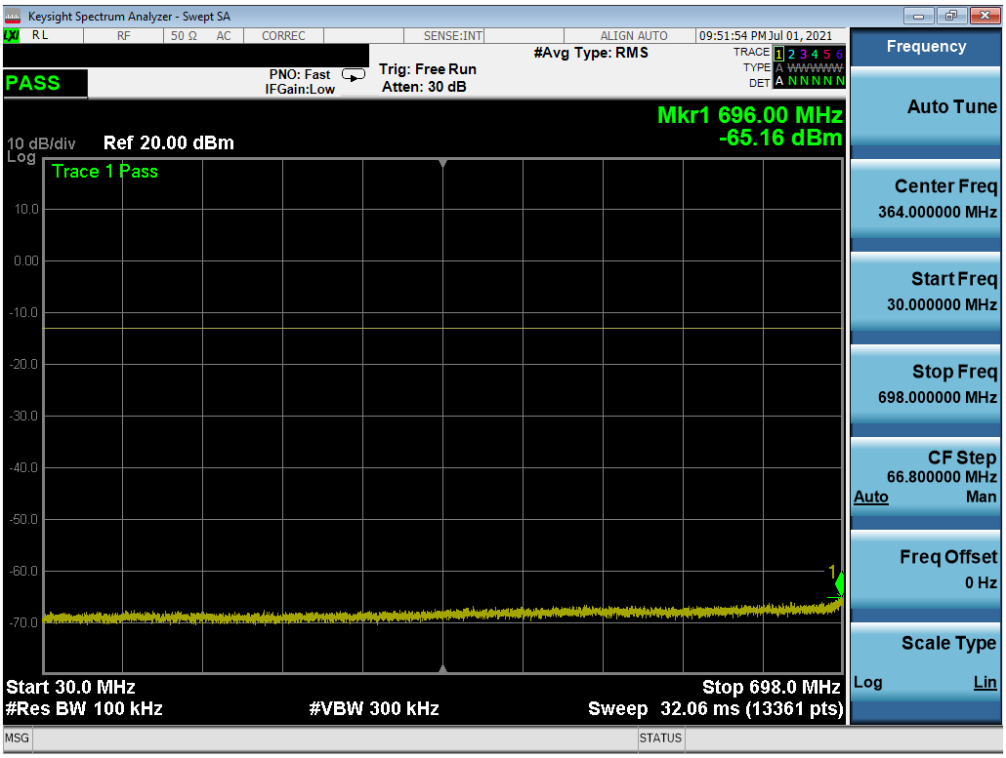
Plot 7-37. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - Mid Channel)



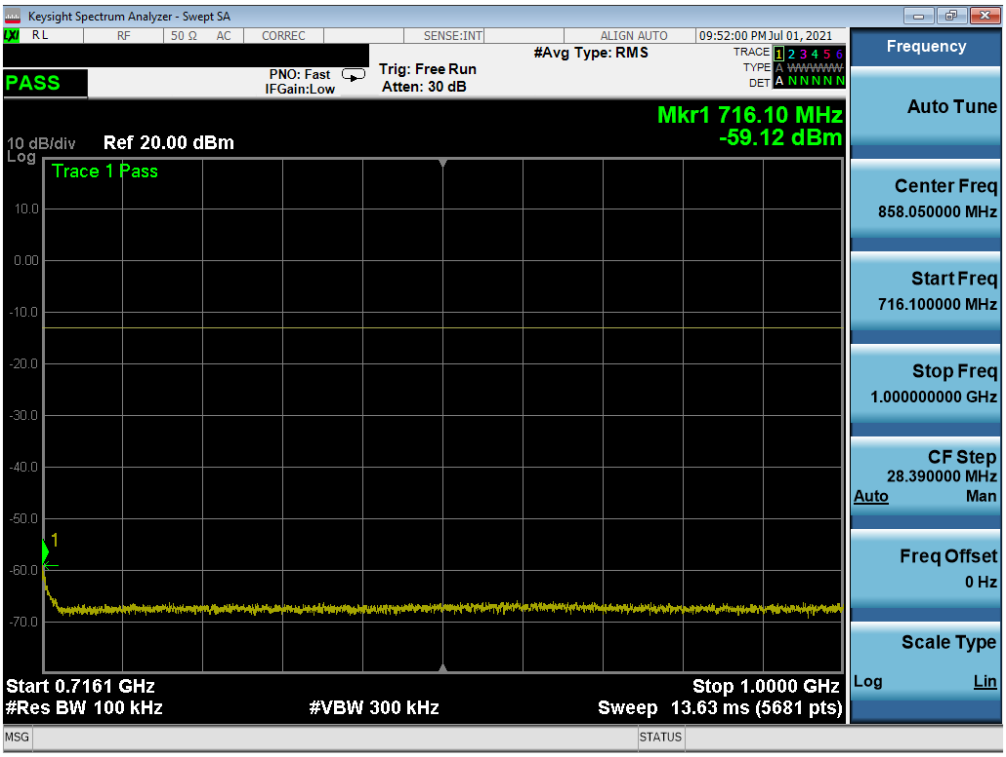
Plot 7-38. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - Mid Channel)



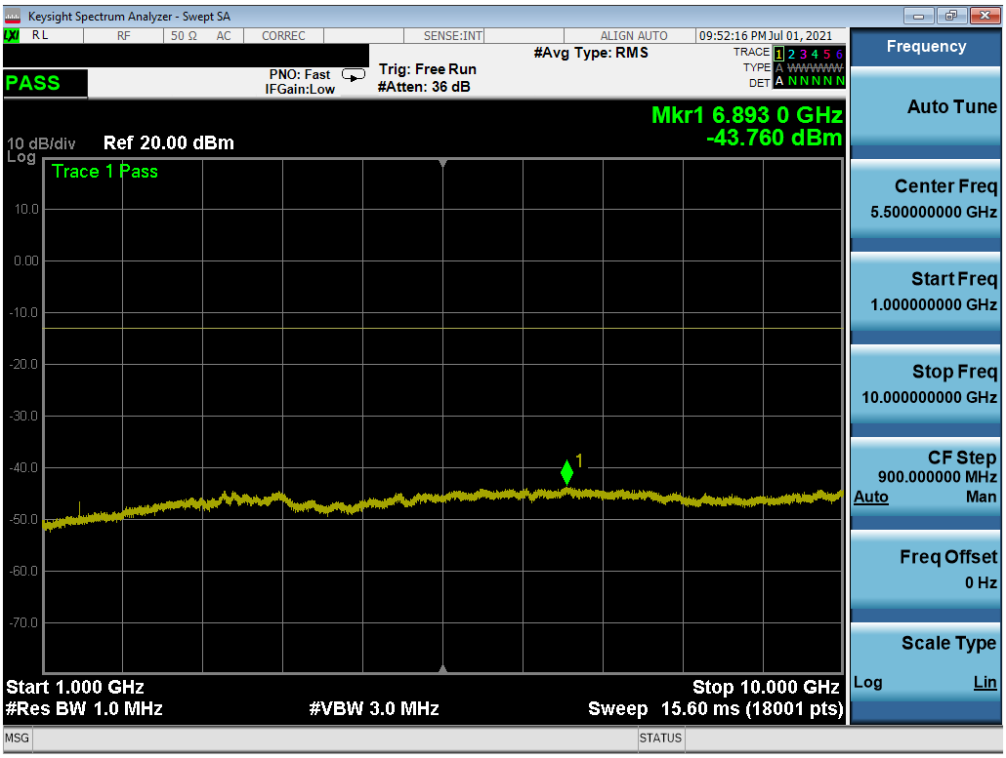
Plot 7-39. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - Mid Channel)



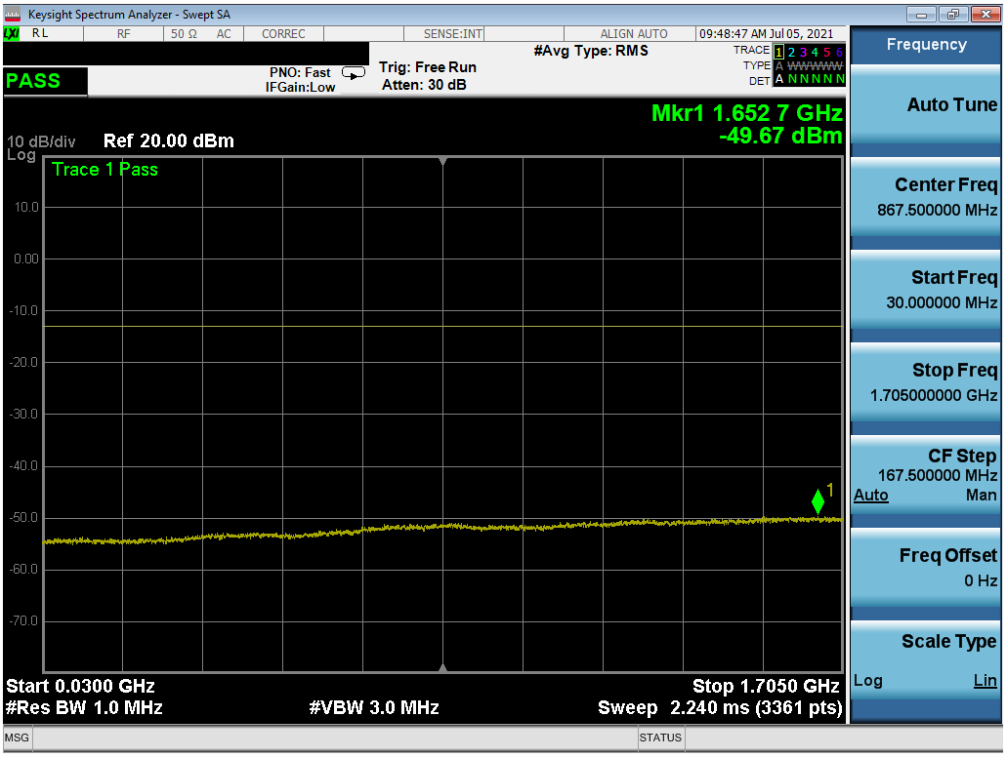
Plot 7-40. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - High Channel)



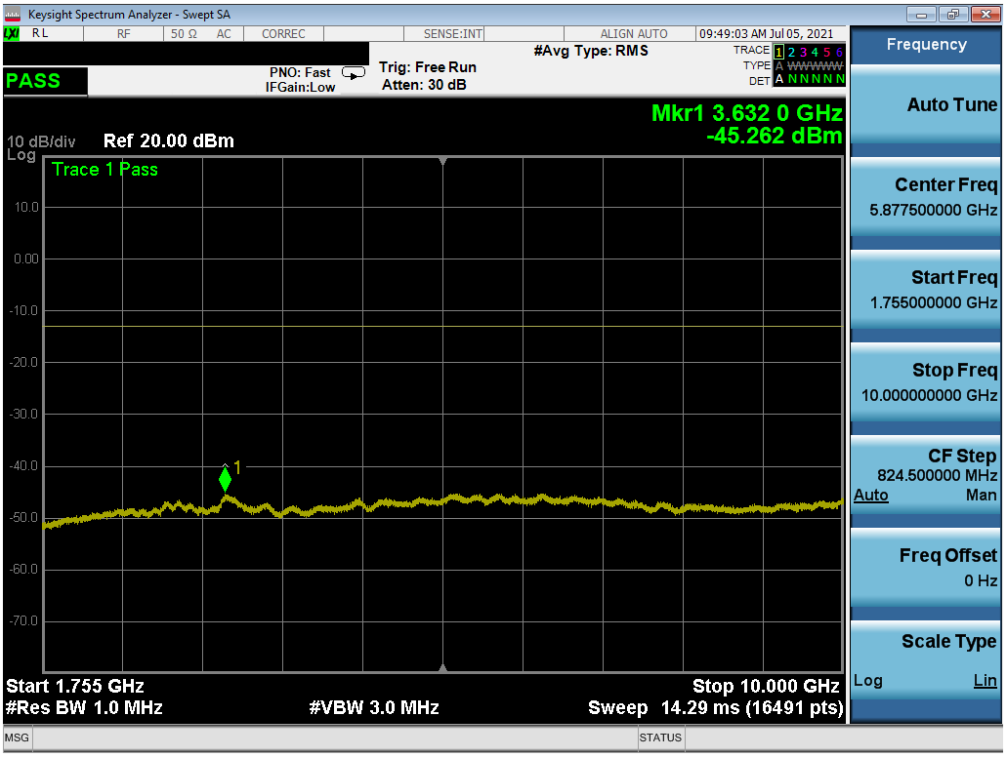
Plot 7-41. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - High Channel)



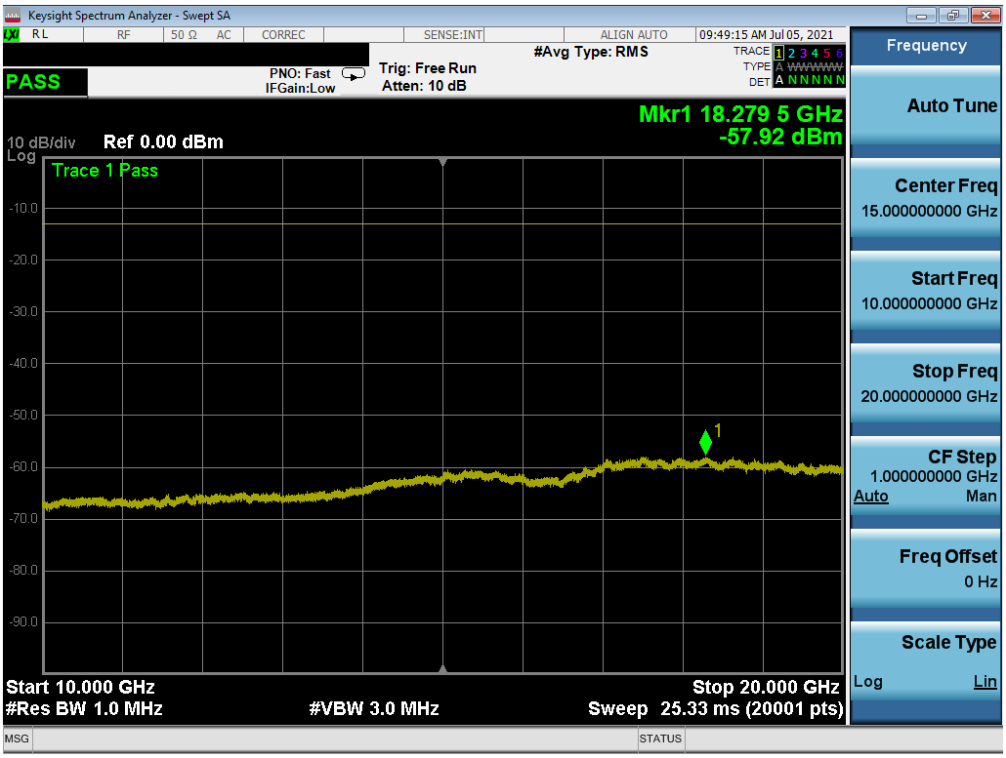
Plot 7-42. Conducted Spurious Plot (LTE Band 12/17 - 10MHz QPSK - 1 RB - High Channel)



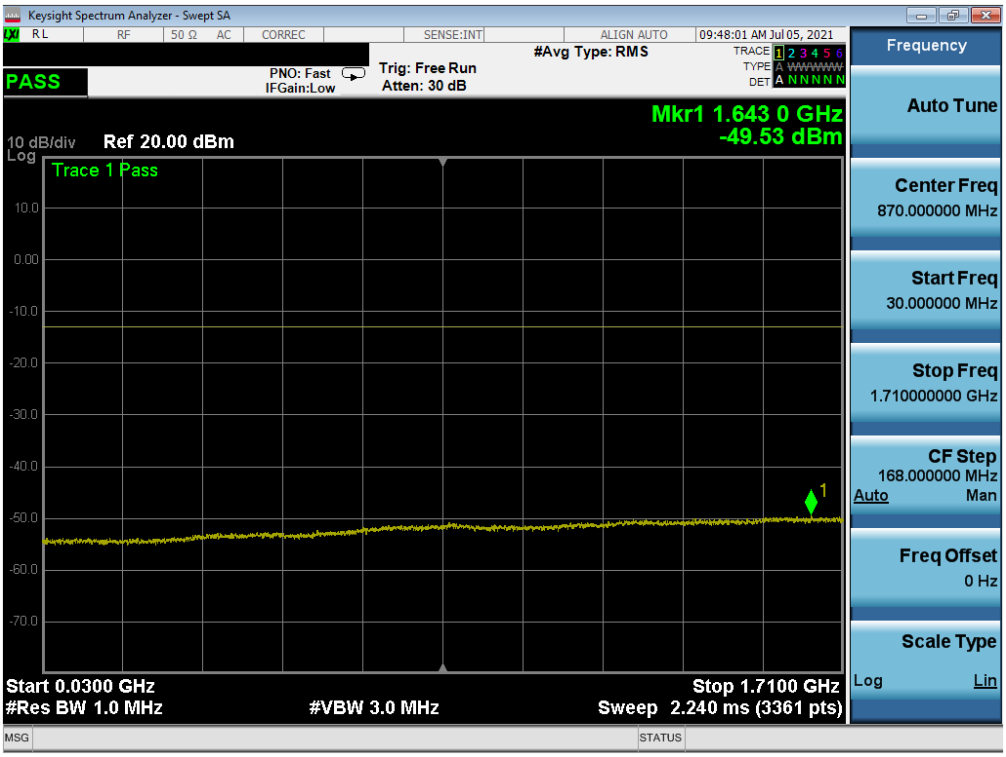
Plot 7-43. Conducted Spurious Plot (WCDMA Ch. 1312- Low Channel)



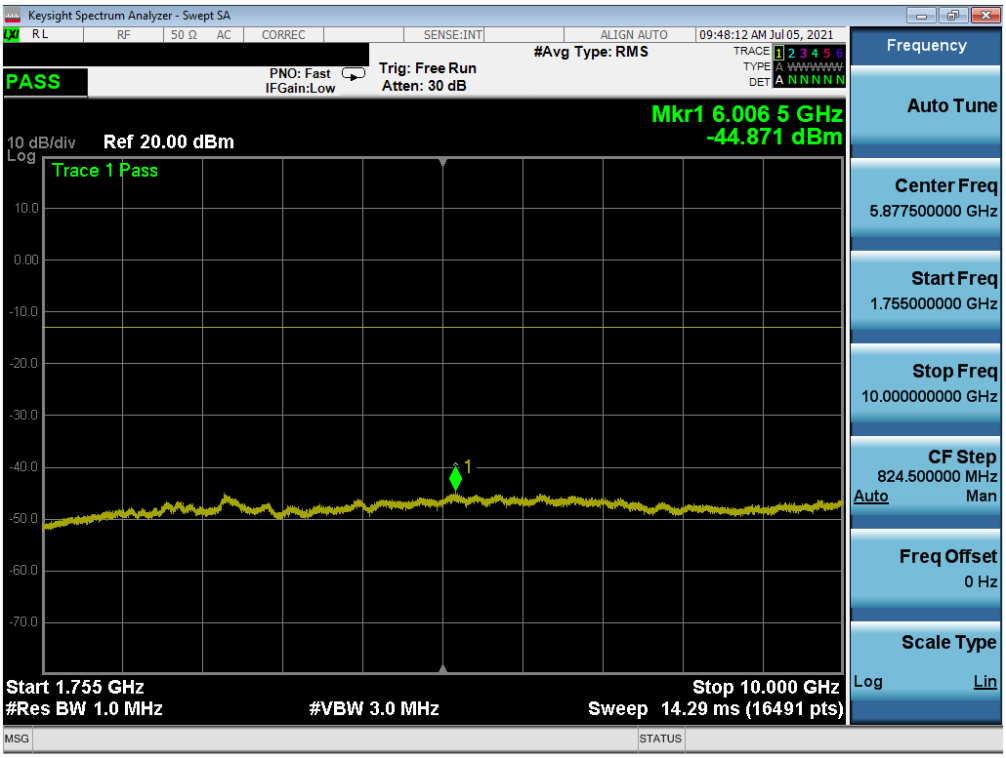
Plot 7-44. Conducted Spurious Plot (WCDMA Ch. 1312- Low Channel)



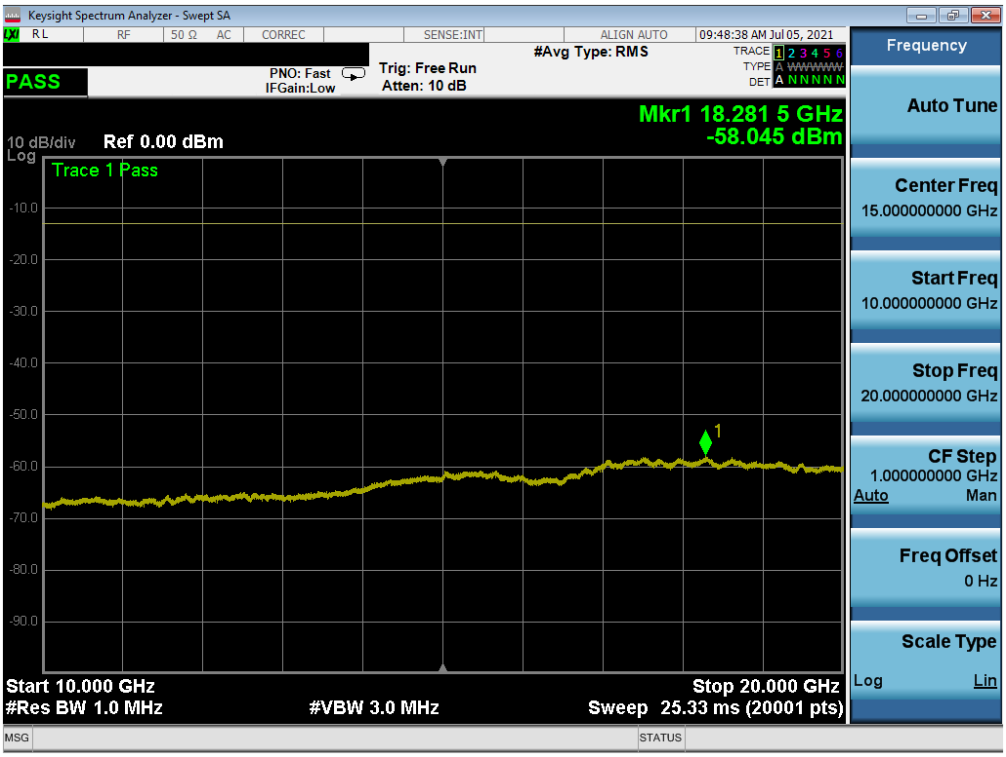
Plot 7-45. Conducted Spurious Plot (WCDMA Ch. 1312- Low Channel)



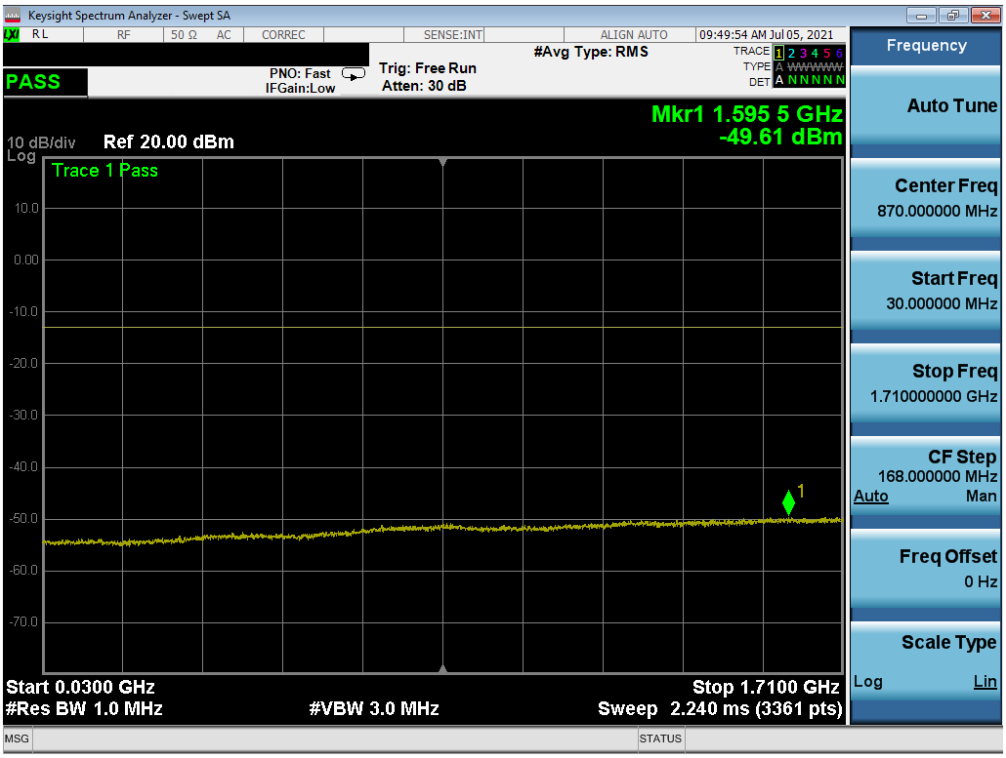
Plot 7-46. Conducted Spurious Plot (WCDMA Ch. 1413- Mid Channel)



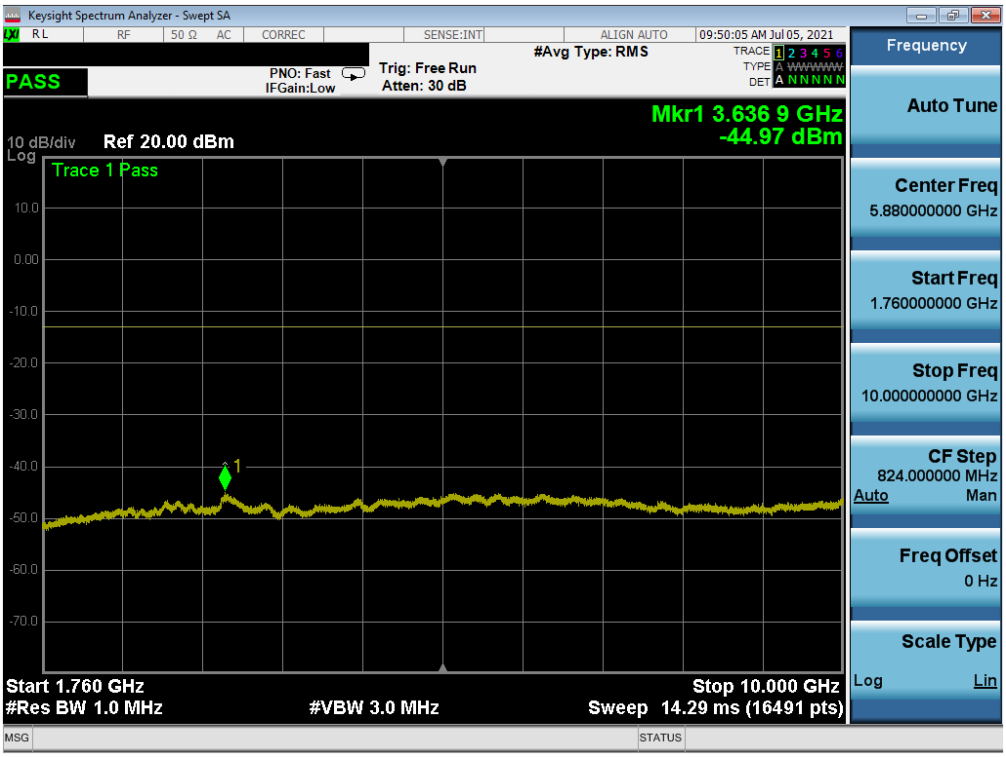
Plot 7-47. Conducted Spurious Plot (WCDMA Ch. 1413- Mid Channel)



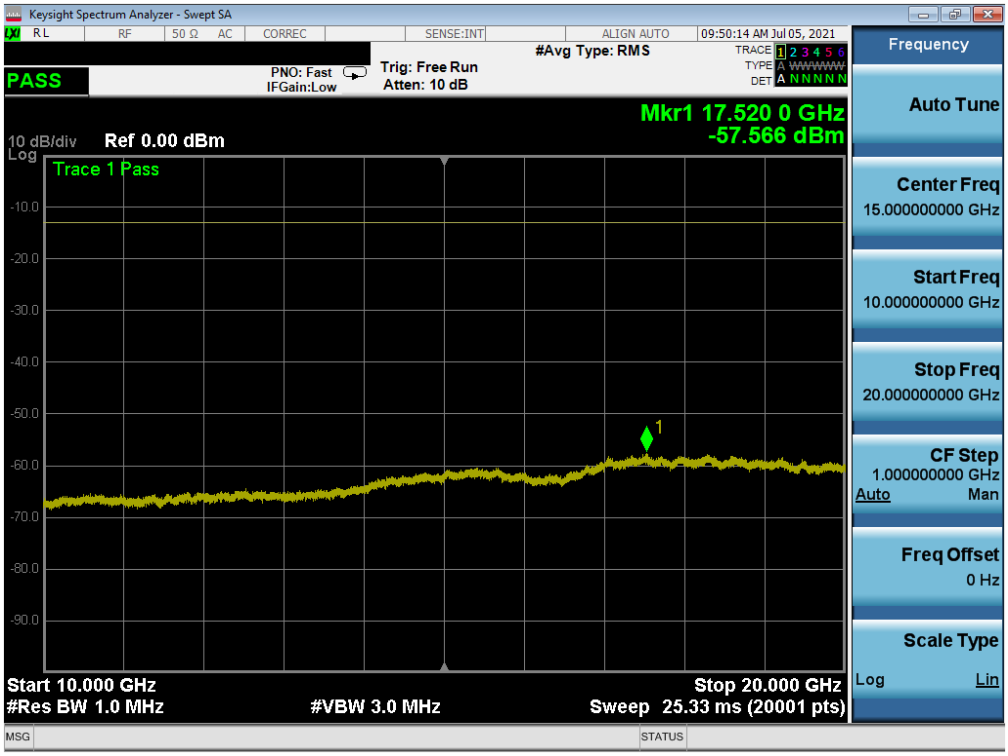
Plot 7-48. Conducted Spurious Plot (WCDMA Ch. 1413- Mid Channel)



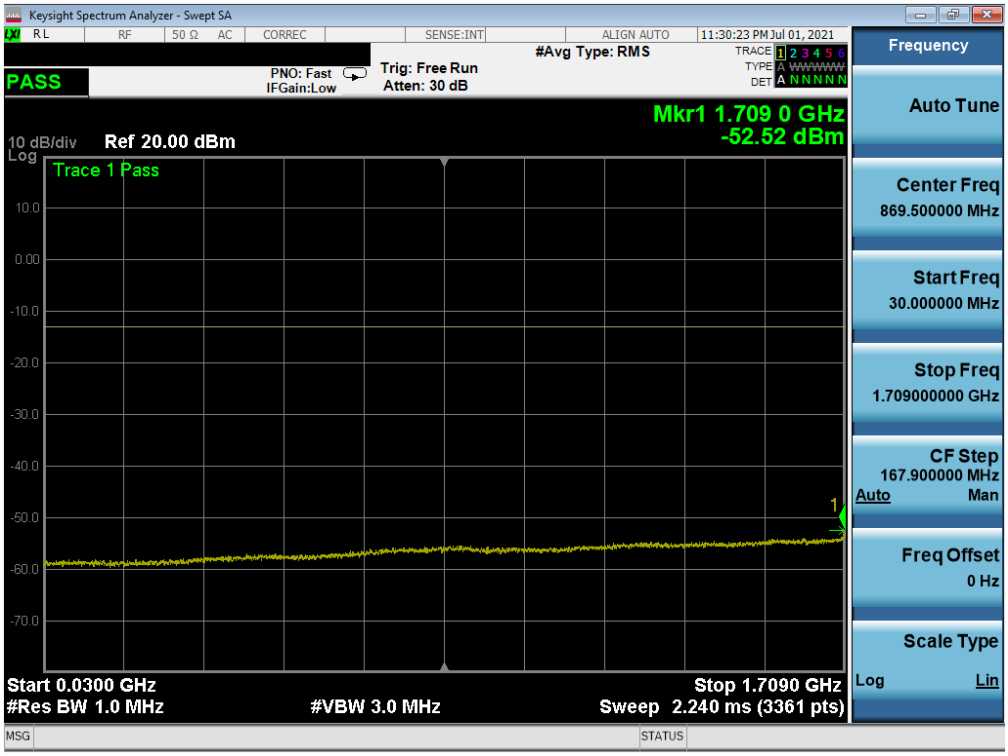
Plot 7-49. Conducted Spurious Plot (WCDMA Ch. 1513- High Channel)



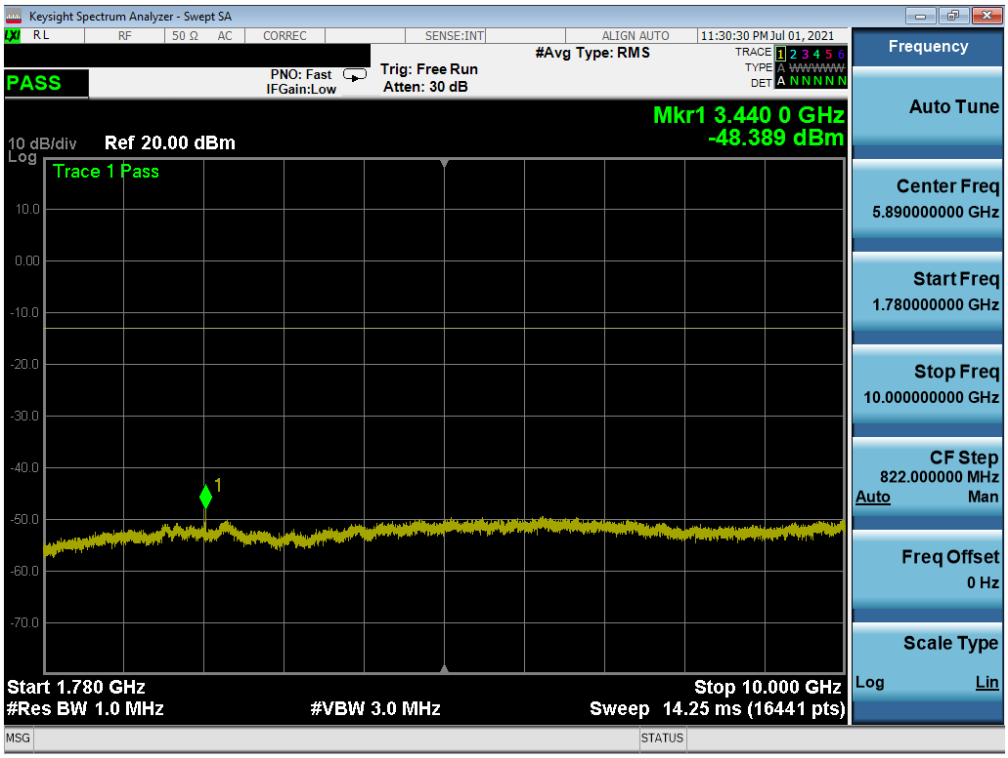
Plot 7-50. Conducted Spurious Plot (WCDMA Ch. 1513- High Channel)



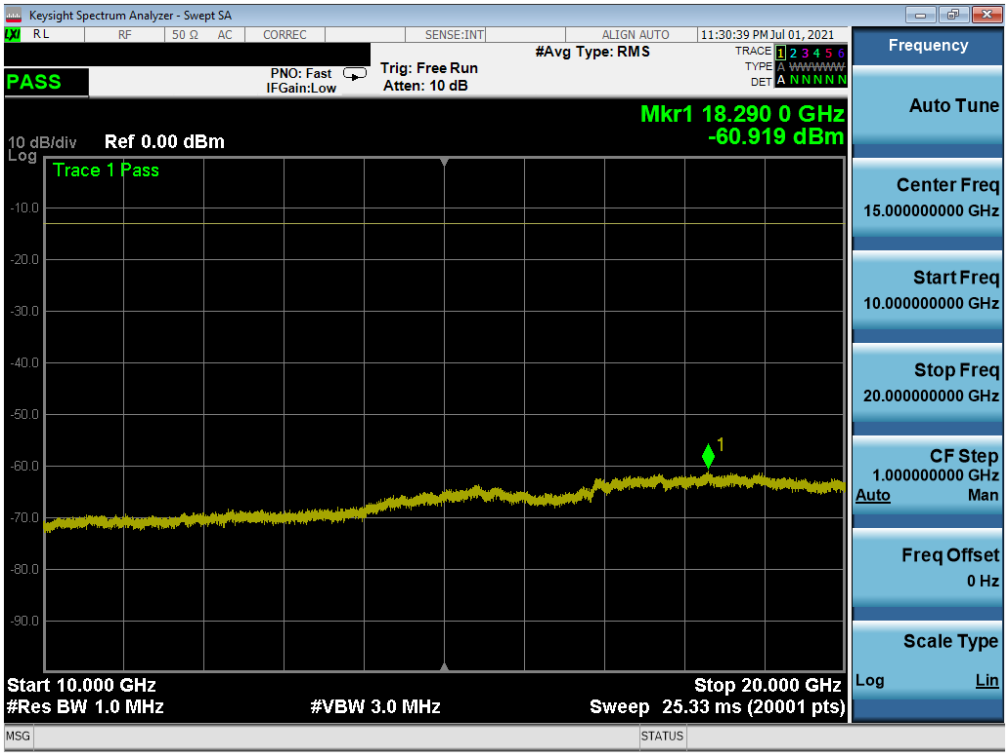
Plot 7-51. Conducted Spurious Plot (WCDMA Ch. 1513- High Channel)



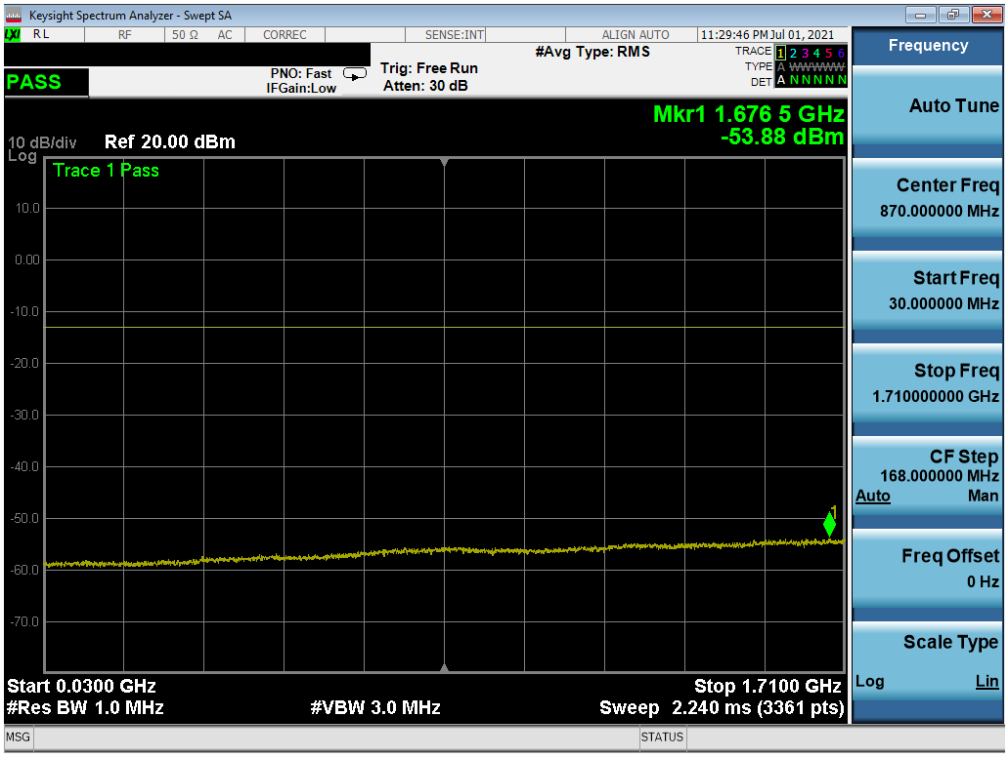
Plot 7-52. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Low Channel)



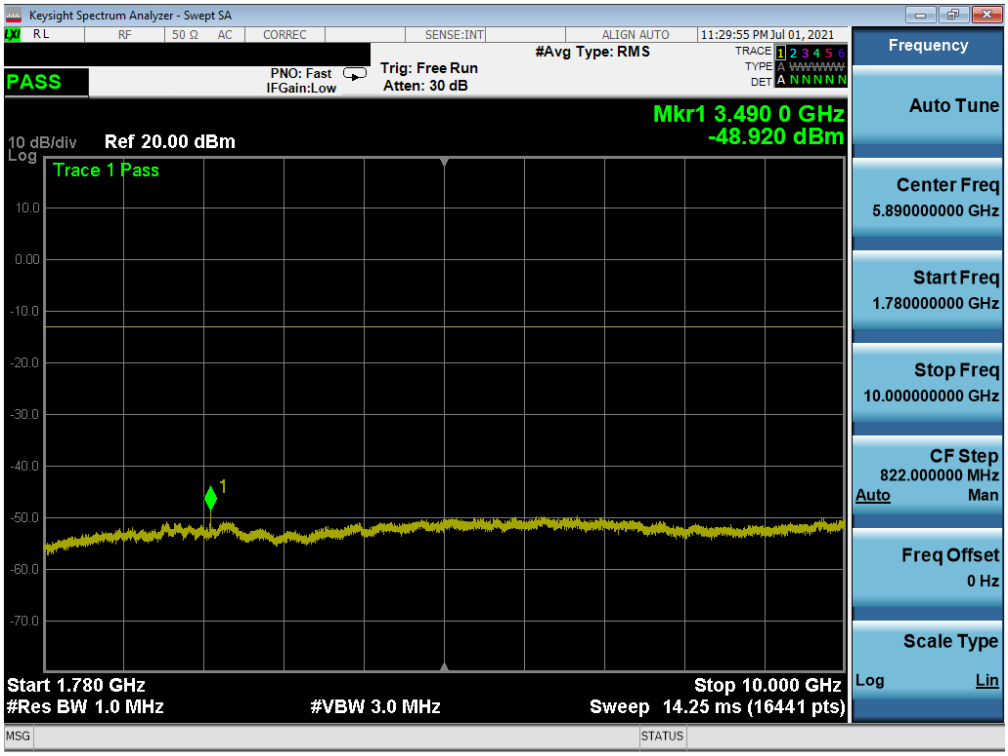
Plot 7-53. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Low Channel)



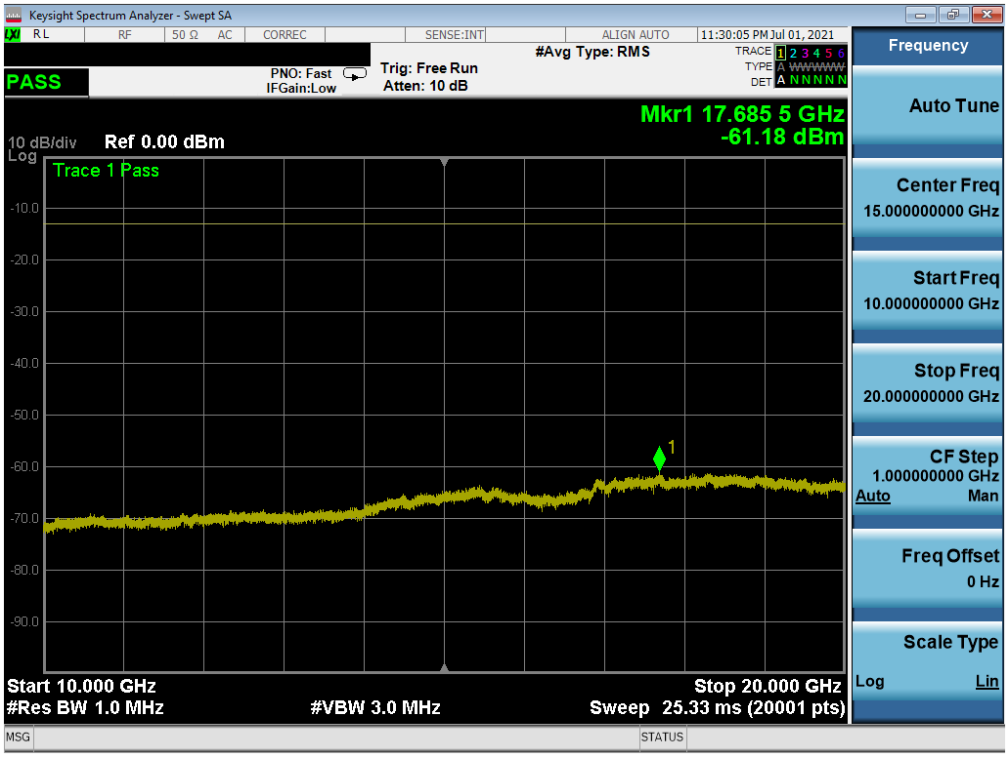
Plot 7-54. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Low Channel)



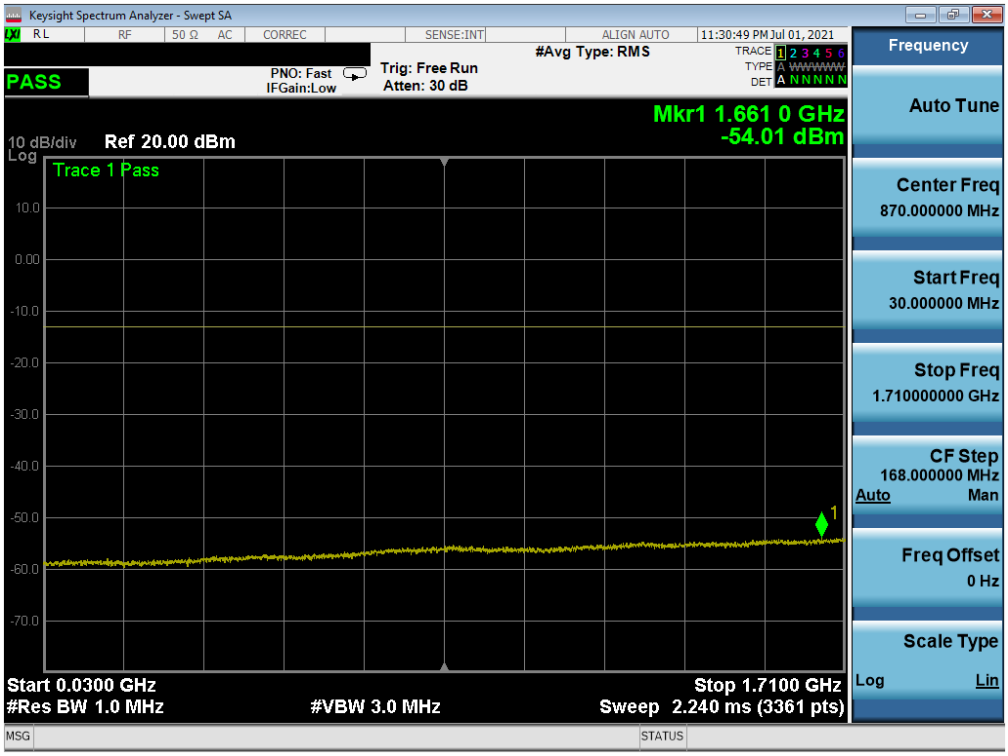
Plot 7-55. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Mid Channel)



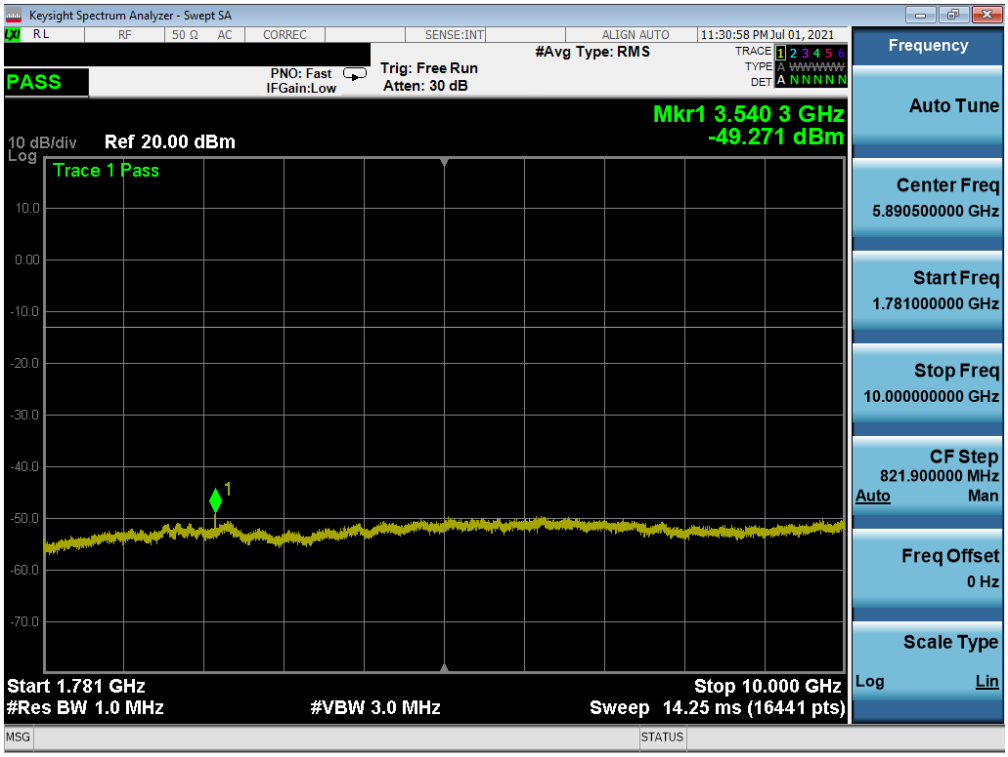
Plot 7-56. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Mid Channel)



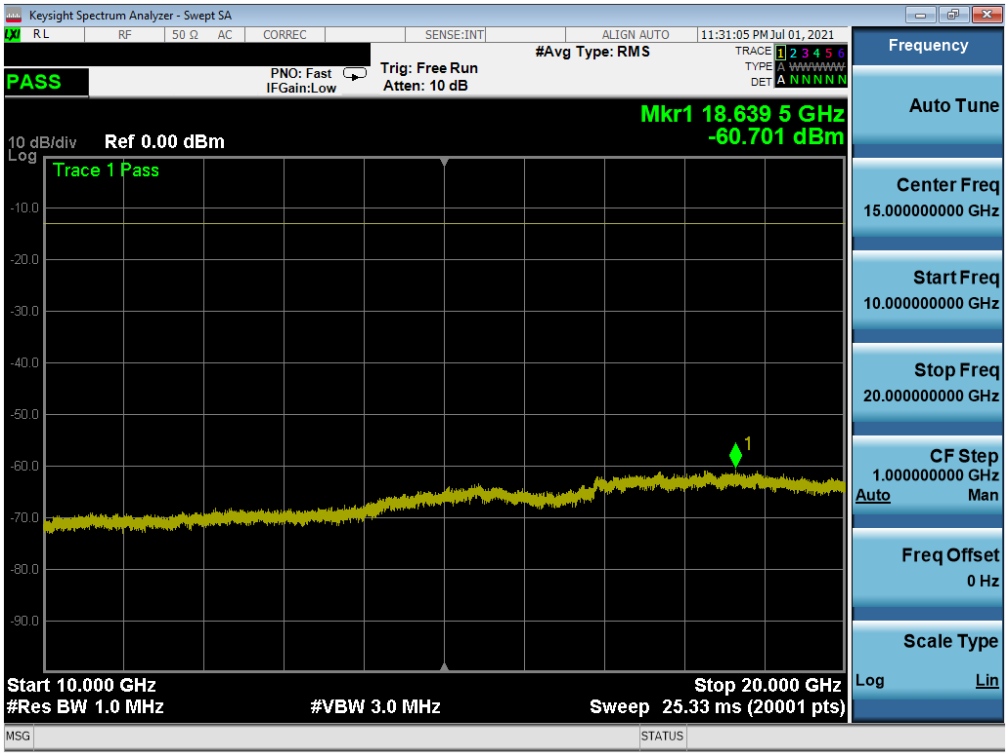
Plot 7-57. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - Mid Channel)



Plot 7-58. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - High Channel)

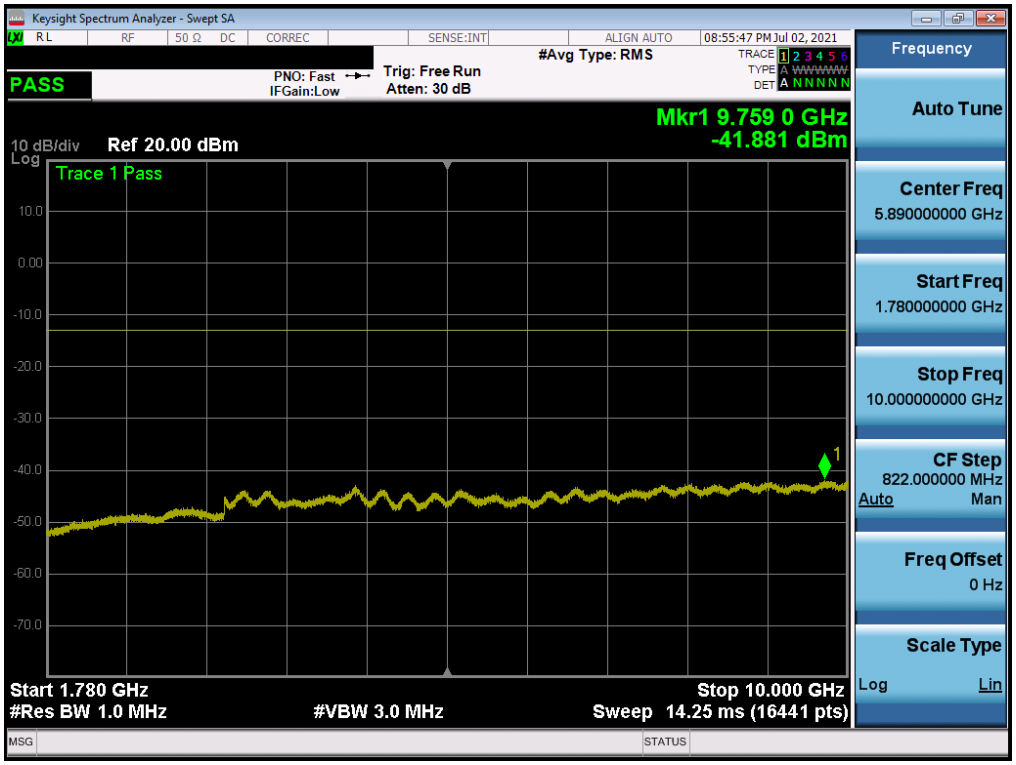


Plot 7-59. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - High Channel)

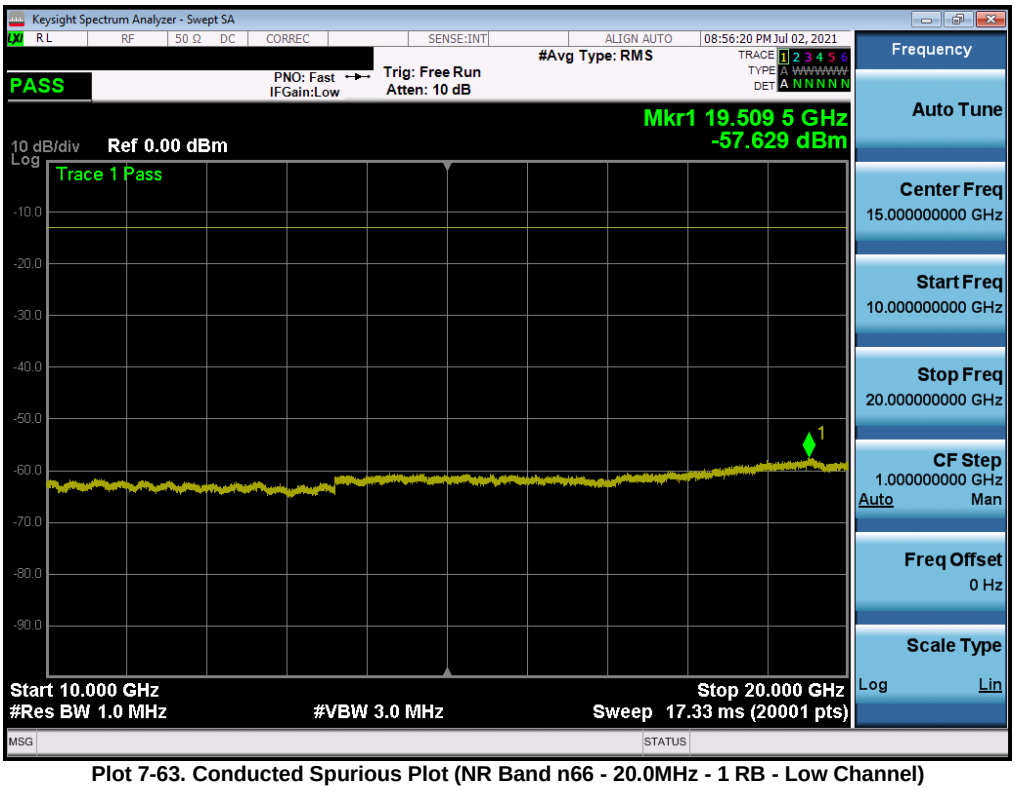


Plot 7-60. Conducted Spurious Plot (LTE Band 66/4 - 20MHz QPSK - 1 RB - High Channel)

Plot 7-61. Conducted Spurious Plot (NR Band n66 - 20.0MHz - 1 RB - Low Channel)

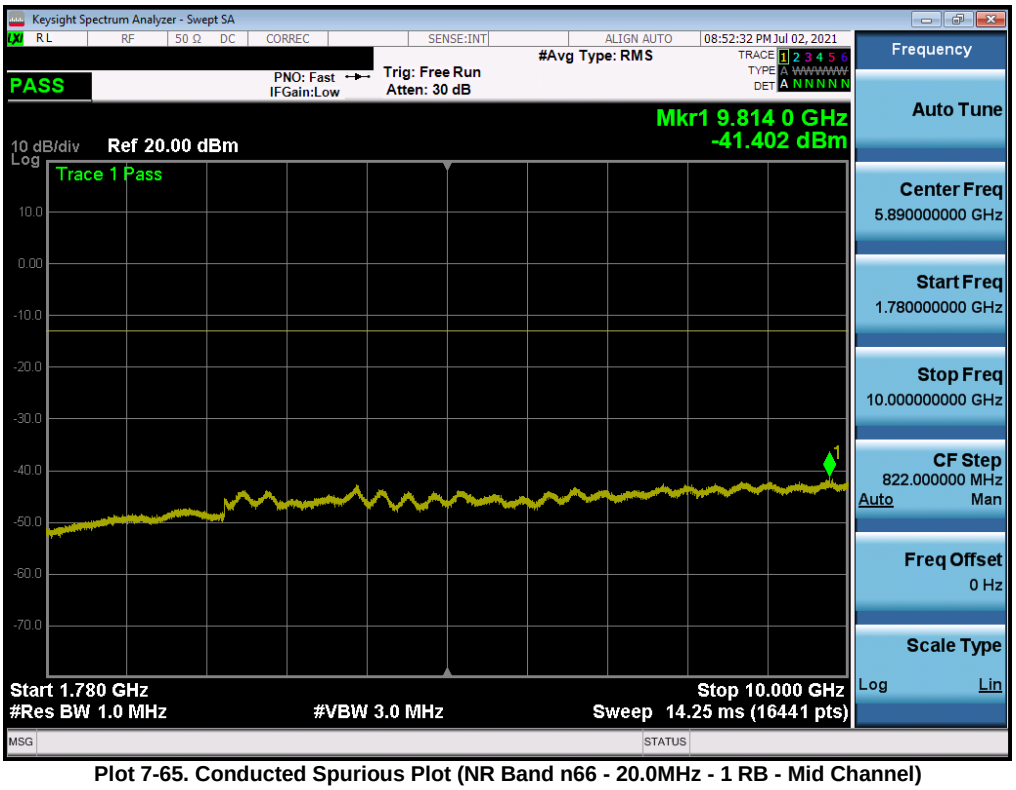


Plot 7-62. Conducted Spurious Plot (NR Band n66 - 20.0MHz - 1 RB - Low Channel)

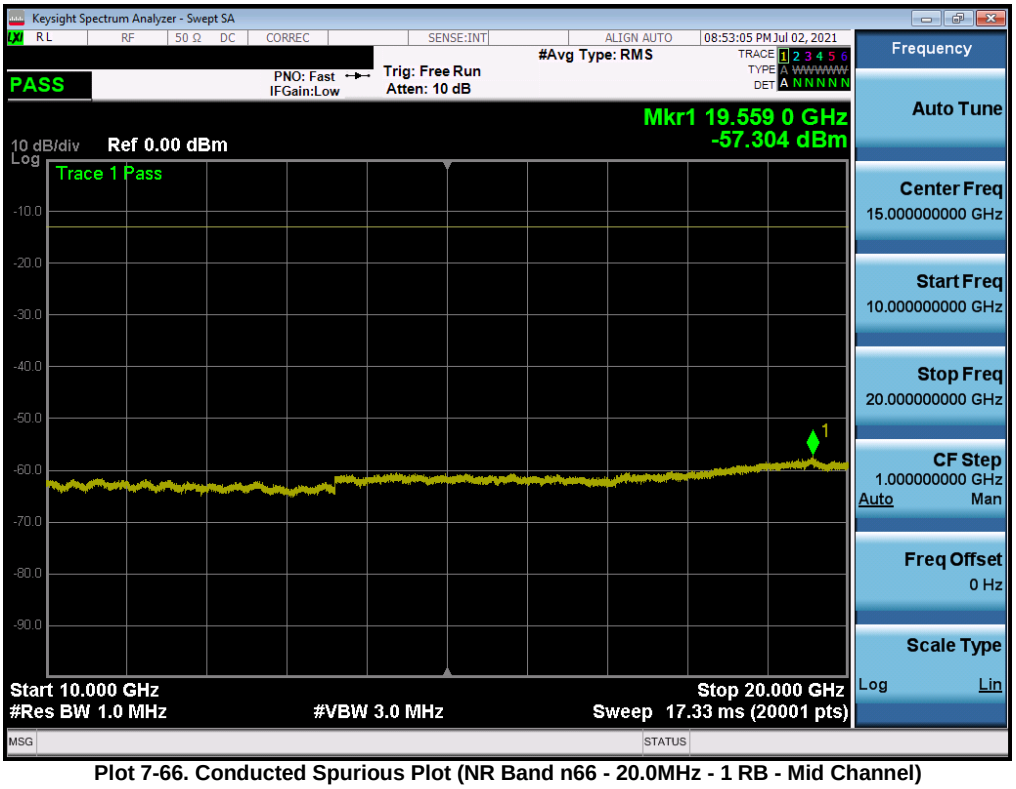


Plot 7-63. Conducted Spurious Plot (NR Band n66 - 20.0MHz - 1 RB - Low Channel)

Plot 7-64. Conducted Spurious Plot (NR Band n66 -20.0MHz - 1 RB - Mid Channel)

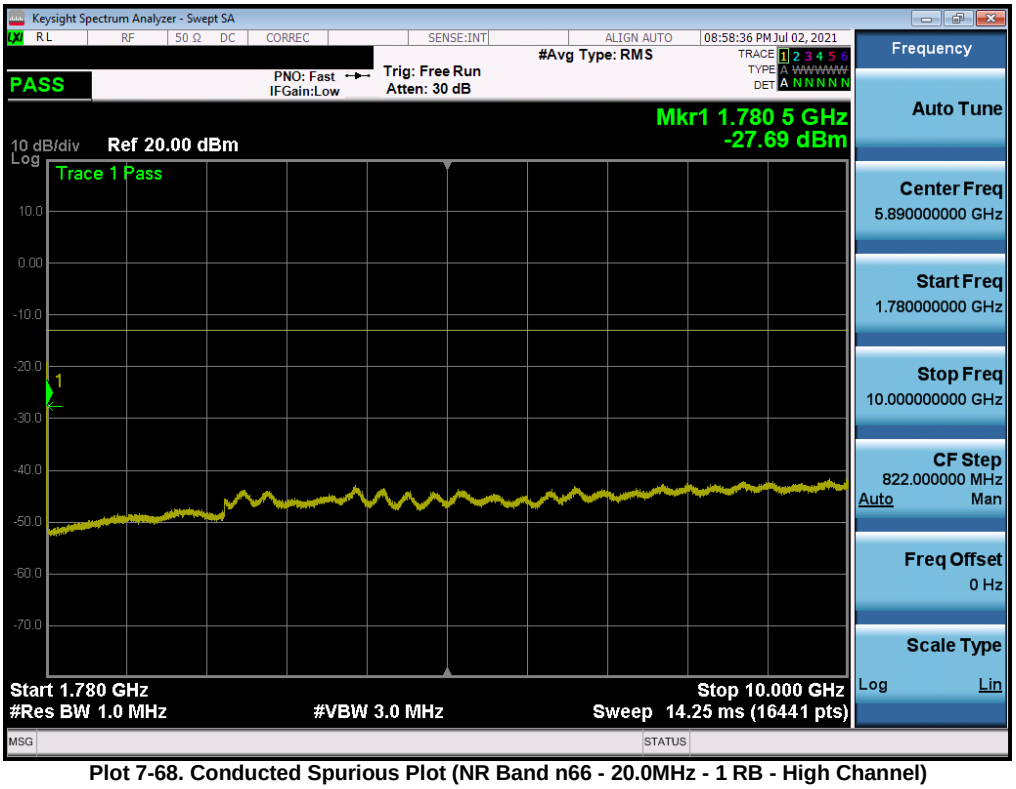


Plot 7-65. Conducted Spurious Plot (NR Band n66 - 20.0MHz - 1 RB - Mid Channel)

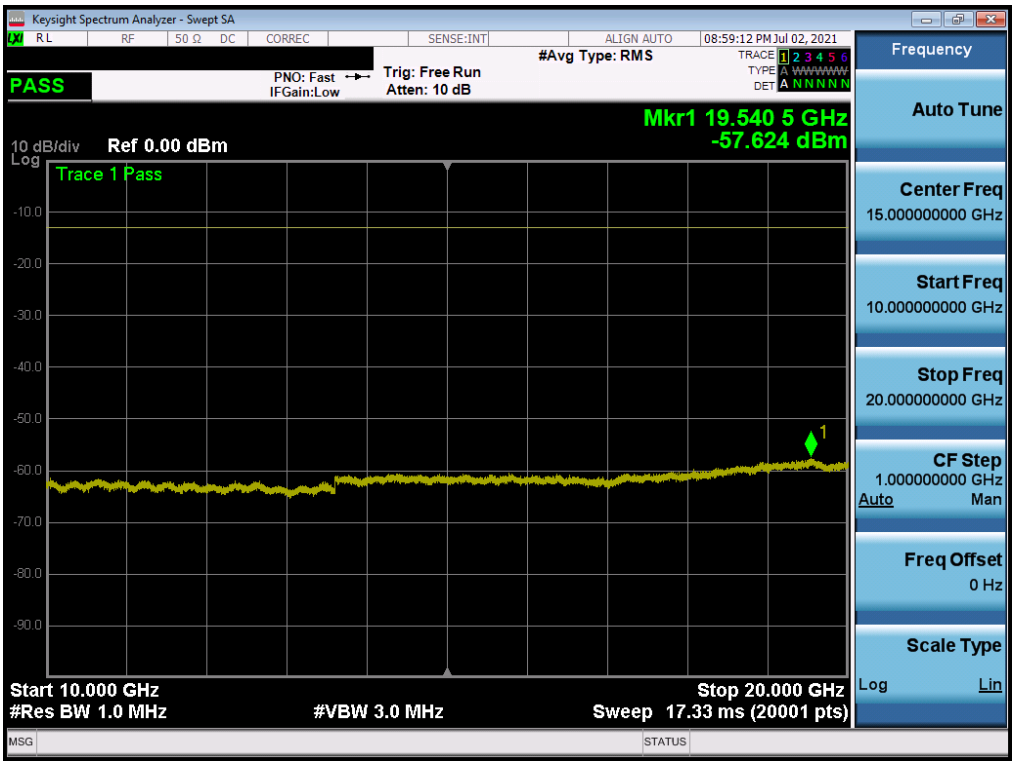


Plot 7-66. Conducted Spurious Plot (NR Band n66 - 20.0MHz - 1 RB - Mid Channel)

Plot 7-67. Conducted Spurious Plot (NR Band n66 - 20.0MHz - 1 RB - High Channel)



Plot 7-68. Conducted Spurious Plot (NR Band n66 - 20.0MHz - 1 RB - High Channel)



Plot 7-69. Conducted Spurious Plot (NR Band n66 - 20.0MHz - 1 RB - High Channel)

7.4 Band Edge Emissions at Antenna Terminal

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is 43 + 10 $log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 6.0

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW ≥ 1% of the emission bandwidth
4. VBW ≥ 3 x RBW
5. Detector = RMS
6. Number of sweep points ≥ 2 x Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

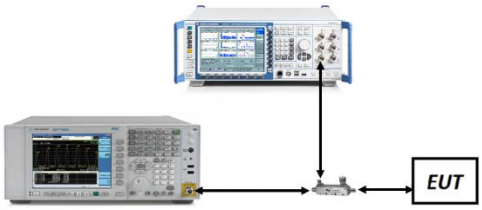
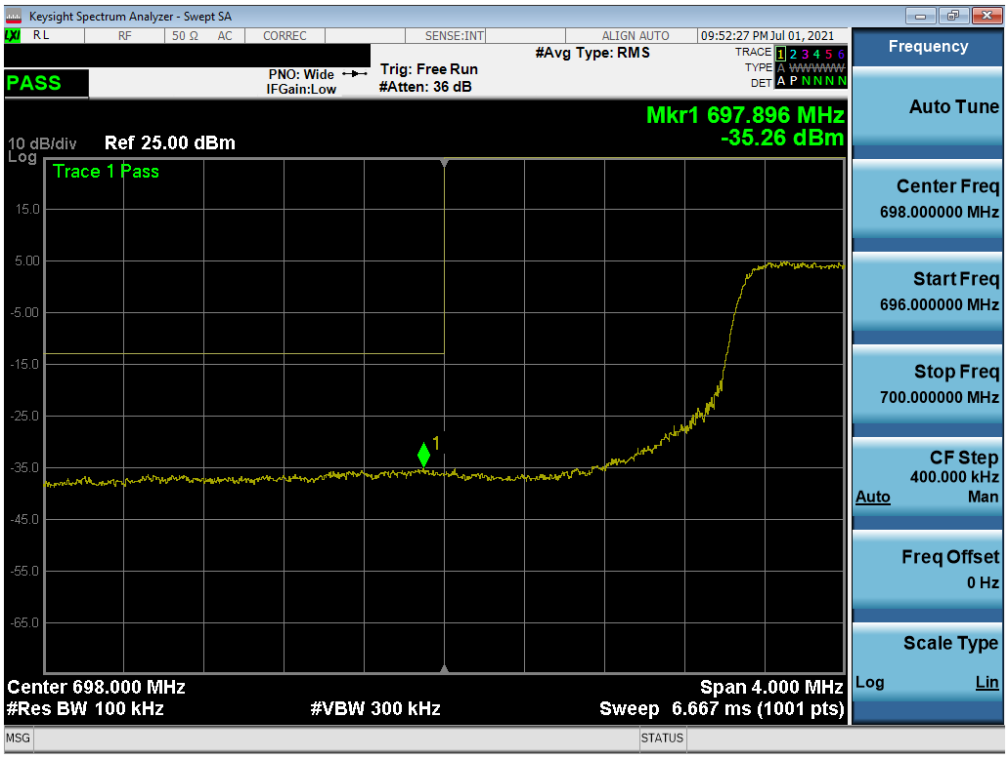


Figure 7-3. Test Instrument & Measurement Setup

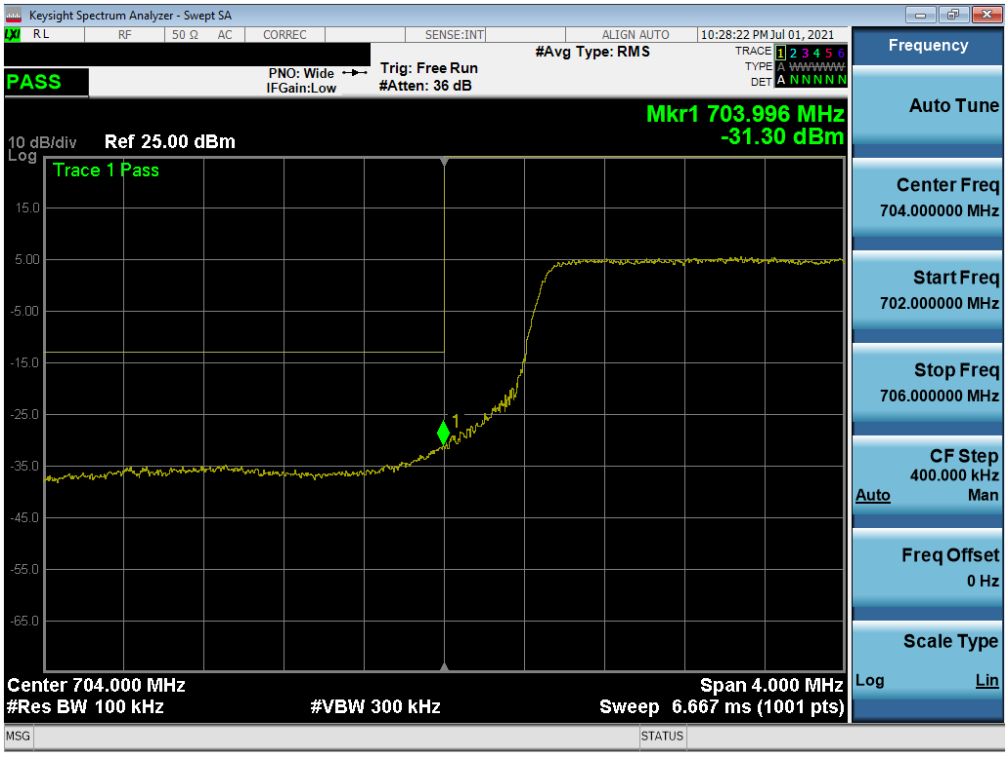
Test Notes

Per 27.53(h) in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

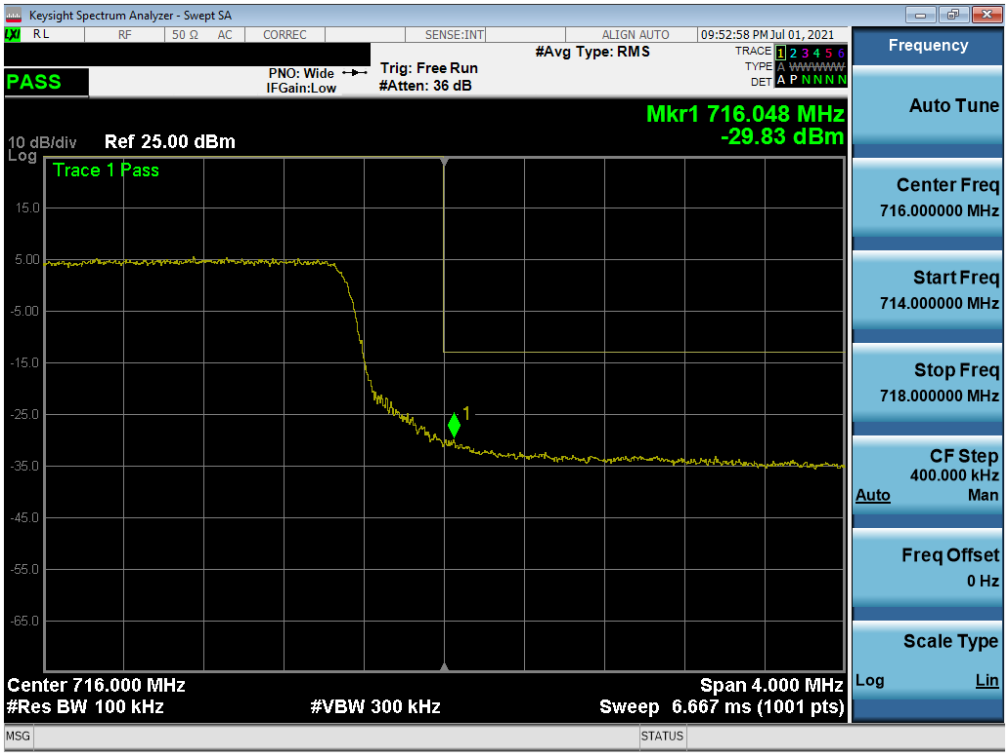
Per 27.53(g) for operations in the 663 - 698 MHz and 698 – 746MHz bands, in the 100 kHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least 30 kHz may be employed to demonstrate compliance with the out-of-band emissions limit.



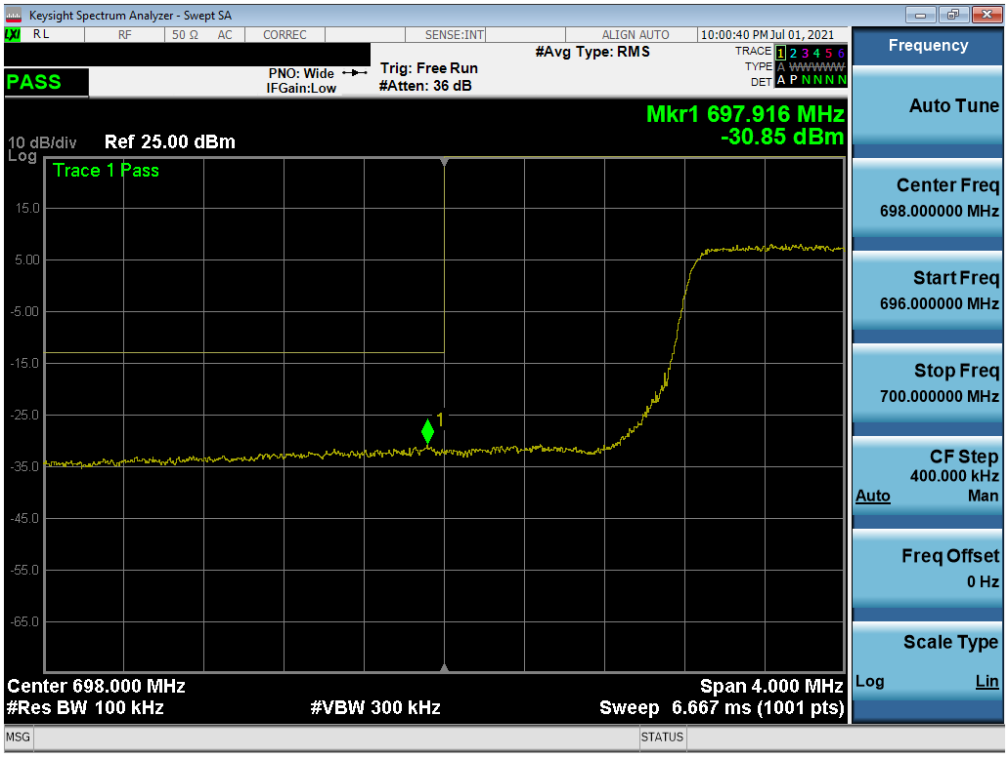
Plot 7-70. Lower Band Edge Plot (LTE Band 12 - 10MHz QPSK – Full RB)



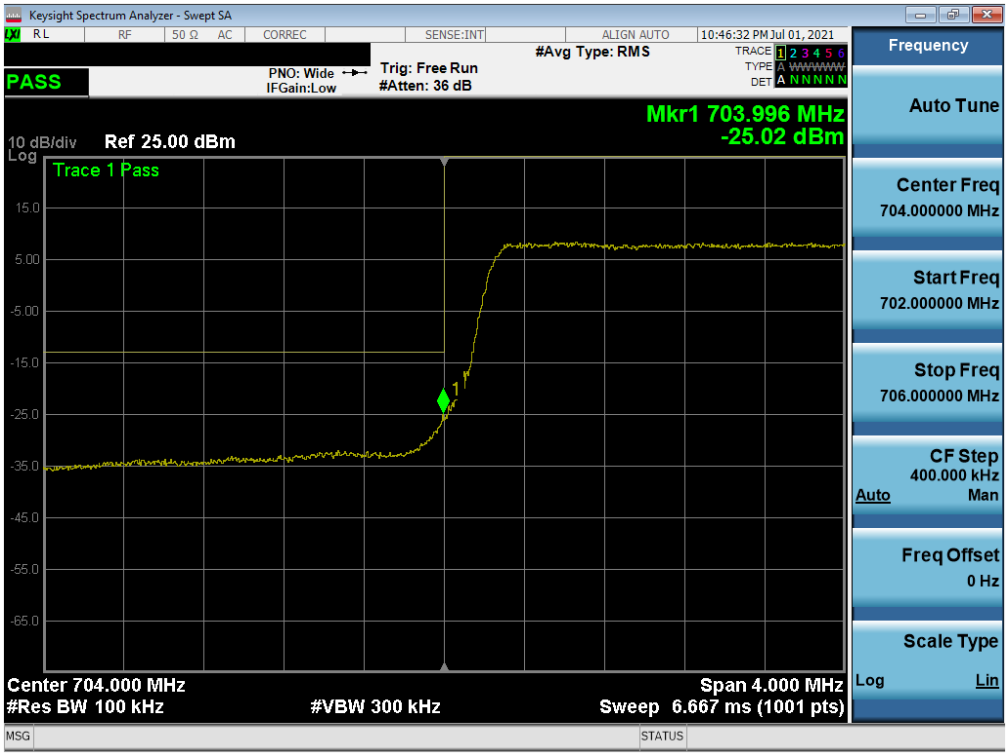
Plot 7-71. Lower Band Edge Plot (LTE Band 17 - 10MHz QPSK – Full RB)



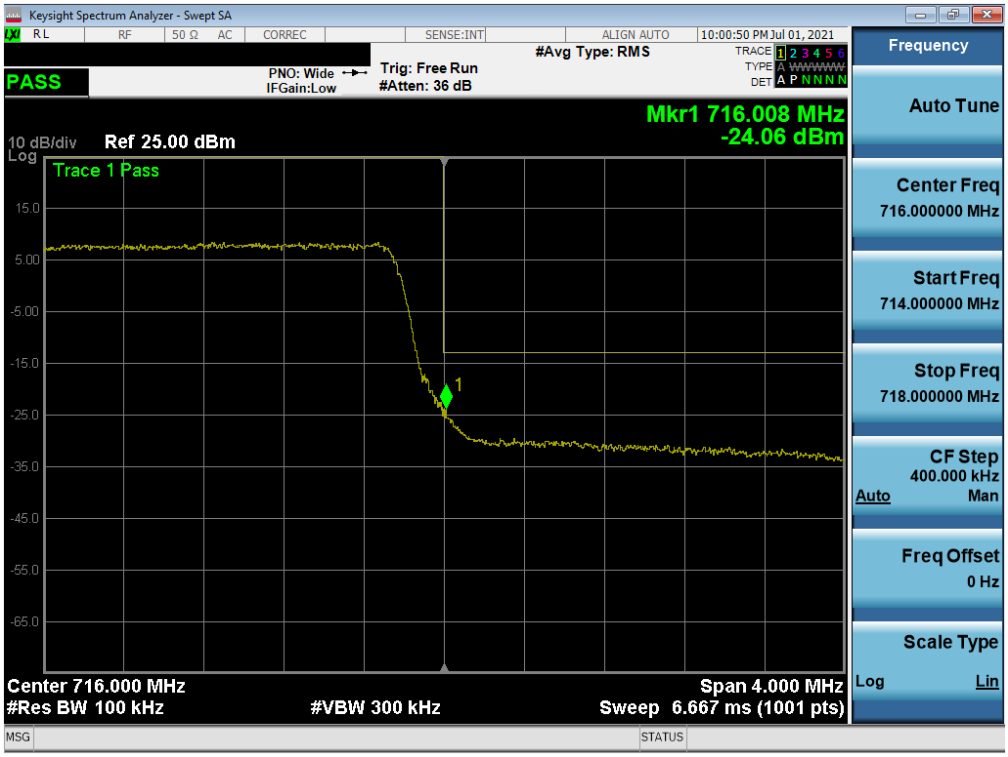
Plot 7-72. Upper Band Edge Plot (LTE Band 12/17 - 10MHz QPSK – Full RB)



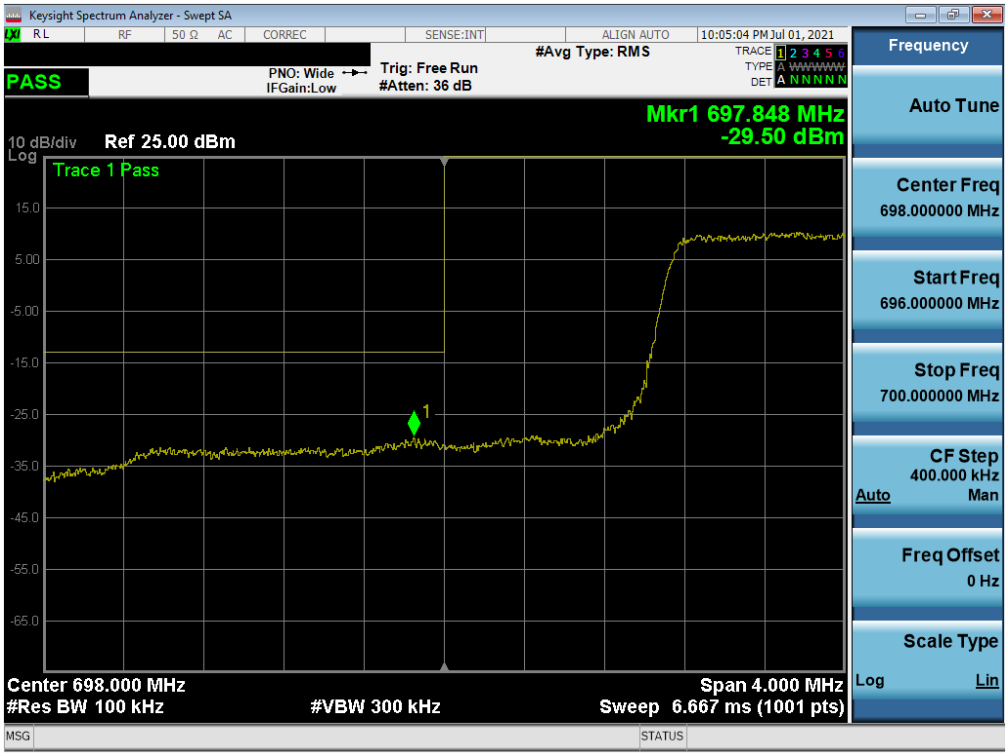
Plot 7-73. Upper Band Edge Plot (LTE Band 12 - 5MHz QPSK – Full RB)



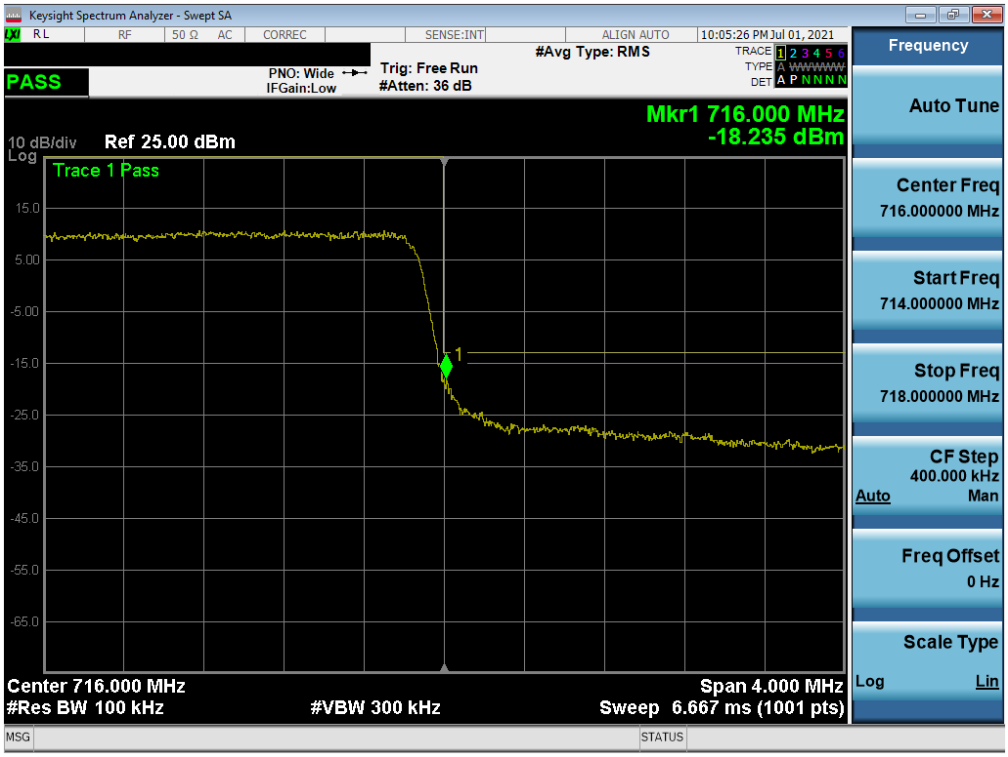
Plot 7-74. Lower Band Edge Plot (LTE Band 17 - 5MHz QPSK – Full RB)



Plot 7-75. Upper Band Edge Plot (LTE Band 12/17 - 5MHz QPSK – Full RB)

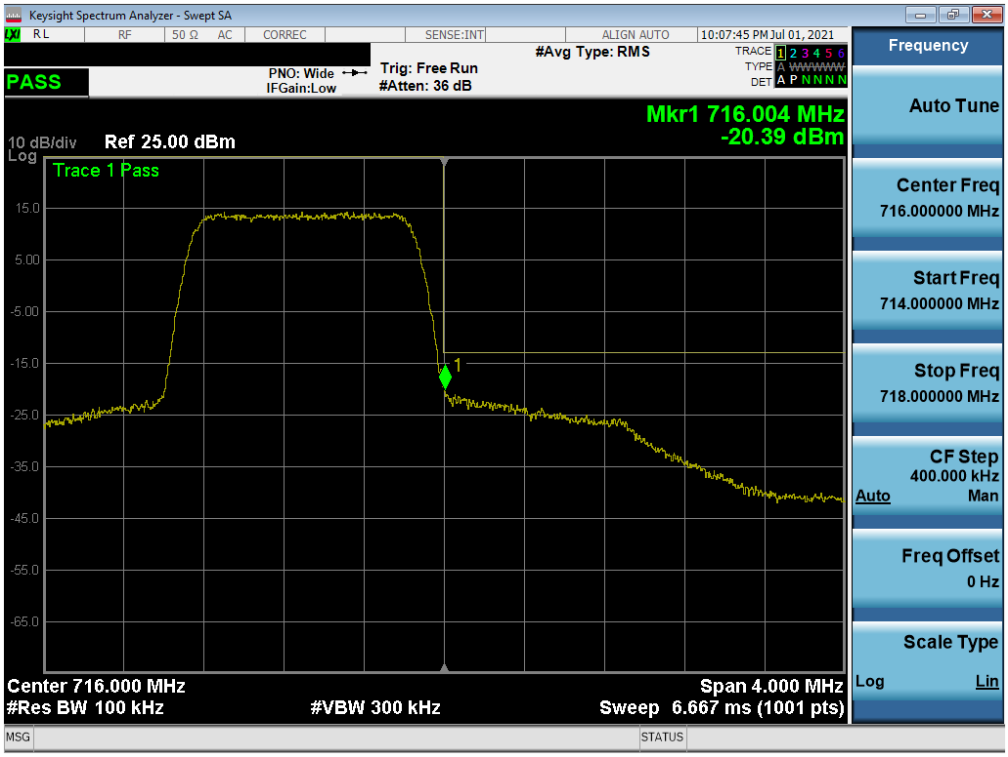


Plot 7-76. Lower Band Edge Plot (LTE Band 12 - 3MHz QPSK – Full RB)

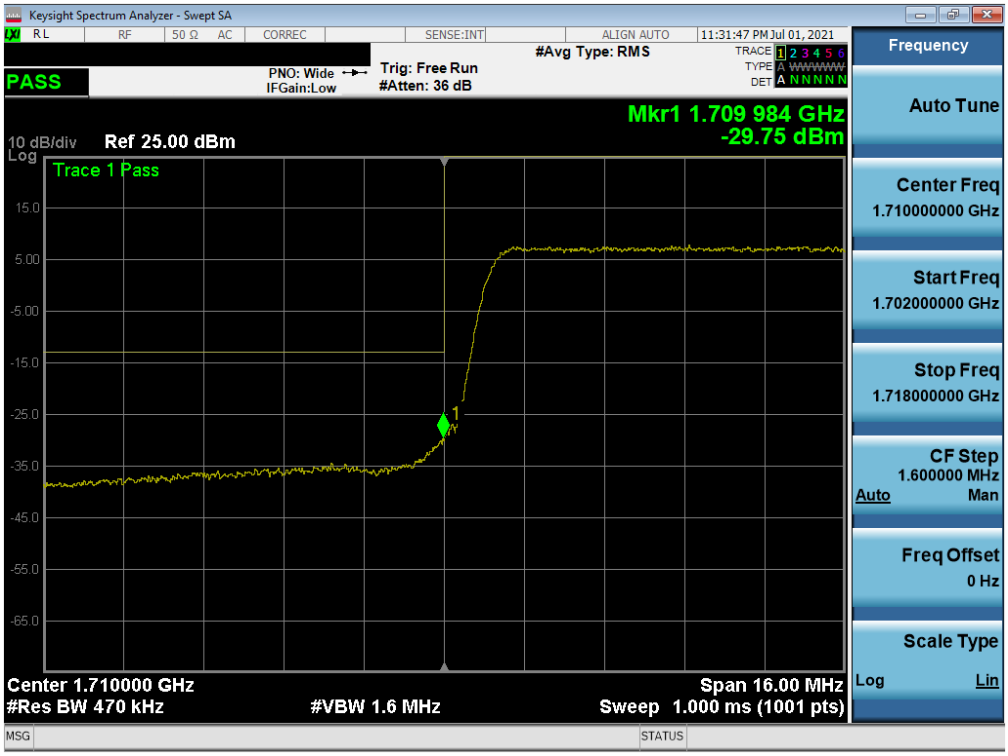


Plot 7-77. Upper Band Edge Plot (LTE Band 12/17 - 3MHz QPSK – Full RB)

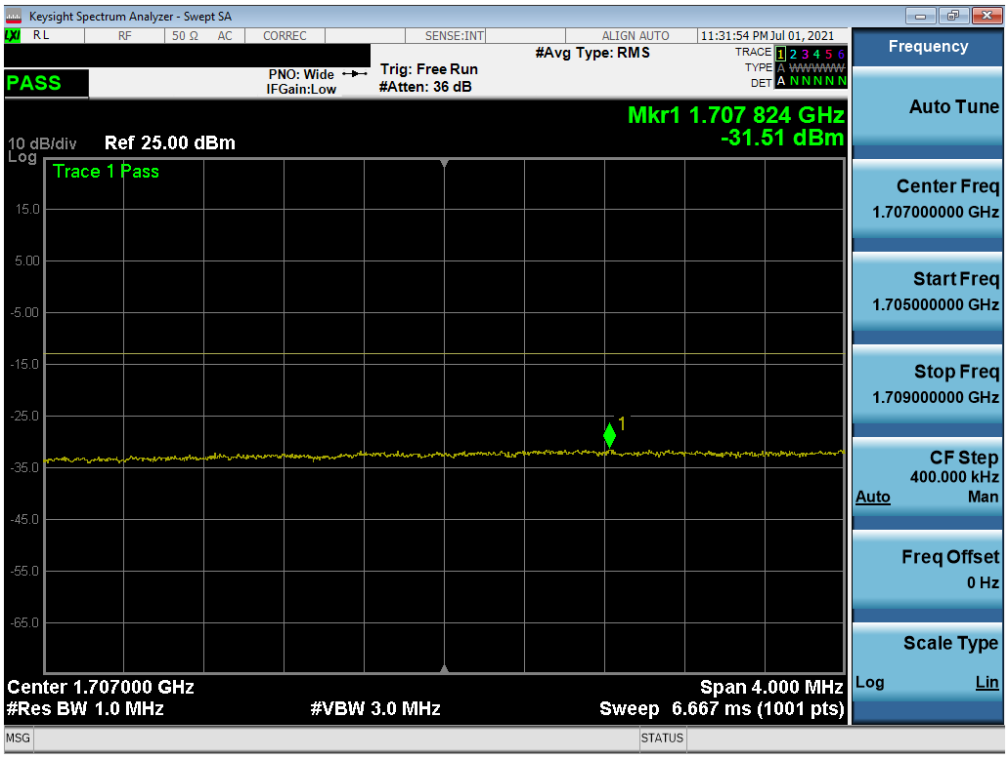
Plot 7-78. Lower Band Edge Plot (LTE Band 12 – 1.4MHz QPSK – Full RB)



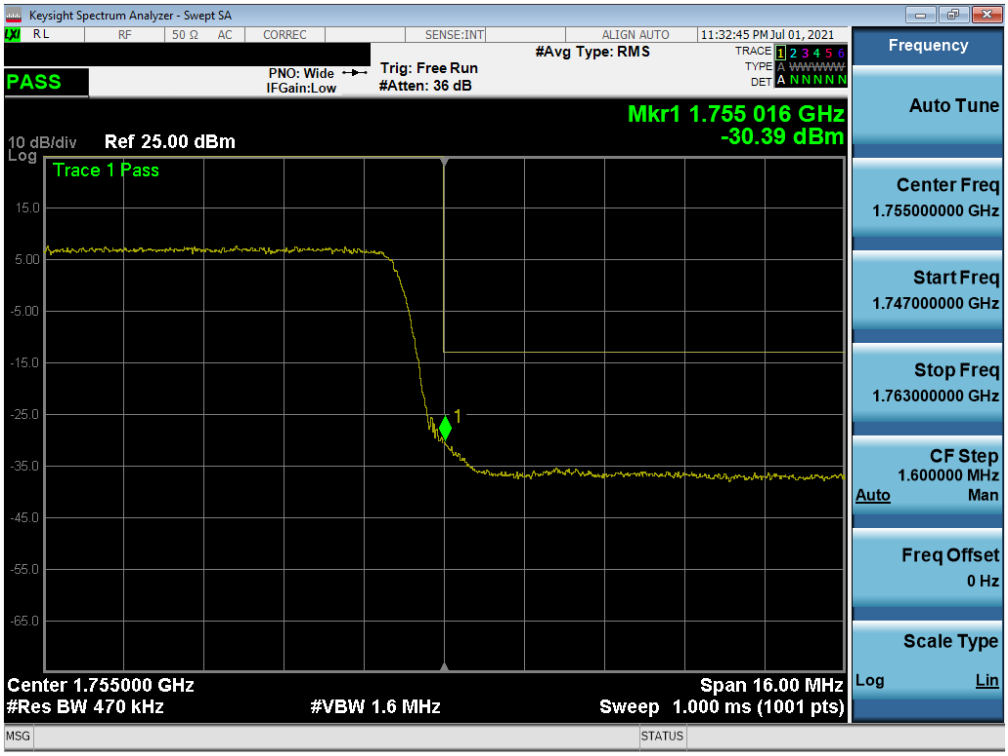
Plot 7-79. Upper Band Edge Plot (LTE Band 12/17 – 1.4MHz QPSK – Full RB)



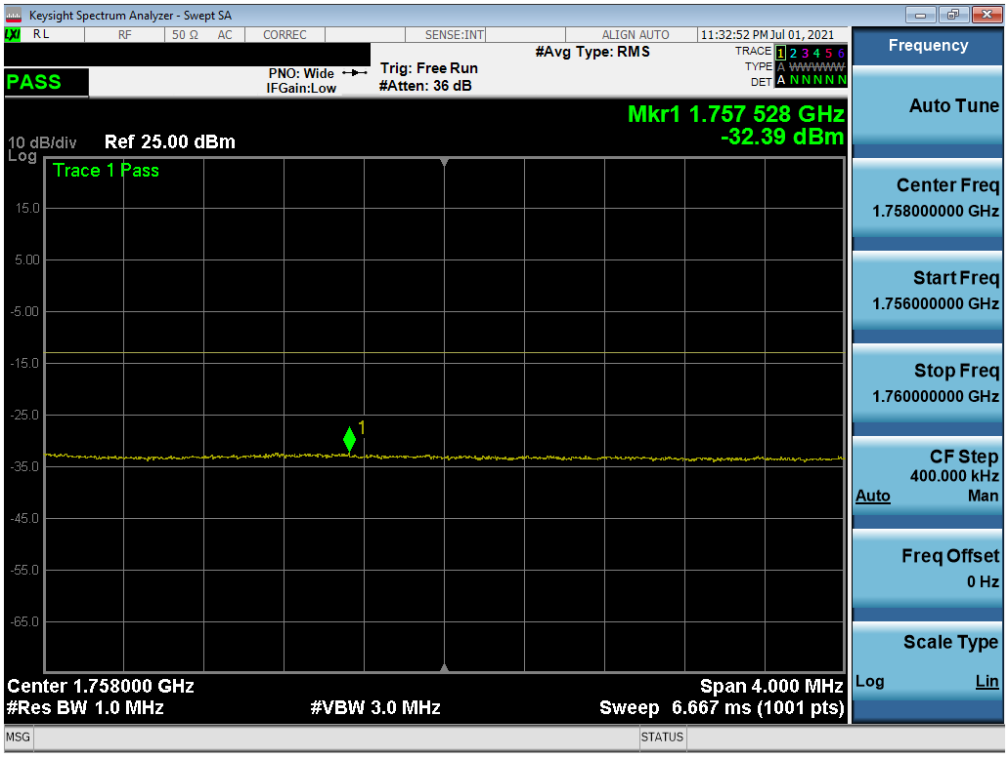
Plot 7-80. Lower Band Edge Plot (LTE Band 66/4 - 20MHz QPSK – Full RB)



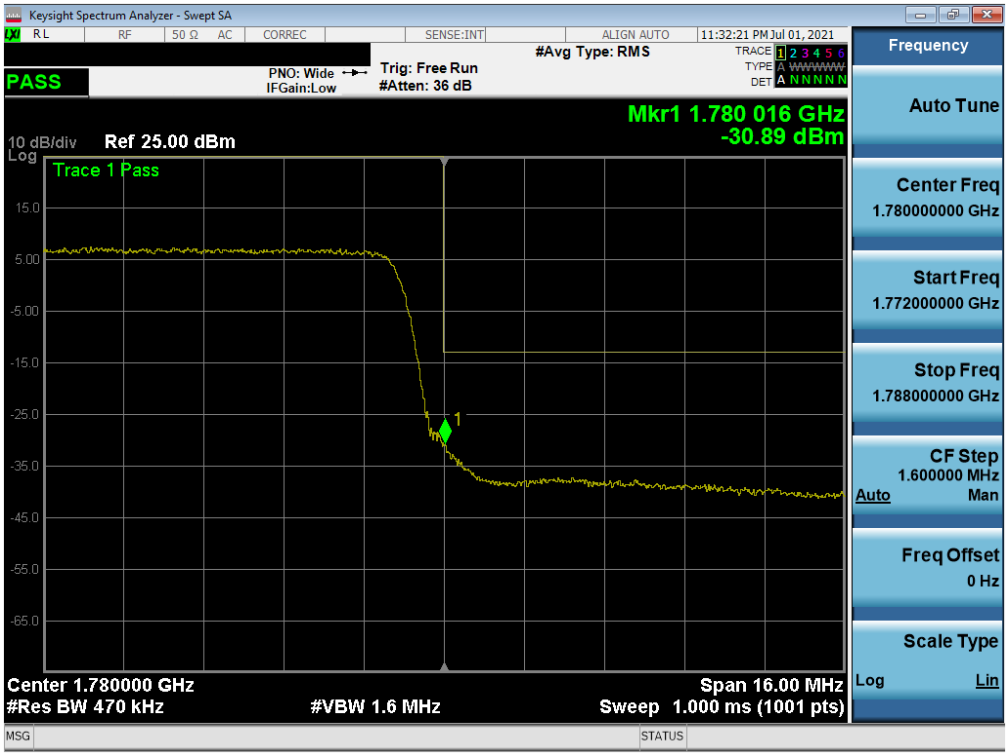
Plot 7-81. Lower Extended Band Edge Plot (LTE Band 66/4 - 20MHz QPSK – Full RB)



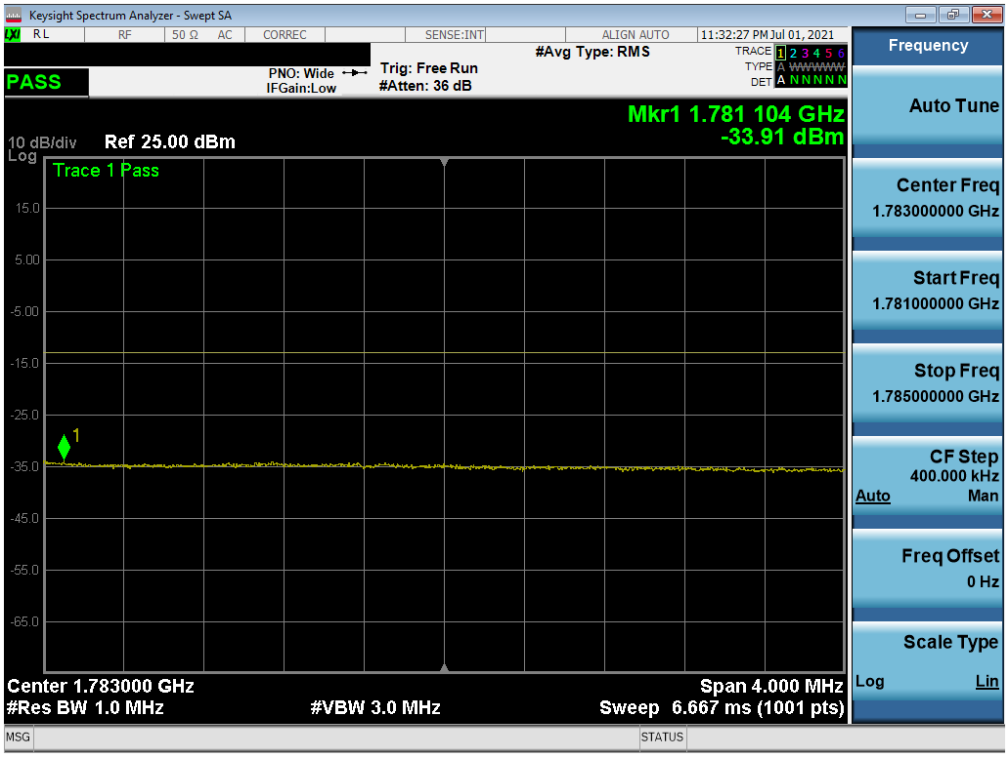
Plot 7-82. Upper Band Edge Plot (LTE Band 4 - 20MHz QPSK – Full RB)



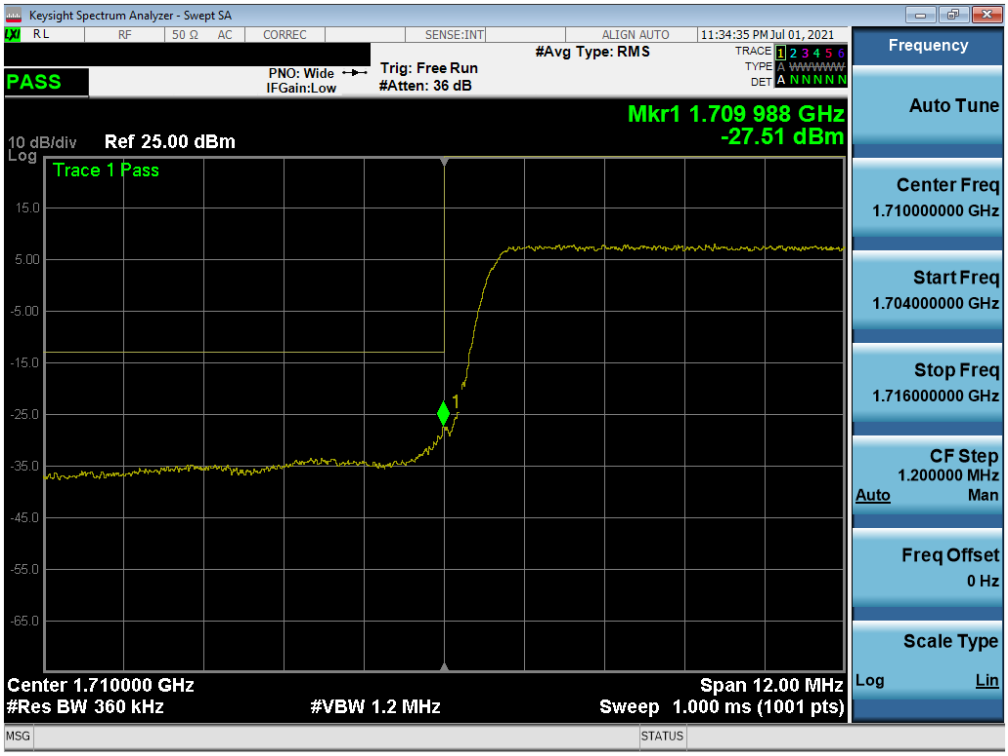
Plot 7-83. Upper Extended Band Edge Plot (LTE Band 4 - 20MHz QPSK – Full RB)



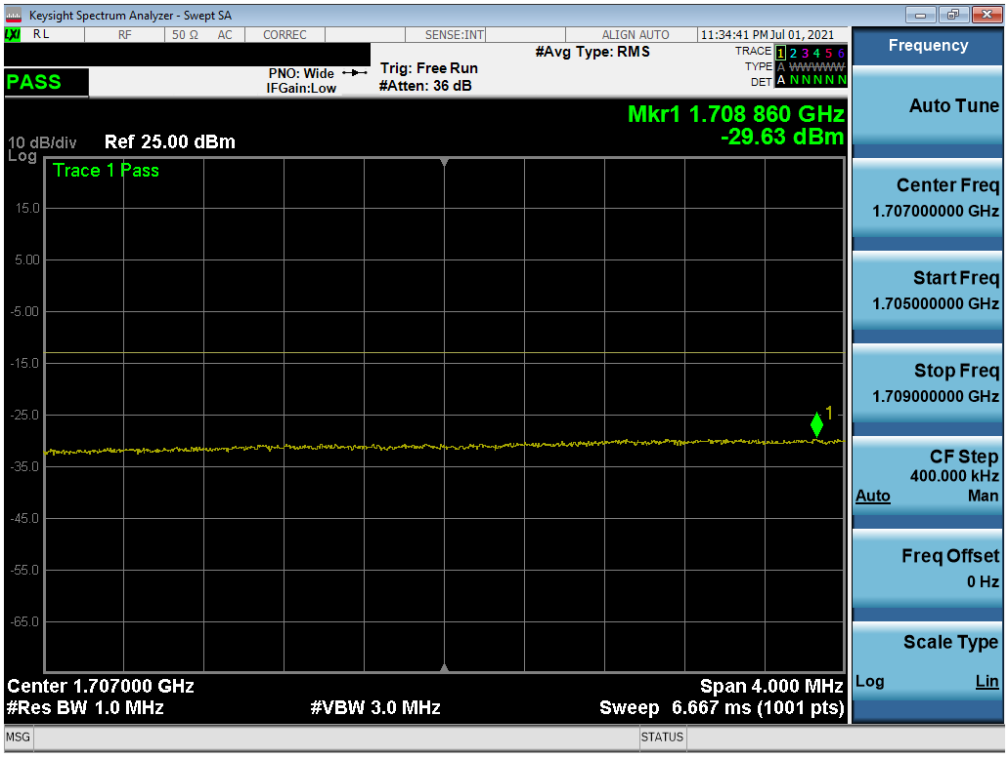
Plot 7-84. Upper Band Edge Plot (LTE Band 66 - 20MHz QPSK – Full RB)



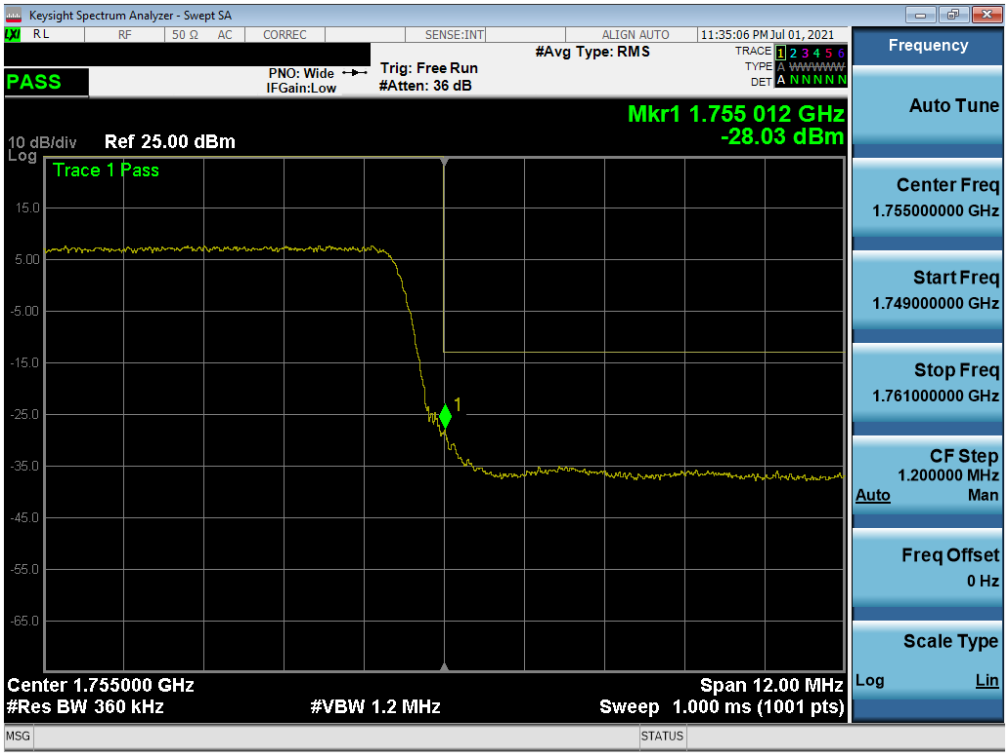
Plot 7-85. Channel Edge Plot (LTE Band 66 - 20MHz QPSK – Full RB)



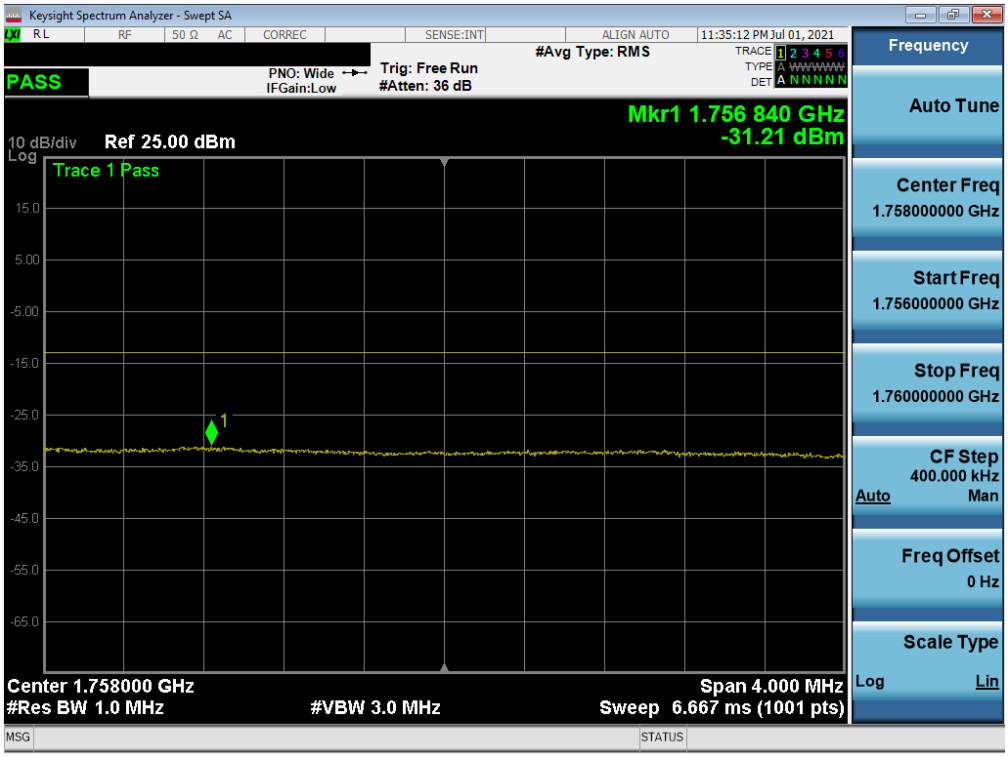
Plot 7-86. Lower Band Edge Plot (LTE Band 66/4 - 15MHz QPSK – Full RB)



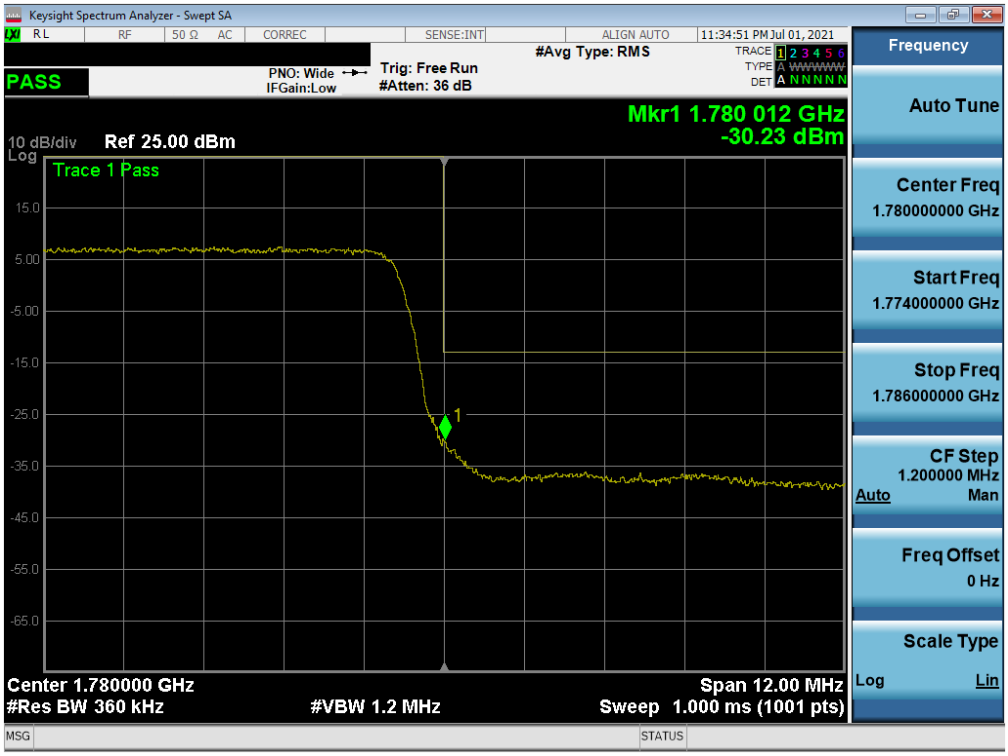
Plot 7-87. Lower Extended Band Edge Plot (LTE Band 66/4 - 15MHz QPSK – Full RB)



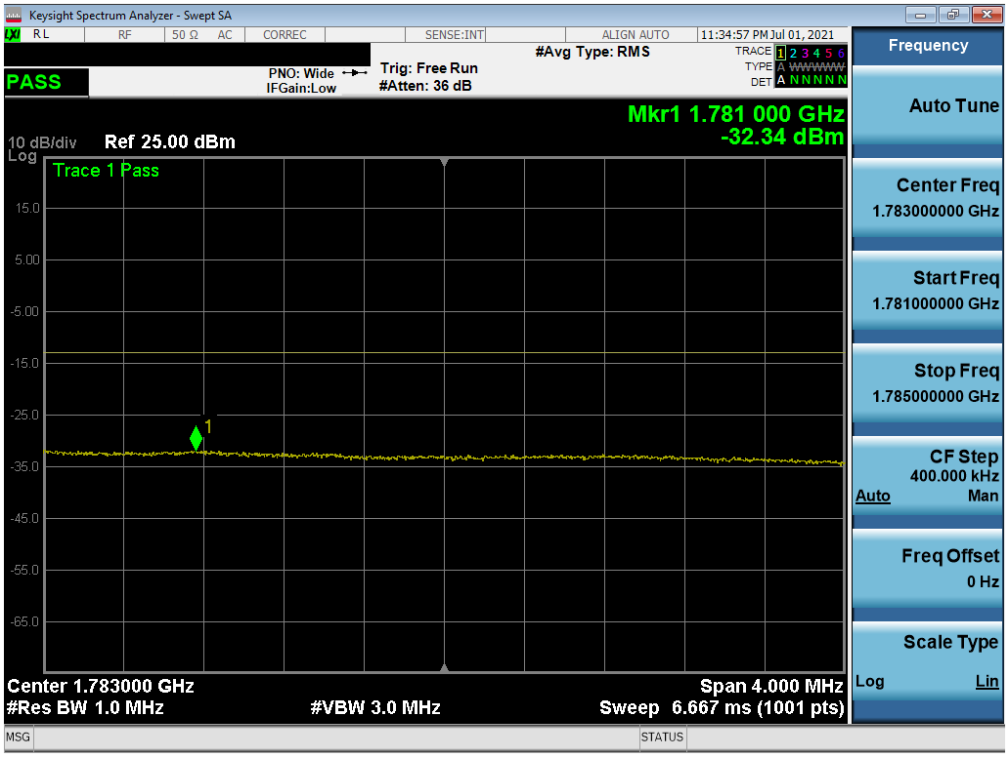
Plot 7-88. Upper Band Edge Plot (LTE Band 4 - 15MHz QPSK – Full RB)



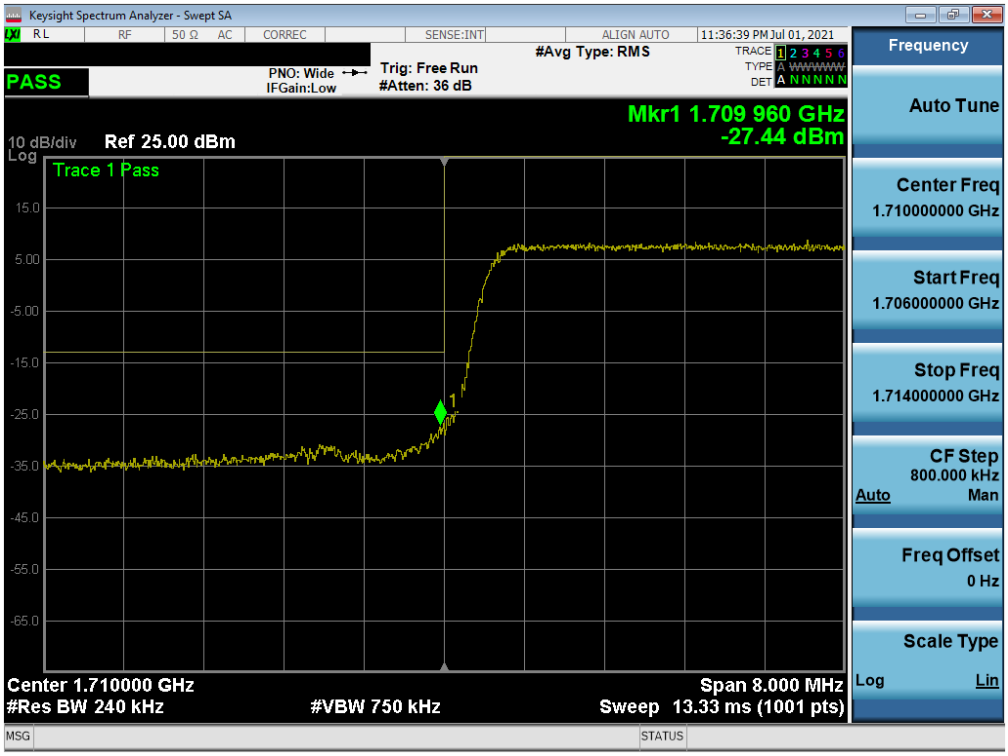
Plot 7-89. Upper Extended Band Edge Plot (LTE Band 4 - 15MHz QPSK – Full RB)



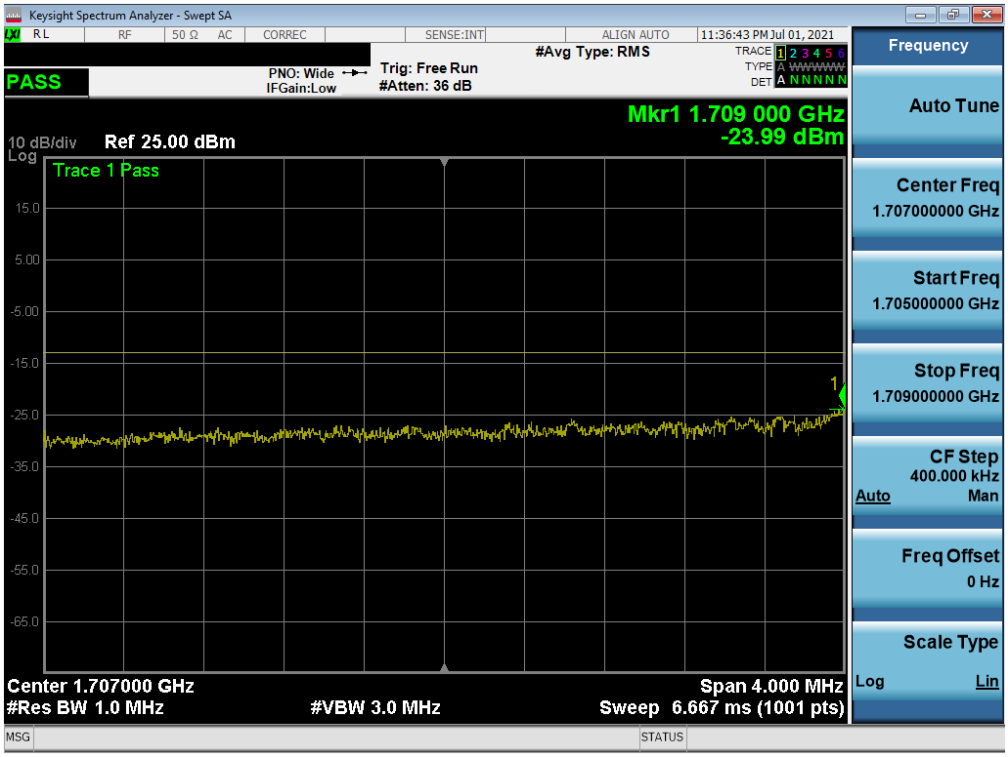
Plot 7-90. Upper Band Edge Plot (LTE Band 66 - 15MHz QPSK – Full RB)



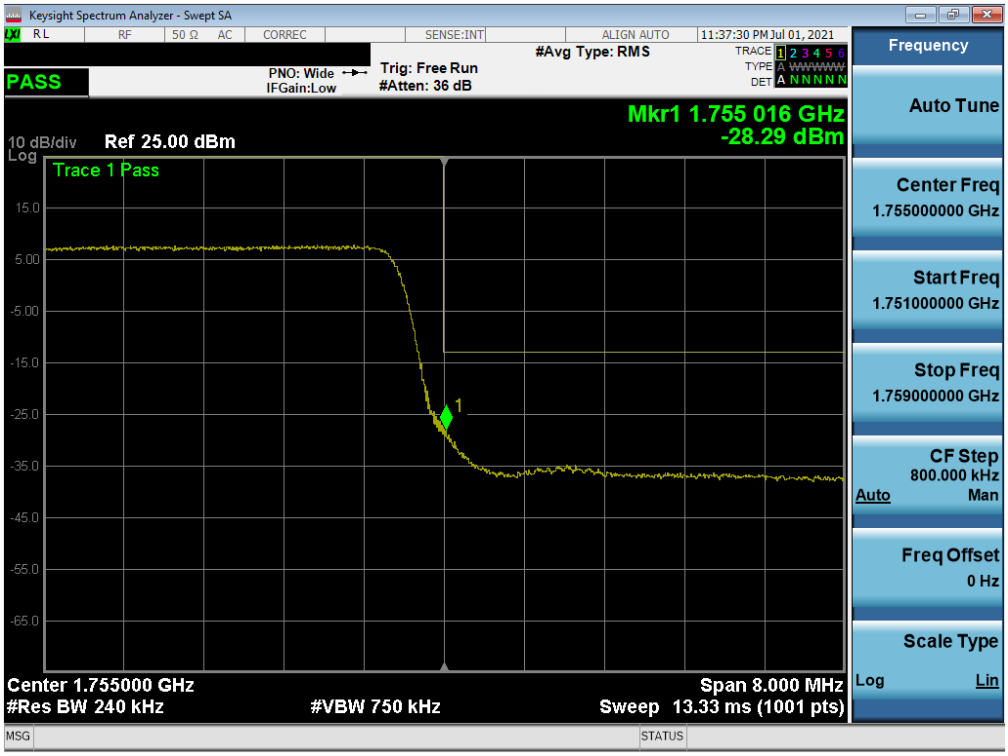
Plot 7-91. Upper Extended Band Edge Plot (LTE Band 66 - 15MHz QPSK – Full RB)



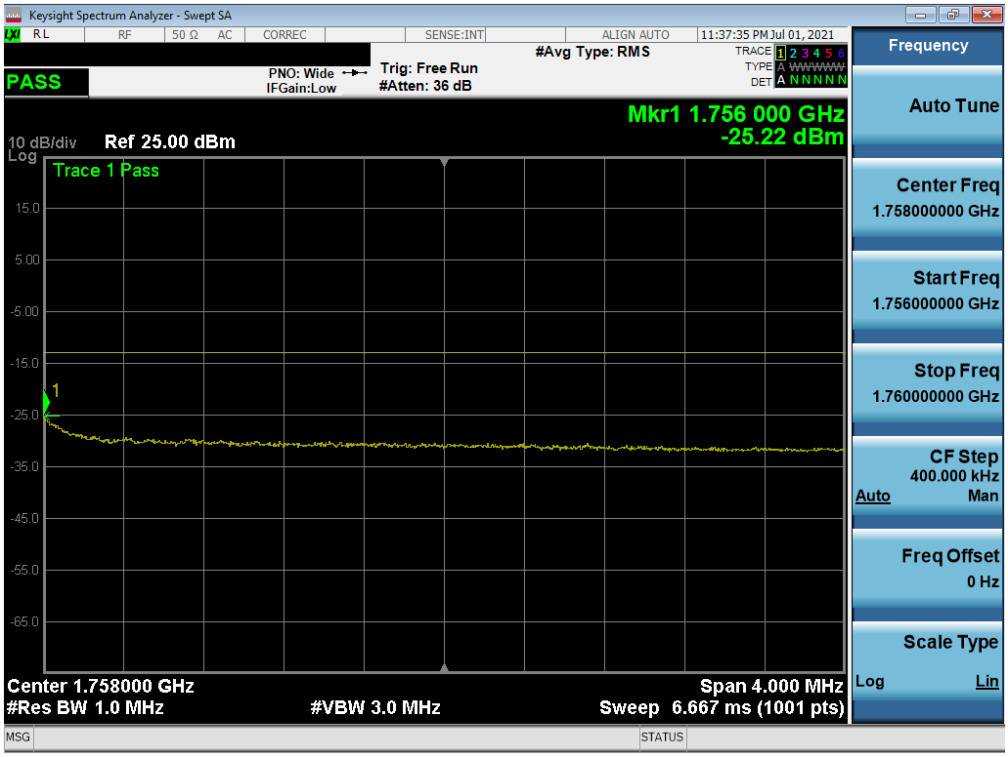
Plot 7-92. Lower Band Edge Plot (LTE Band 66/4 - 10MHz QPSK – Full RB)



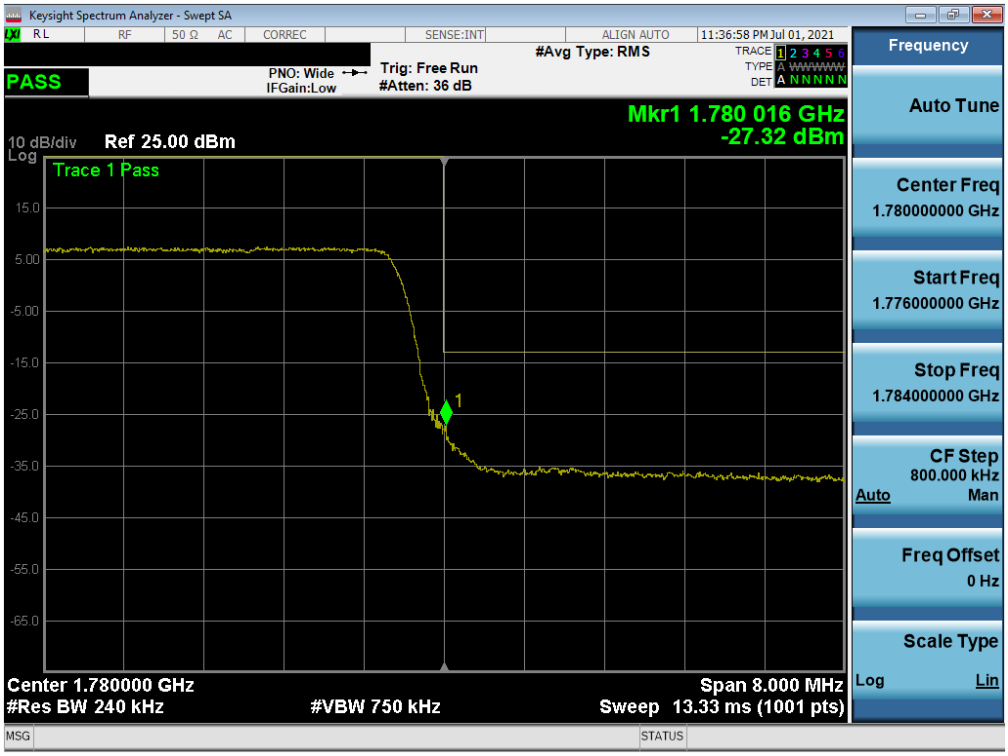
Plot 7-93. Lower Extended Band Edge Plot (LTE Band 66/4 - 10MHz QPSK – Full RB)



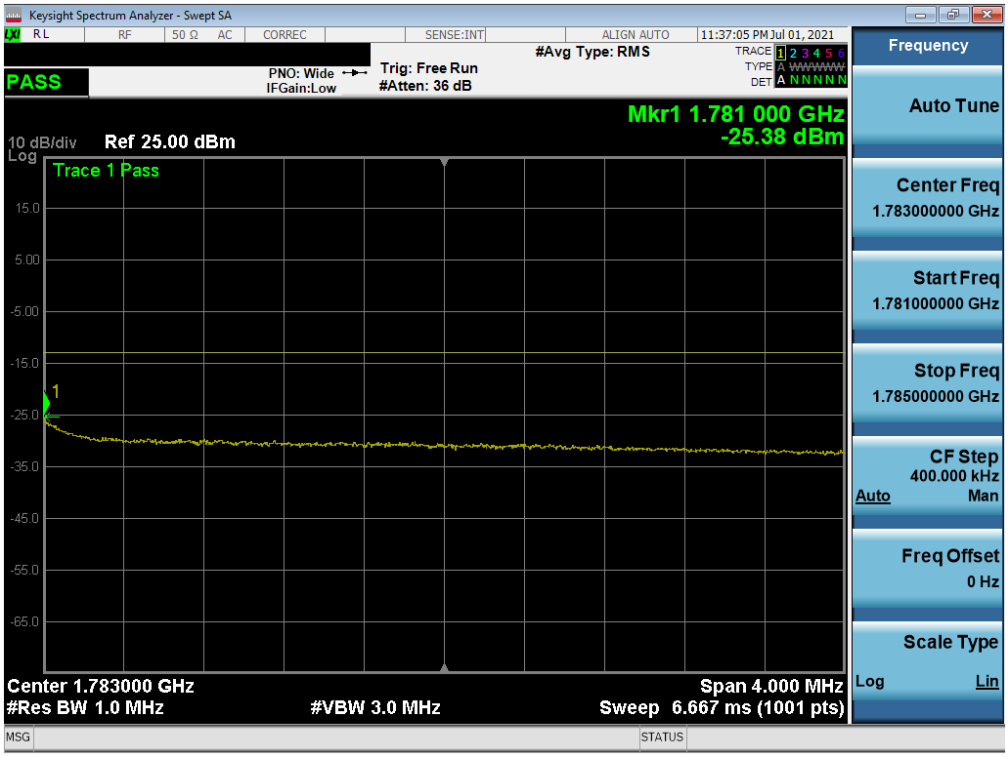
Plot 7-94. Upper Band Edge Plot (LTE Band 4 - 10MHz QPSK – Full RB)



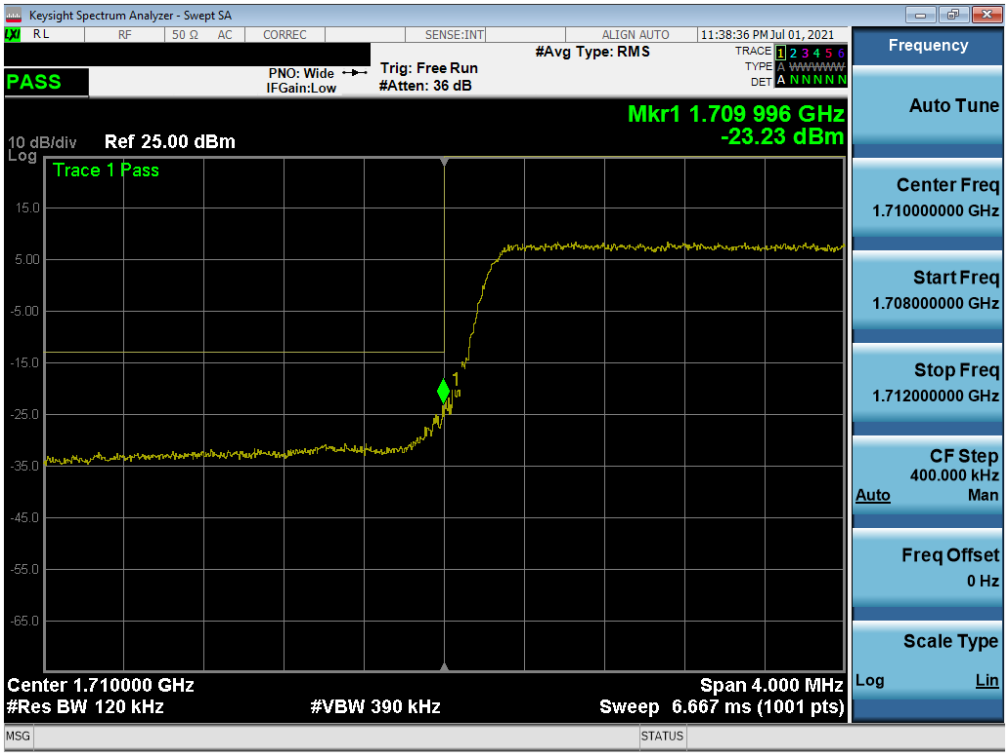
Plot 7-95. Upper Extended Band Edge Plot (LTE Band 4 - 10MHz QPSK – Full RB)



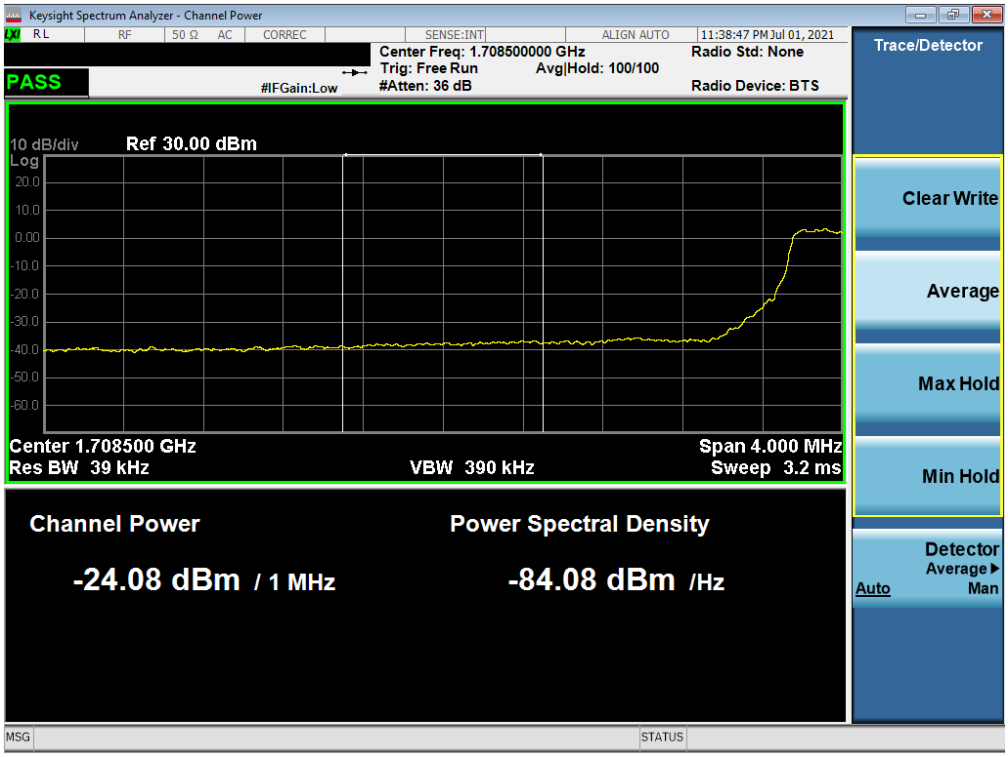
Plot 7-96. Upper Band Edge Plot (LTE Band 66 - 10MHz QPSK – Full RB)



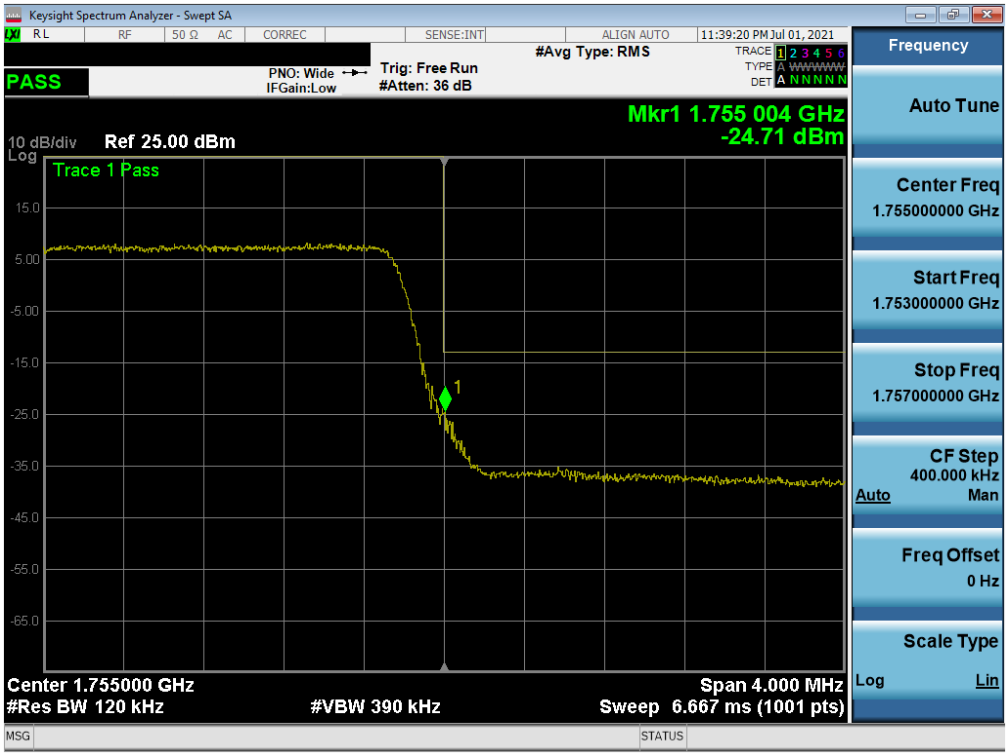
Plot 7-97. Upper Extended Band Edge Plot (LTE Band 66 - 10MHz QPSK – Full RB)



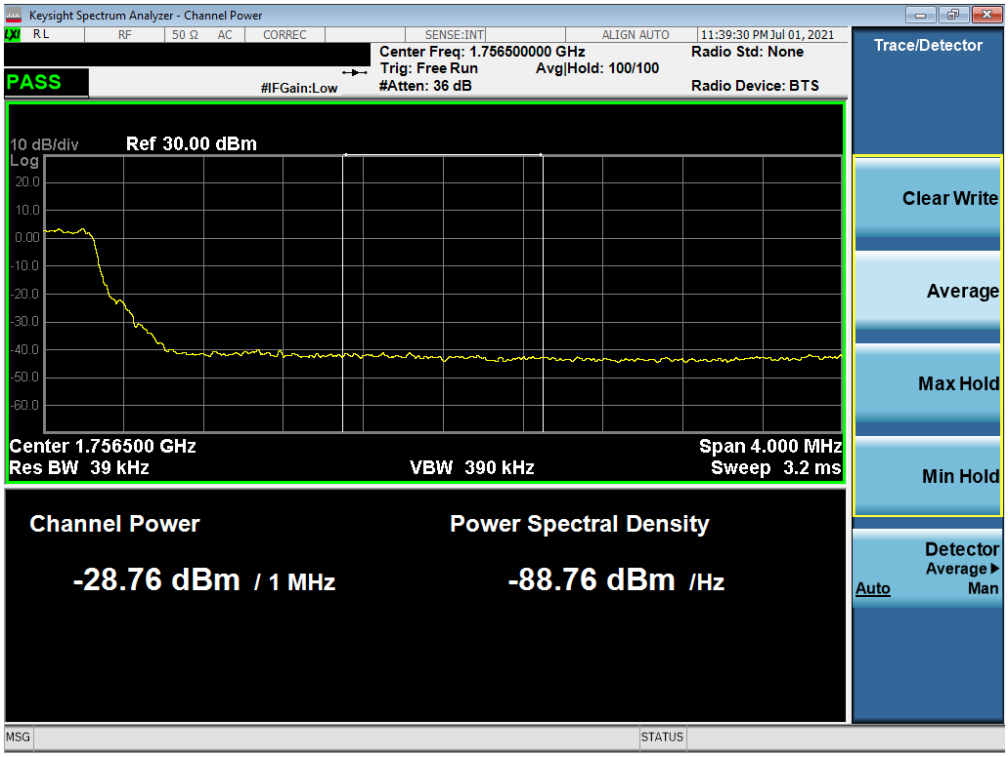
Plot 7-98. Lower Band Edge Plot (LTE Band 66/4 - 5MHz QPSK – Full RB)



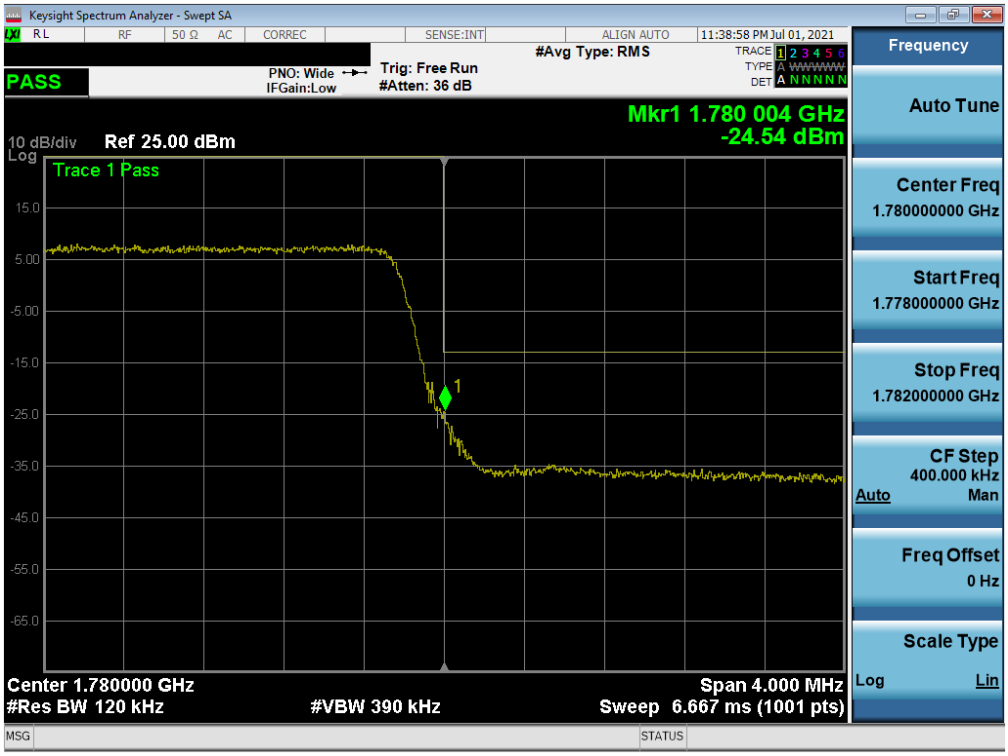
Plot 7-99. Lower Extended Band Edge Plot (LTE Band 66/4 - 5MHz QPSK – Full RB)



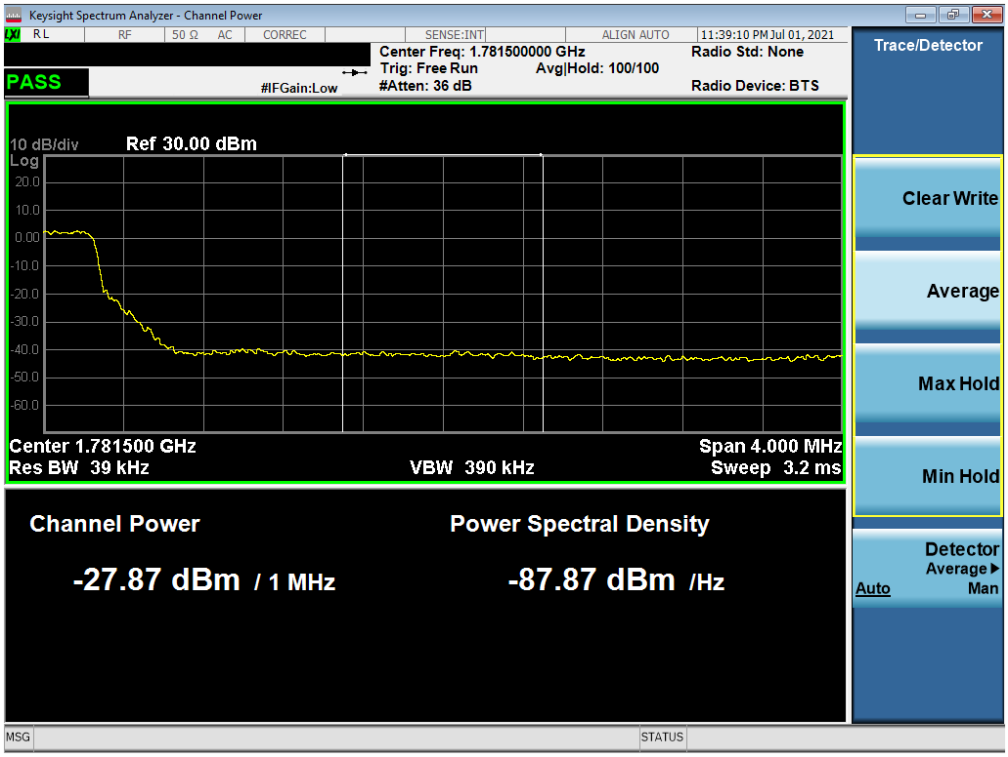
Plot 7-100. Upper Band Edge Plot (LTE Band 4 - 5MHz QPSK – Full RB)



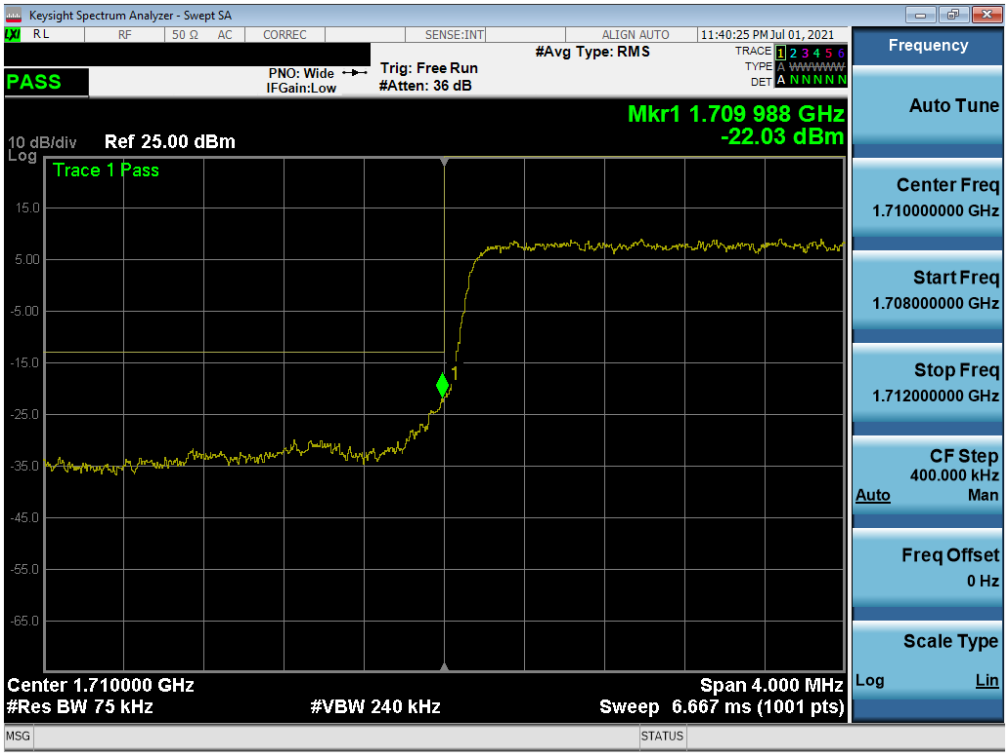
Plot 7-101. Upper Extended Band Edge Plot (LTE Band 4 - 5MHz QPSK – Full RB)



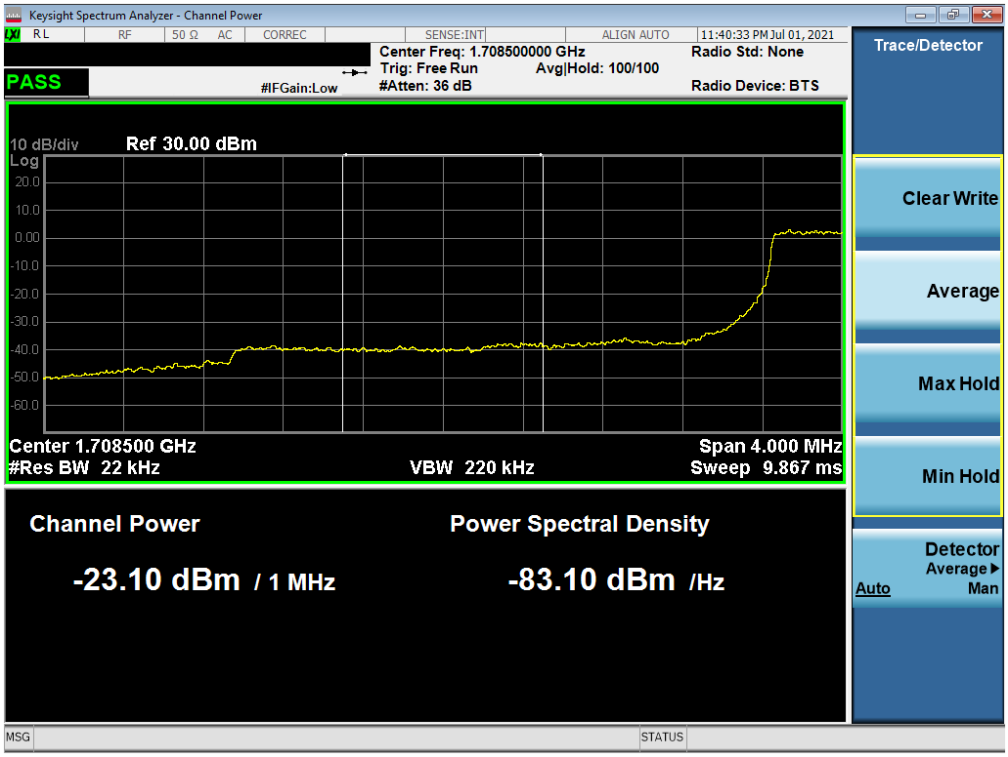
Plot 7-102. Upper Band Edge Plot (LTE Band 66 - 5MHz QPSK – Full RB)



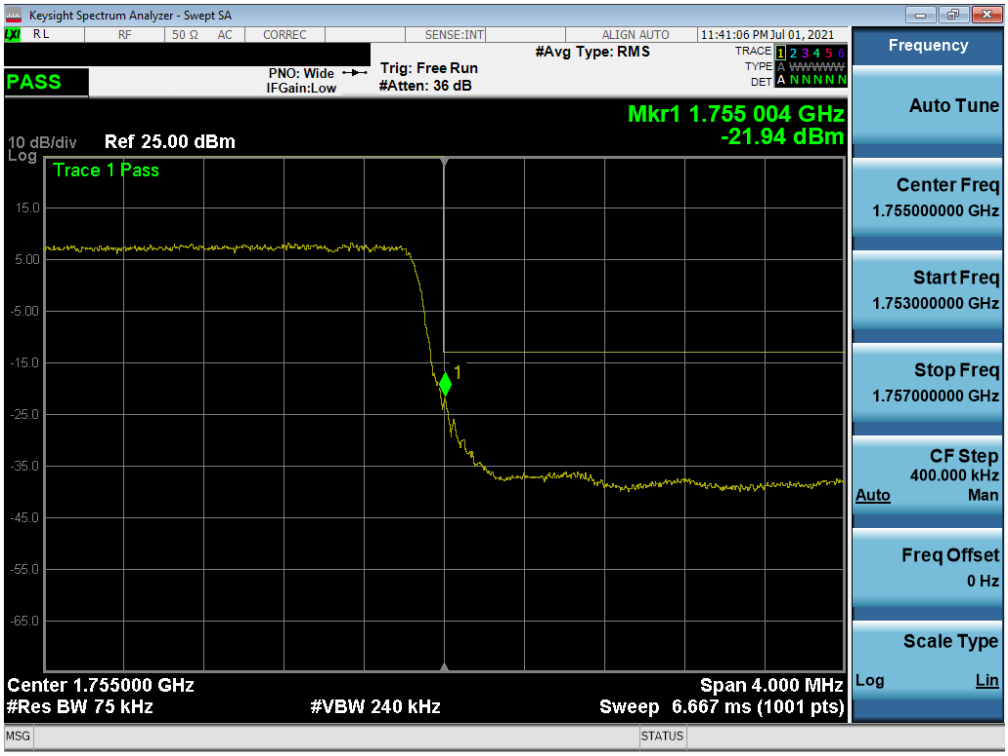
Plot 7-103. Upper Extended Band Edge Plot (LTE Band 66 - 5MHz QPSK – Full RB)



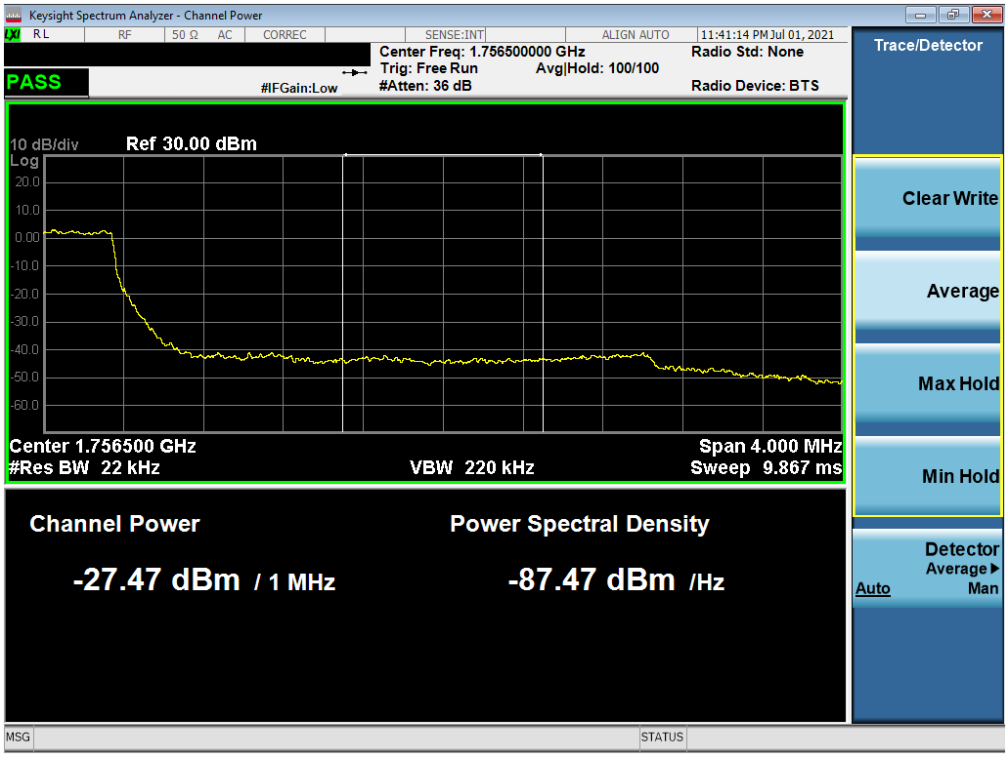
Plot 7-104. Lower Band Edge Plot (LTE Band 66/4 - 3MHz QPSK – Full RB)



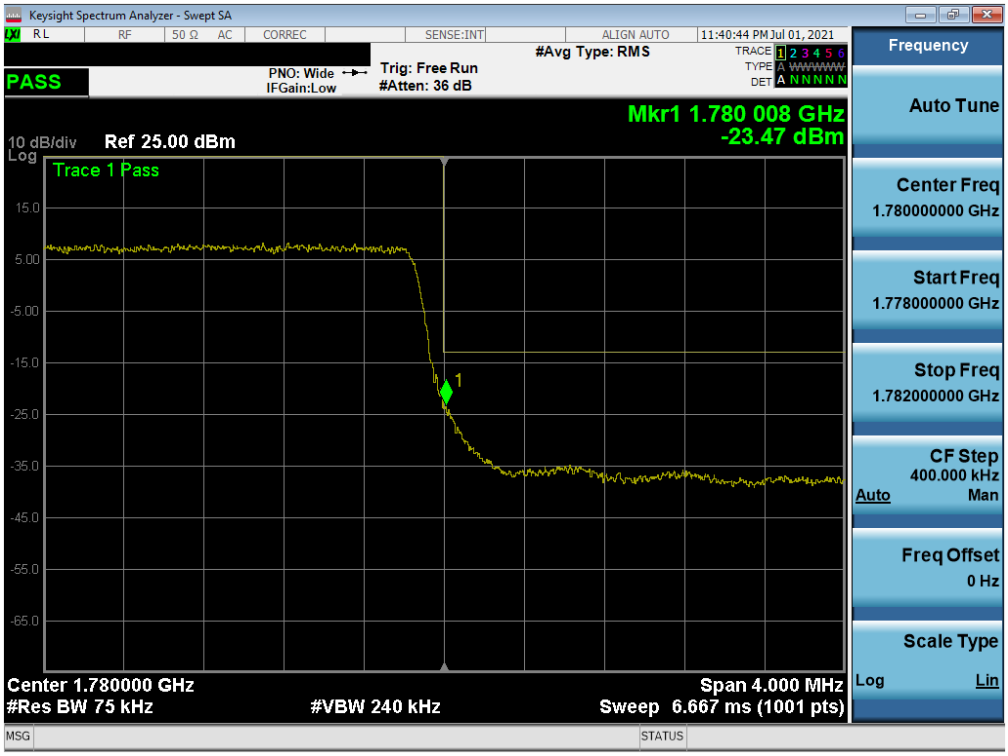
Plot 7-105. Lower Extended Band Edge Plot (LTE Band 66/4 - 3MHz QPSK – Full RB)



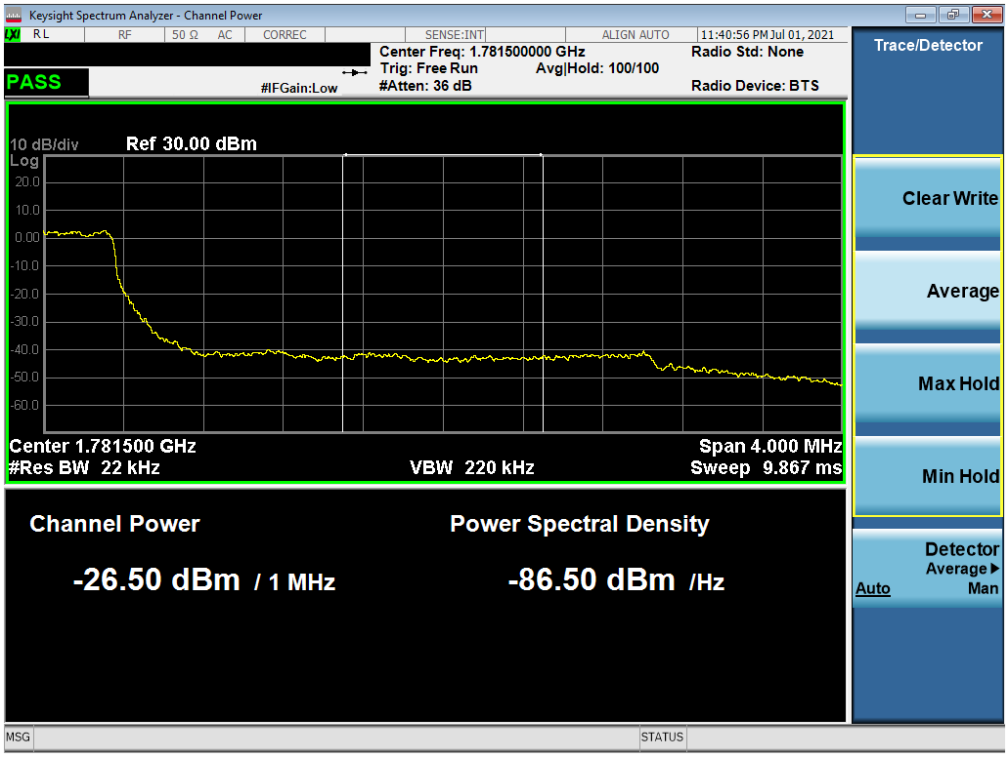
Plot 7-106. Upper Band Edge Plot (LTE Band 4 - 3MHz QPSK – Full RB)



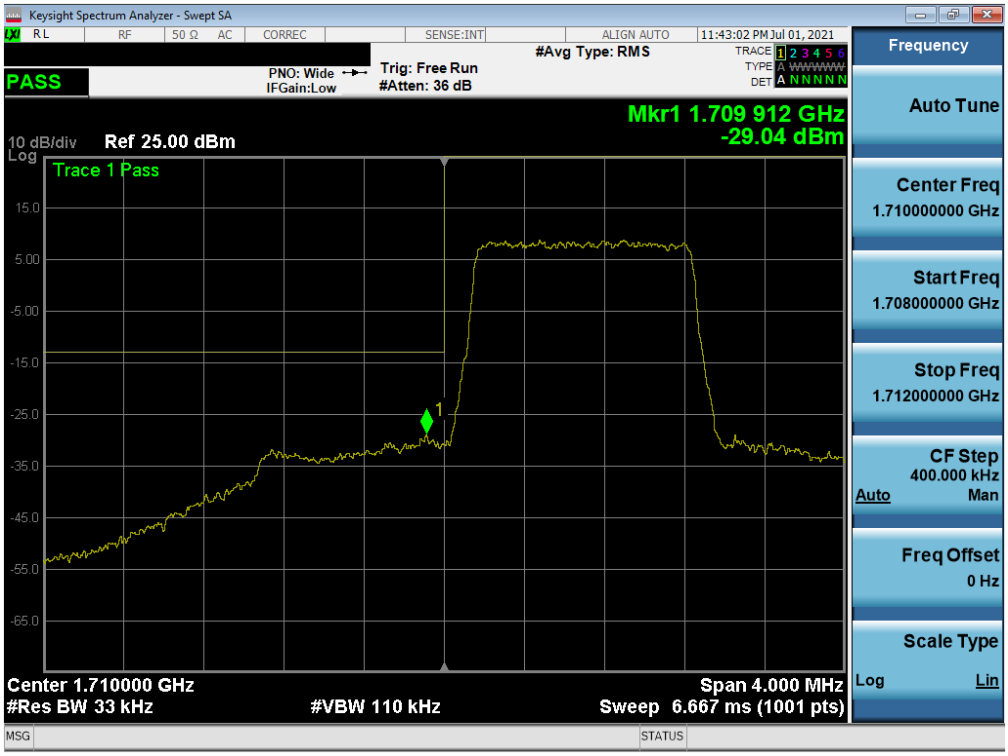
Plot 7-107. Upper Extended Band Edge Plot (LTE Band 4 - 3MHz QPSK – Full RB)



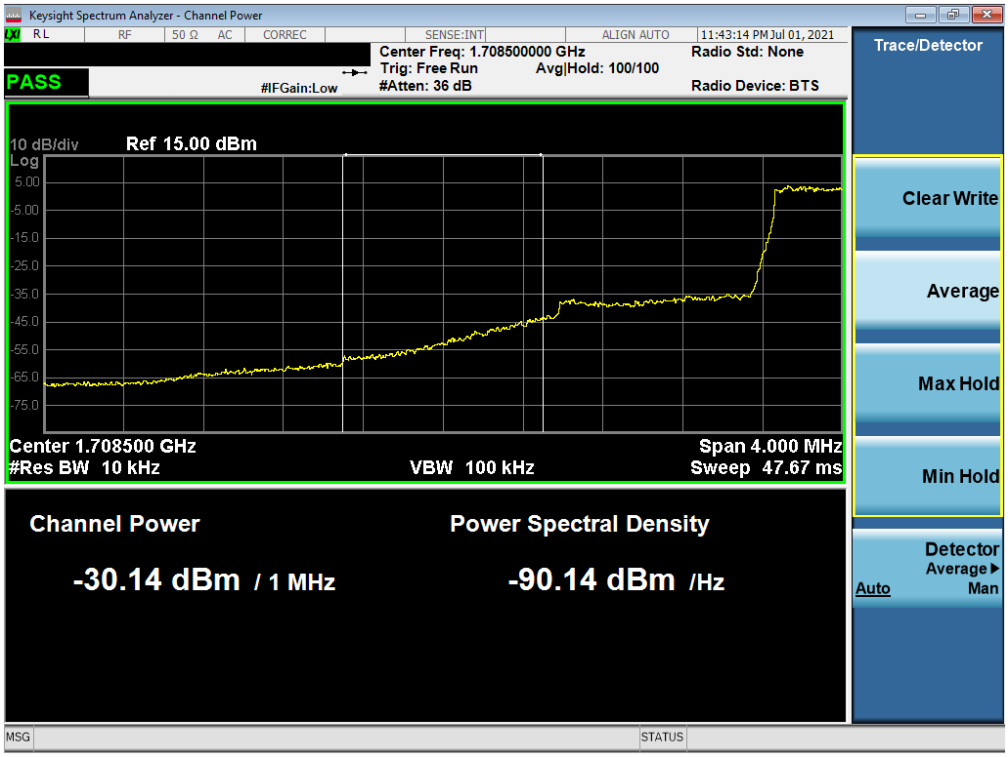
Plot 7-108. Upper Band Edge Plot (LTE Band 66 - 3MHz QPSK – Full RB)



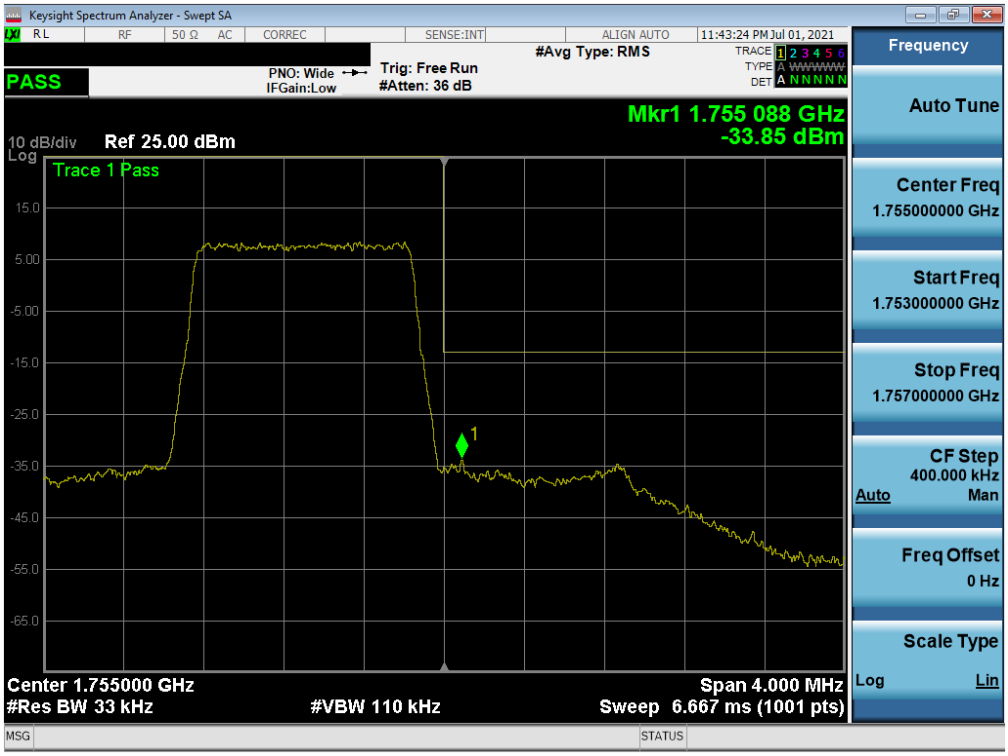
Plot 7-109. Upper Extended Band Edge Plot (LTE Band 66 - 3MHz QPSK – Full RB)



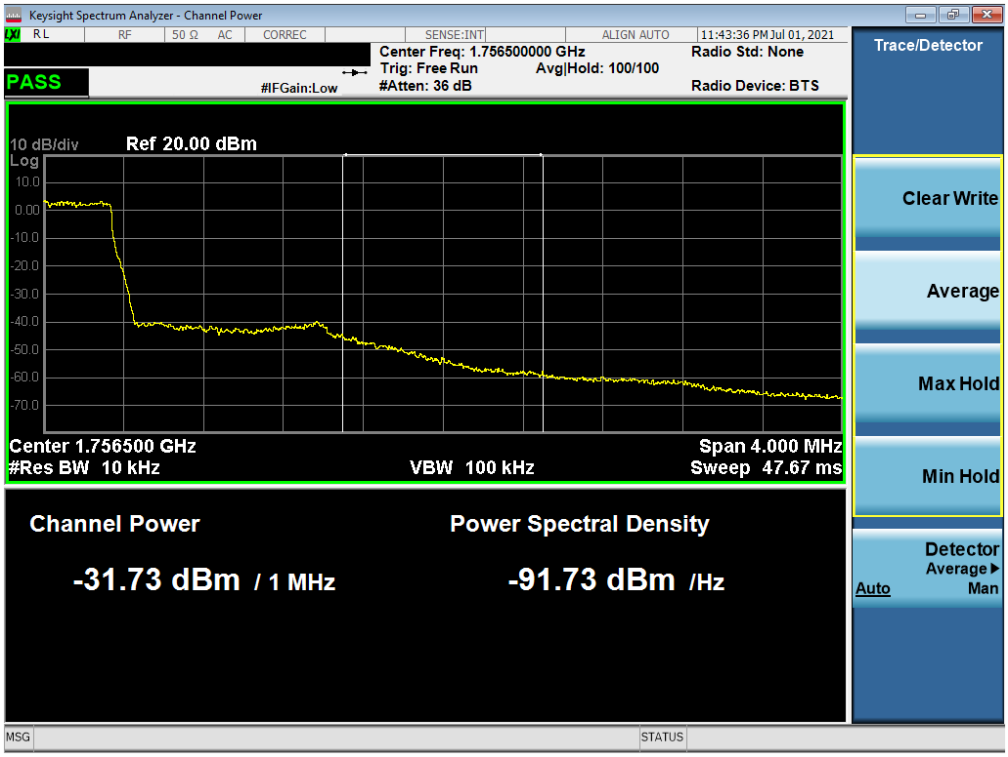
Plot 7-110. Lower Band Edge Plot (LTE Band 66/4 – 1.4MHz QPSK – Full RB)



Plot 7-111. Lower Extended Band Edge Plot (LTE Band 66/4 – 1.4MHz QPSK – Full RB)

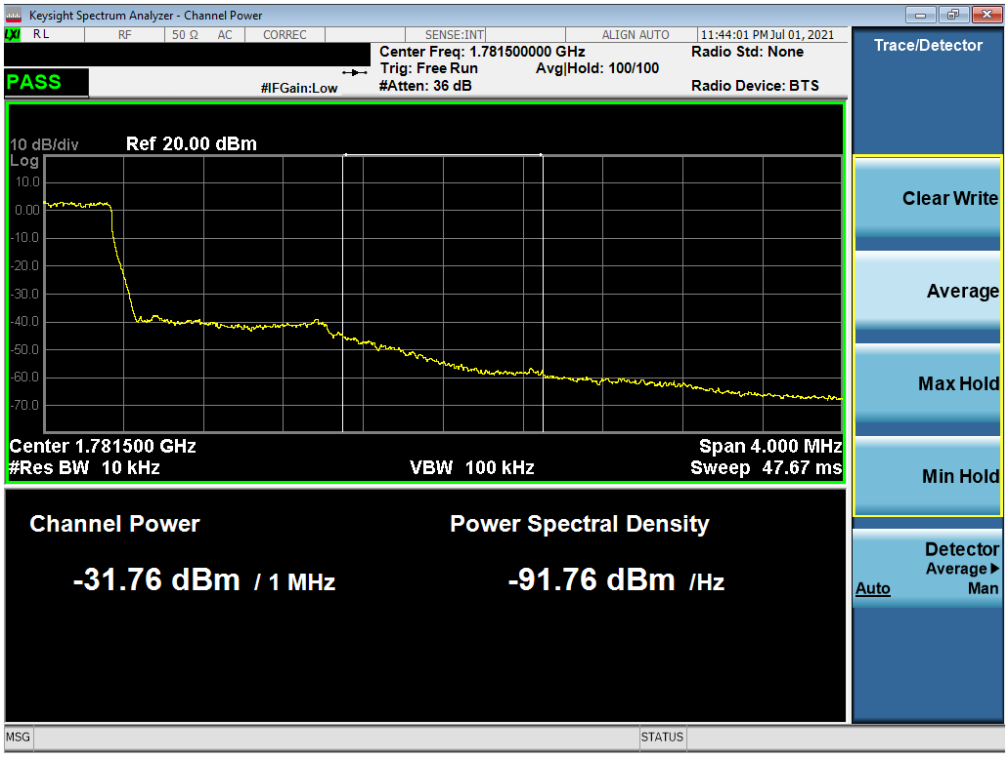


Plot 7-112. Upper Band Edge Plot (LTE Band 4 – 1.4MHz QPSK – Full RB)



Plot 7-113. Upper Extended Band Edge Plot (LTE Band 4 – 1.4MHz QPSK – Full RB)

Plot 7-114. Upper Band Edge Plot (LTE Band 66 – 1.4MHz QPSK – Full RB)



Plot 7-115. Upper Extended Band Edge Plot (LTE Band 66 – 1.4MHz QPSK – Full RB)